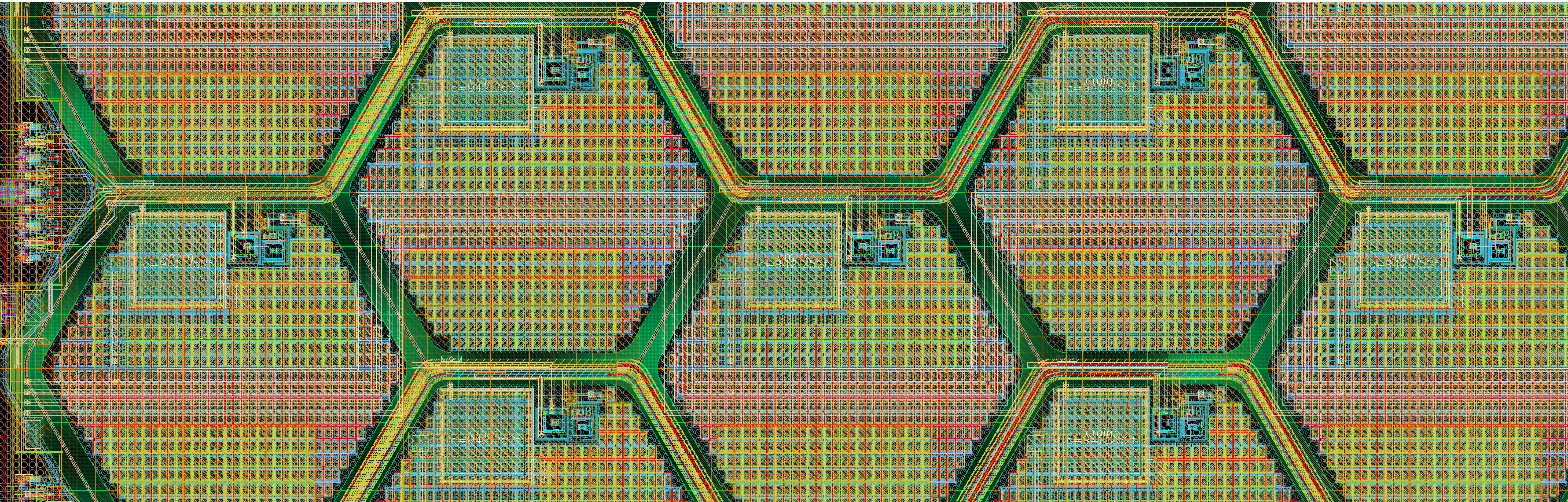


Next generation silicon pixel detectors: towards **picosecond timing**

Giuseppe Iacobucci — Université de Genève



**UNIVERSITÉ
DE GENÈVE**



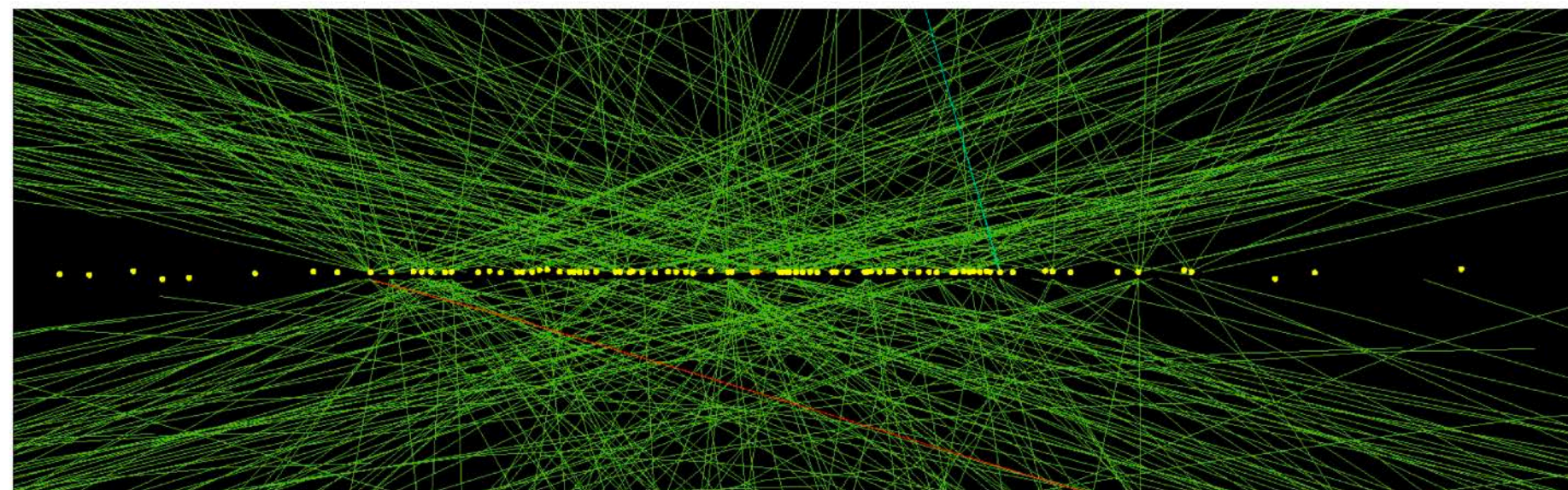
**Swiss National
Science Foundation**



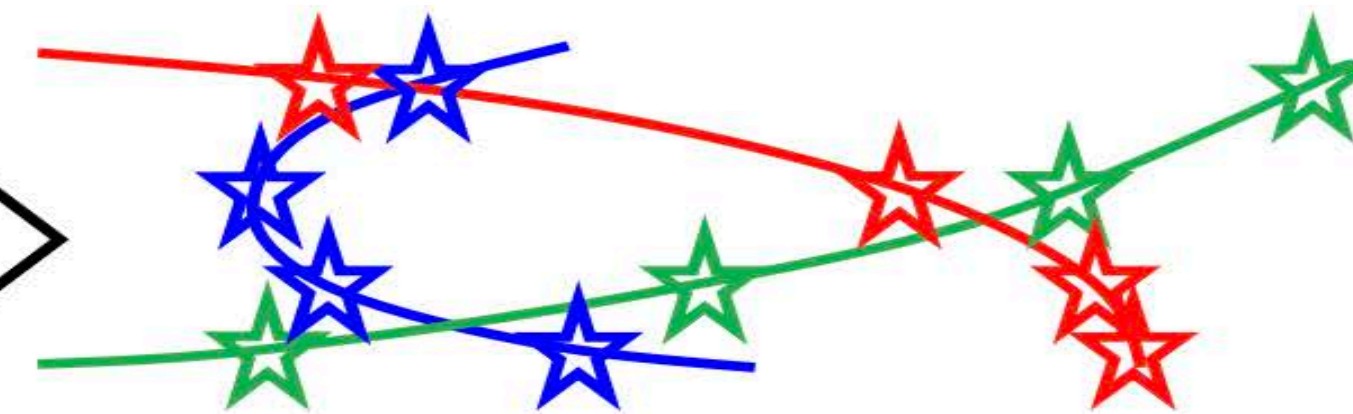
European Research Council
Established by the European Commission

- High Luminosity LHC (**HL-LHC**, starting in 2029): expect a pile-up of **150-200 events per bunch crossing**
- Timing and spatial resolution of standard silicon trackers not sufficient: *10-15% of vertexes composed of 2 events*

Pile-up without timing:



Pile-up with precise timing – **4D tracking**:



H. Sadrozinski, A. Seiden and N. Cartiglia, 2018 Rep. Prog. Phys. **81** 026101

Requirements for silicon detectors for **4D tracking at the HL-LHC**:

- Time resolution: **30 ps**
- Spatial granularity: **~1 mm** (timing information assigned to the track)
- Radiation tolerance: **$\gtrsim 10^{15} n_{eq}\cdot cm^{-2}$**

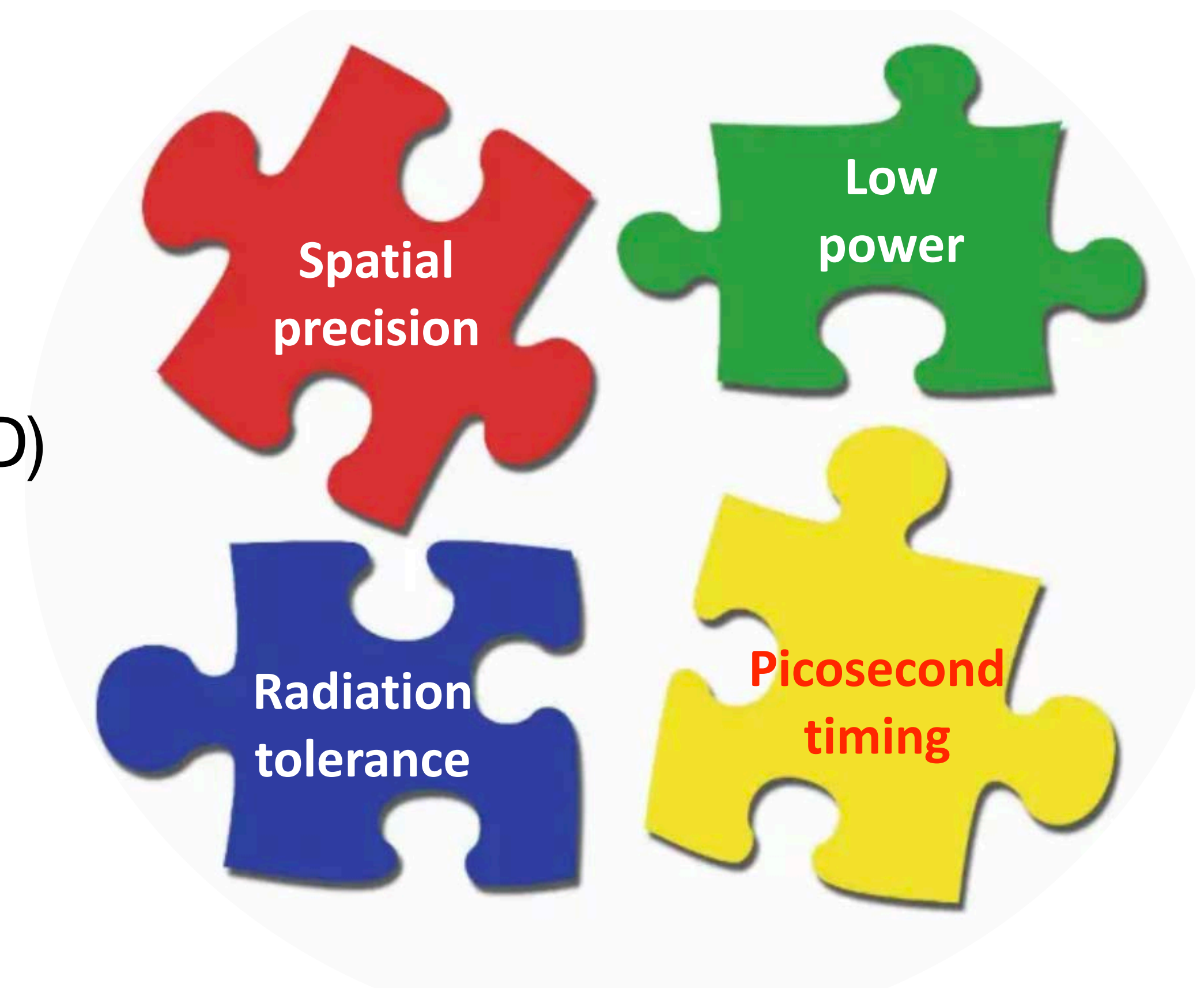
Timing resolution in silicon pixel detectors mainly determined by:

1. Sensor **geometry and fields**
2. **Charge-collection** (Landau) noise
3. **Electronic** noise
4. **Gain**: Internal charge multiplication (except 3D)

Challenge:



Optimise these parameters for **picosecond timing** while maintaining **other performance requirements**



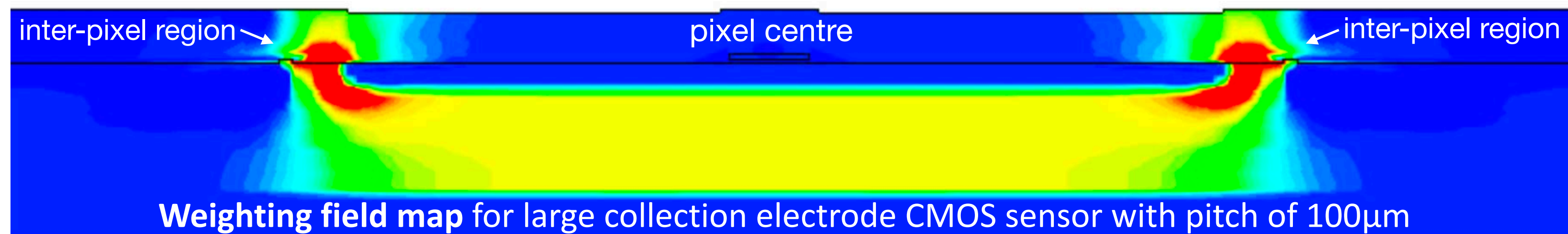
Sensor geometry needs to guarantee *fast and uniform time response*:

- High and uniform **electric field** (charge transport with uniform and saturated **drift velocity**)
- High and uniform **weighting field** (fast and uniform **signal induction**)

$$I_{ind} = \sum_i q_i \vec{v}_{drift,i} \cdot \vec{E}_{w,i}$$

Challenge:

- **Small pixels** introduce **low and non-uniform electric and weighting field** regions:



Red = high
Blue = low

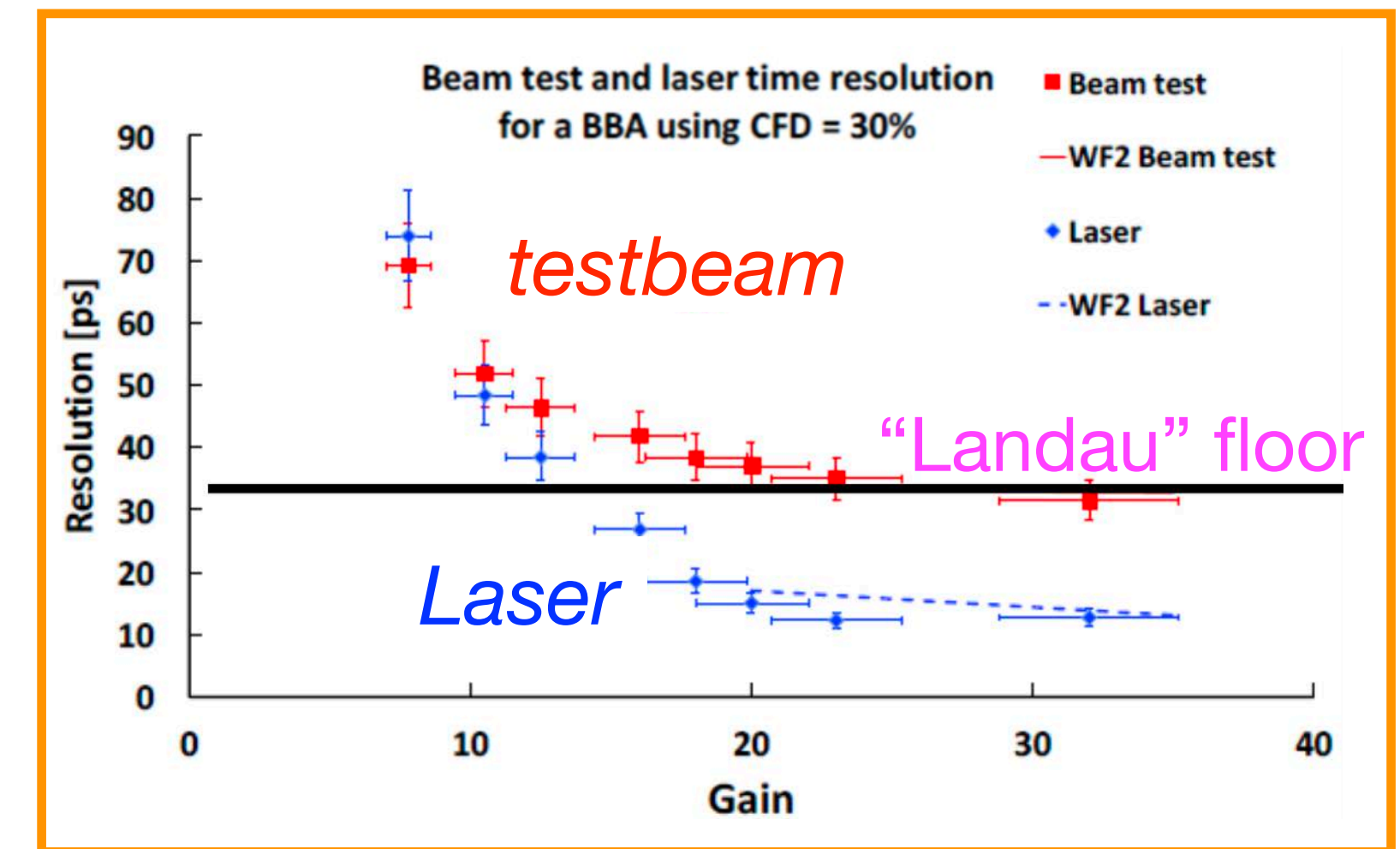
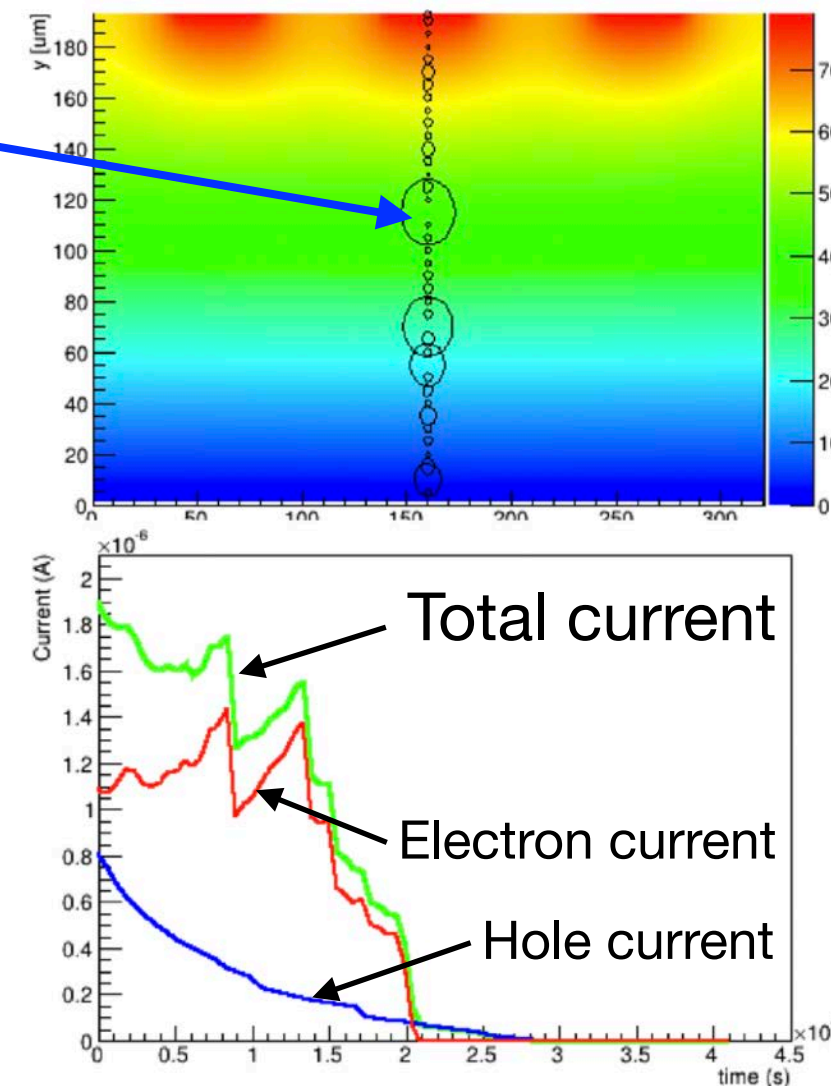
L. Paolozzi PhD thesis, 2014 – http://www.infn.it/thesis/thesis_dettaglio.php?tid=11828

Sensor design needs to reduce **charge-collection noise**:

Non uniform charge deposition along particle track induces a **jitter in the current pulse**

$$I_{ind} = \sum_i q_i \vec{v}_{drift,i} \cdot \vec{E}_{w,i}$$

The **statistical origin** of this variability of I_{ind} makes this effect **irreducible in PN-junction sensors**

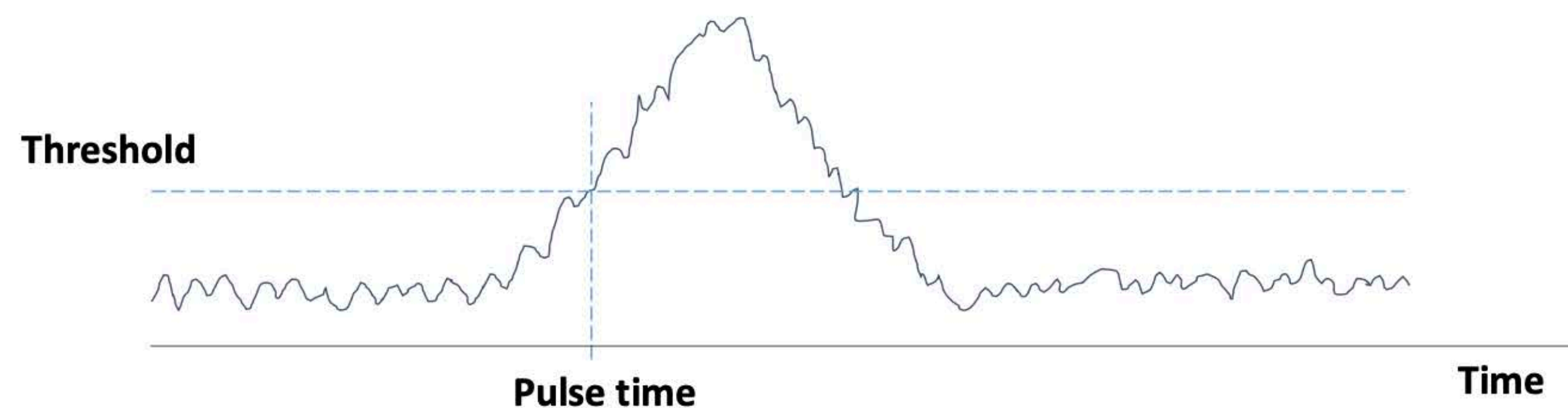


H. Sadrozinski, A. Seiden and N. Cartiglia, 2018 Rep. Prog. Phys. **81** 026101

Way out: **thinning** of the sensor

Challenge: although thin sensors reduce charge collection noise, they are typically bad for Signal/Noise (less ionization + increased capacitive coupling to sensor backside)

Once the geometry has been fixed, the time resolution depends mostly on the **amplifier performance**:



$$\sigma_t = \frac{\sigma_V}{\frac{dV}{dt}} = \frac{A_{Gain} \cdot ENC}{A_{Gain} \cdot I_{ind}} \approx \frac{t_{rise}}{\frac{Q}{ENC}} = \frac{t_{rise}}{Signal/Noise}$$

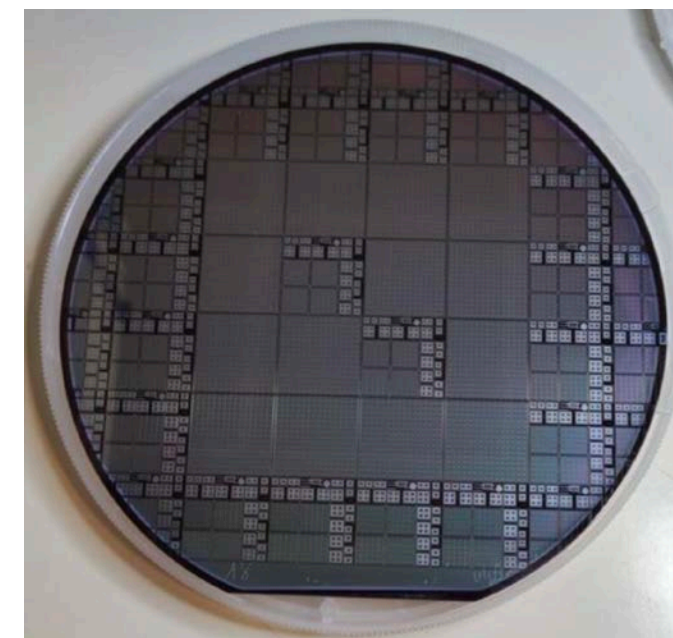
→ Need an **ultra-fast, high-gain, low-noise** (low power-consumption) electronics with **fast risetime** and **small capacitance**

Towards ps timing: Outline

Under the impulse of the High Energy Physics community, a new generation of silicon sensors for timing is being developed:

30 ps sensors:

- ▶ **LGAD** (Low-Gain Avalanche Detector)
 - ➔ TI-LGAD (Trench-Isolated LGAD)
 - ➔ AC-Coupled (Resistive) LGAD

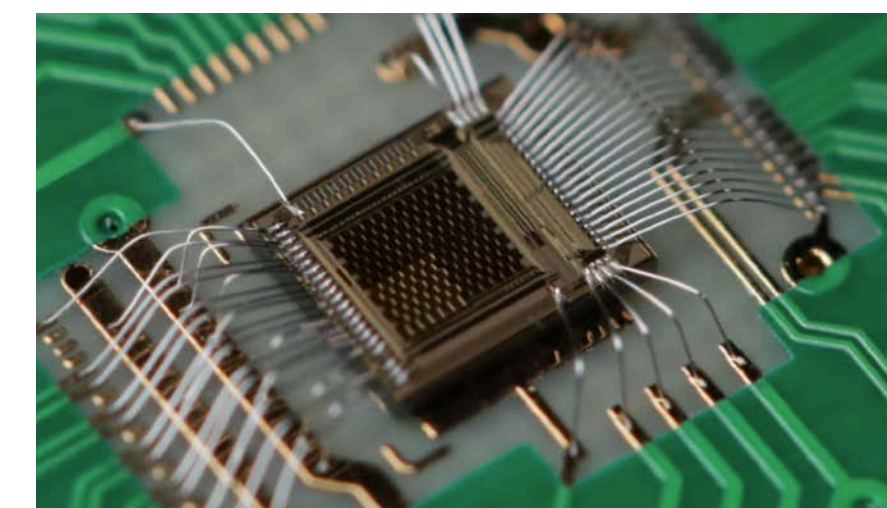


10 ps sensors:

- ▶ **3D** sensors (TIMESPOT Project)



- ▶ **PicoAD** (MONOLITH Project)

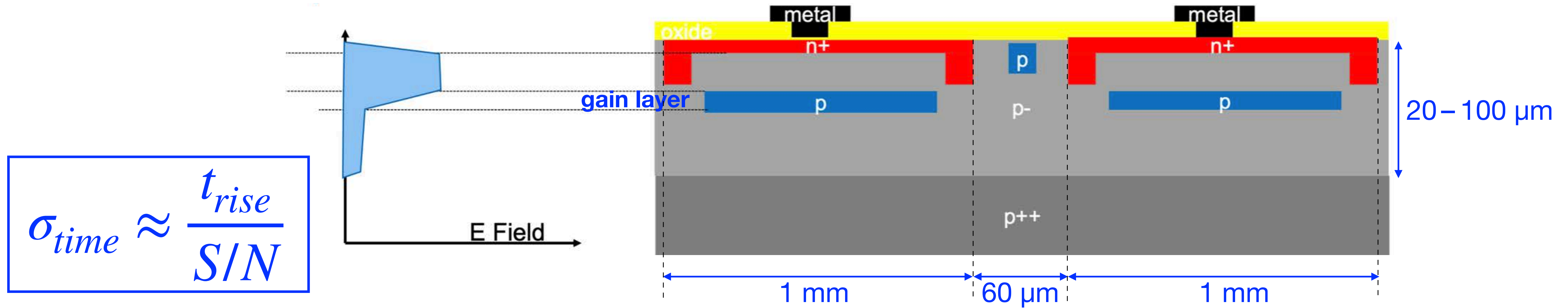


Low Gain Avalanche Detectors

LGAD

Low Gain Avalanche Detectors

LGADs: developed and being produced for HL-LHC

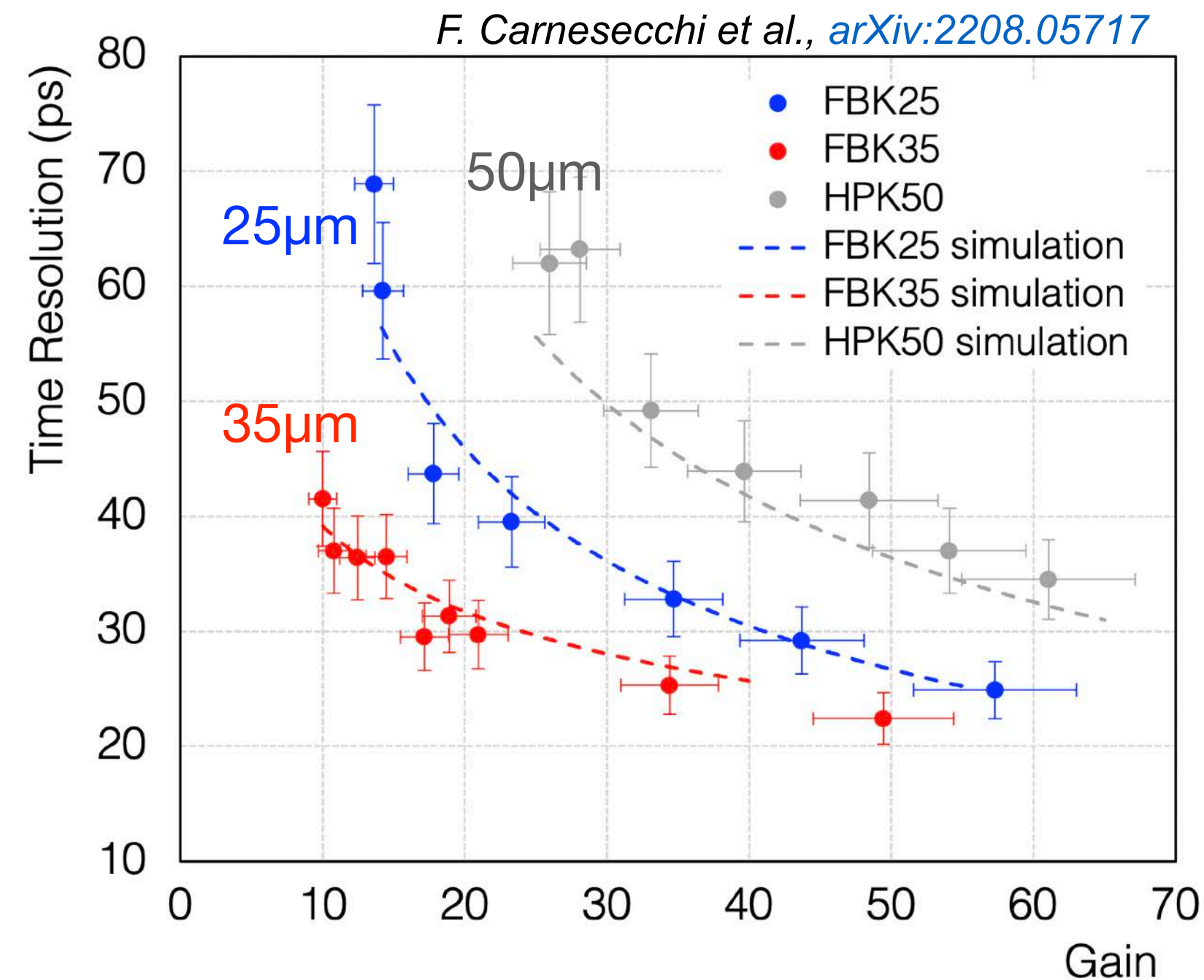


- ▶ Internal charge multiplication (**gain** = 10 – 20) \Rightarrow S/N increases and gives better σ_{time}
- ▶ **Hybrid** silicon “pad” sensors; 1 mm pads, with $\lesssim 100\mu\text{m}$ inactive inter-pad region
- ▶ Depleted thickness 20 – 100 μm
- ▶ Time resolution: **25 – 35 ps** (depending on the thickness)



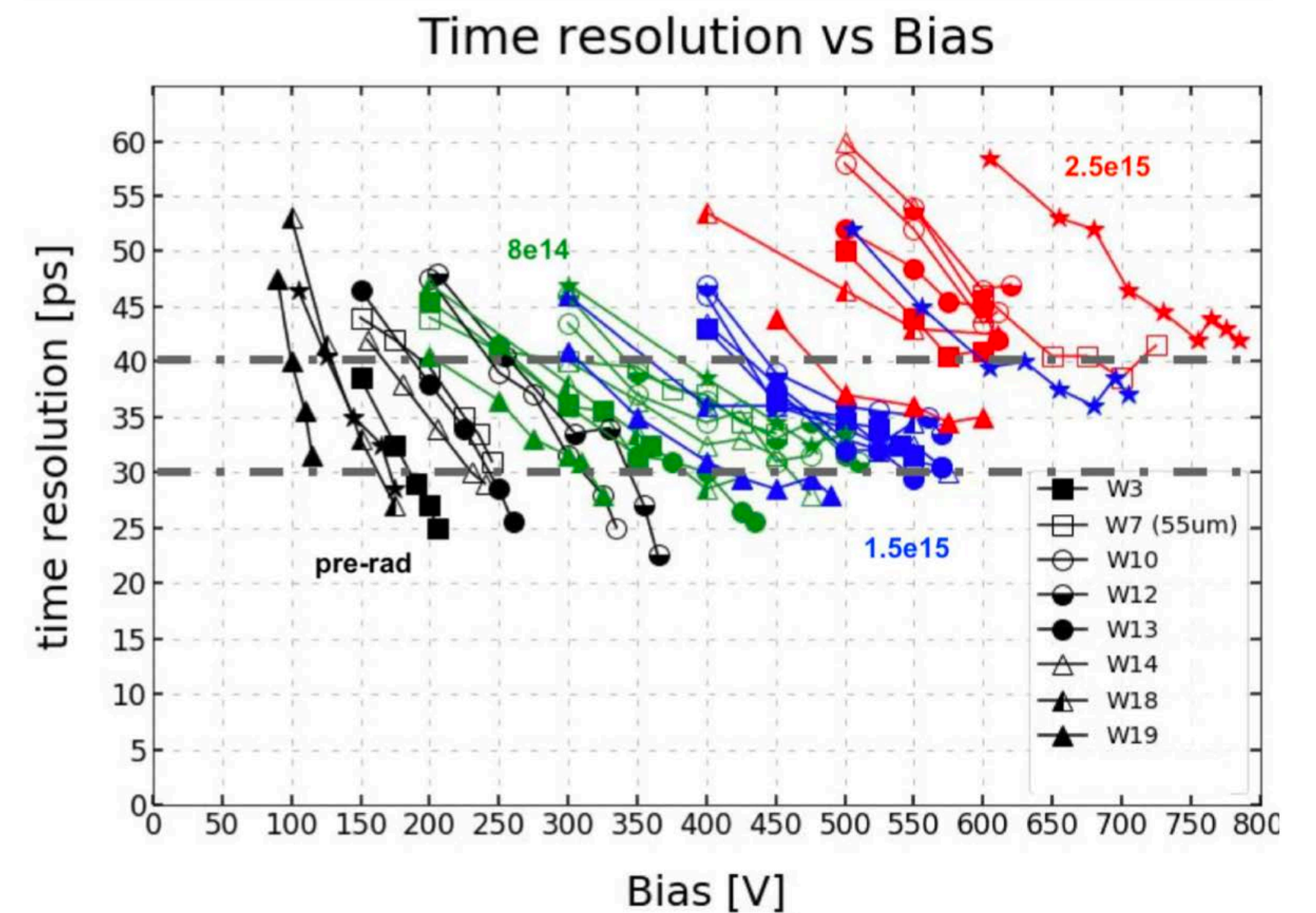
Low Gain Avalanche Detectors

Recent test of **ultra-thin** FBK LGADs :



35 µm thick LGADs approach 25 ps time resolution (mostly due to reduction of Landau-noise jitter)

Demonstrated **radiation tolerance** and time resolution for HL-LHC:

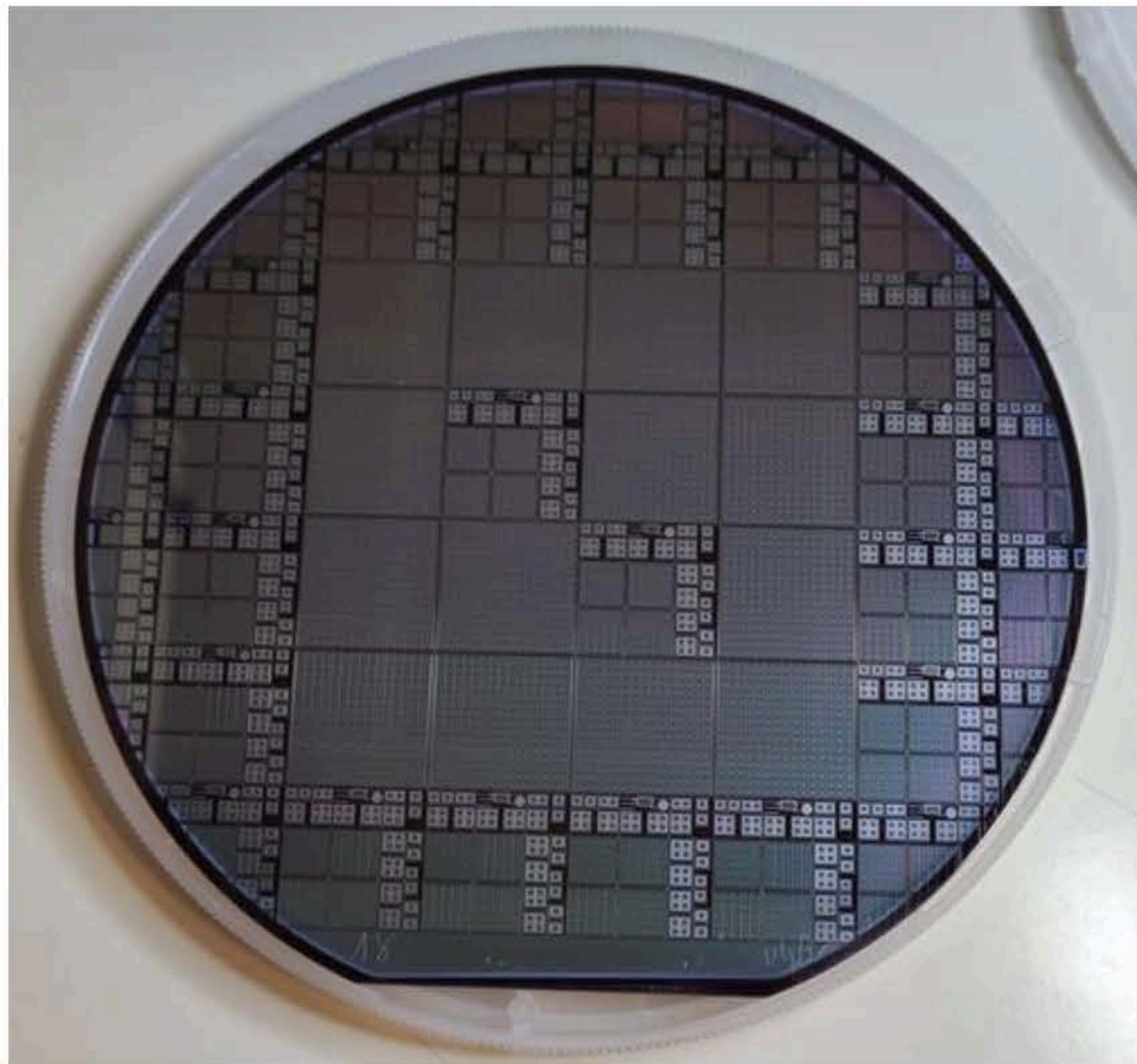


σ_T [ps]	NIEL [n_{eq}/cm^2]
30	$1 \cdot 10^{15}$
40	$2.5 \cdot 10^{15}$

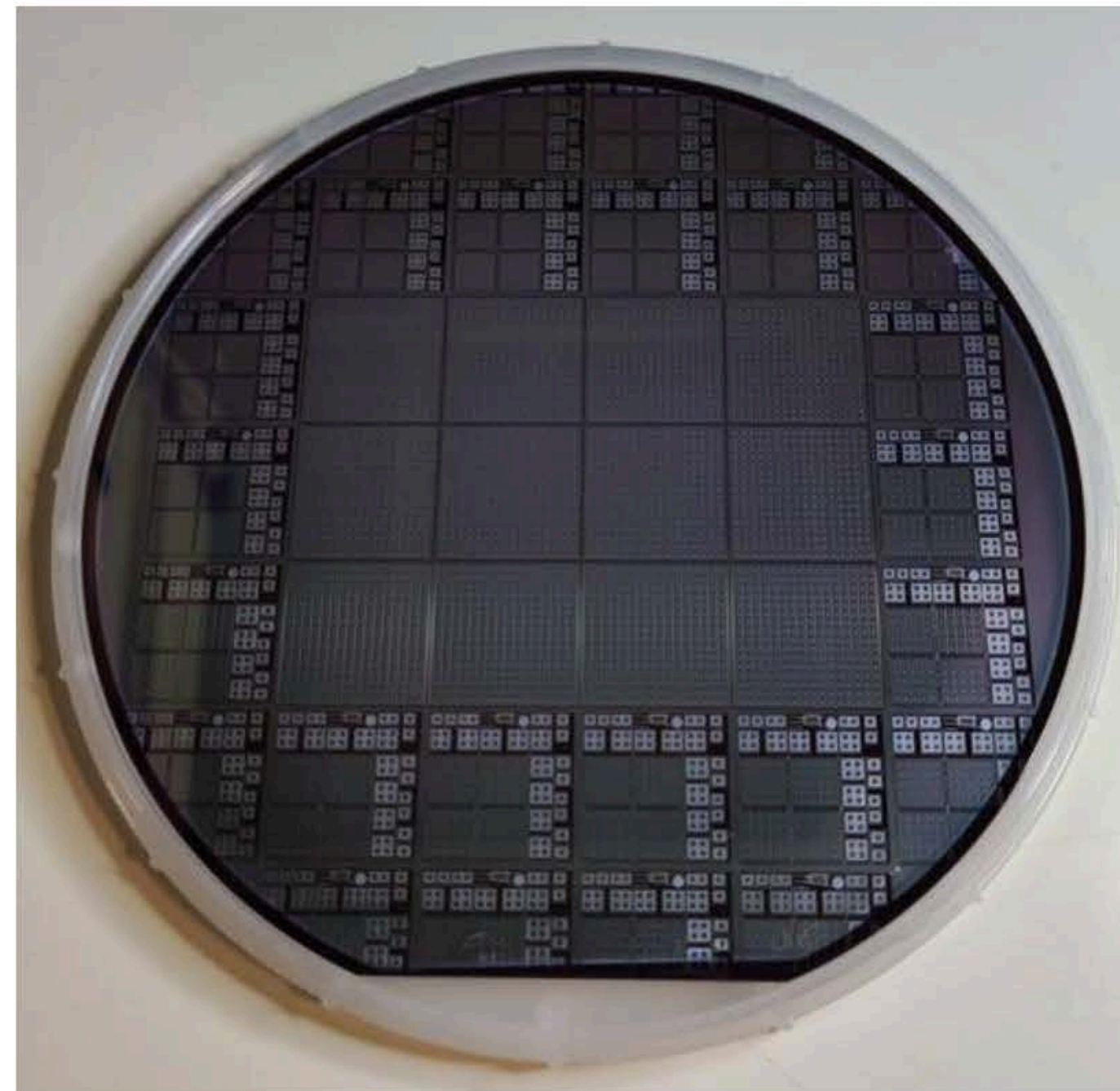
Low Gain Avalanche Detectors

LGADs now being fabricated for the HL-LHC experiments:

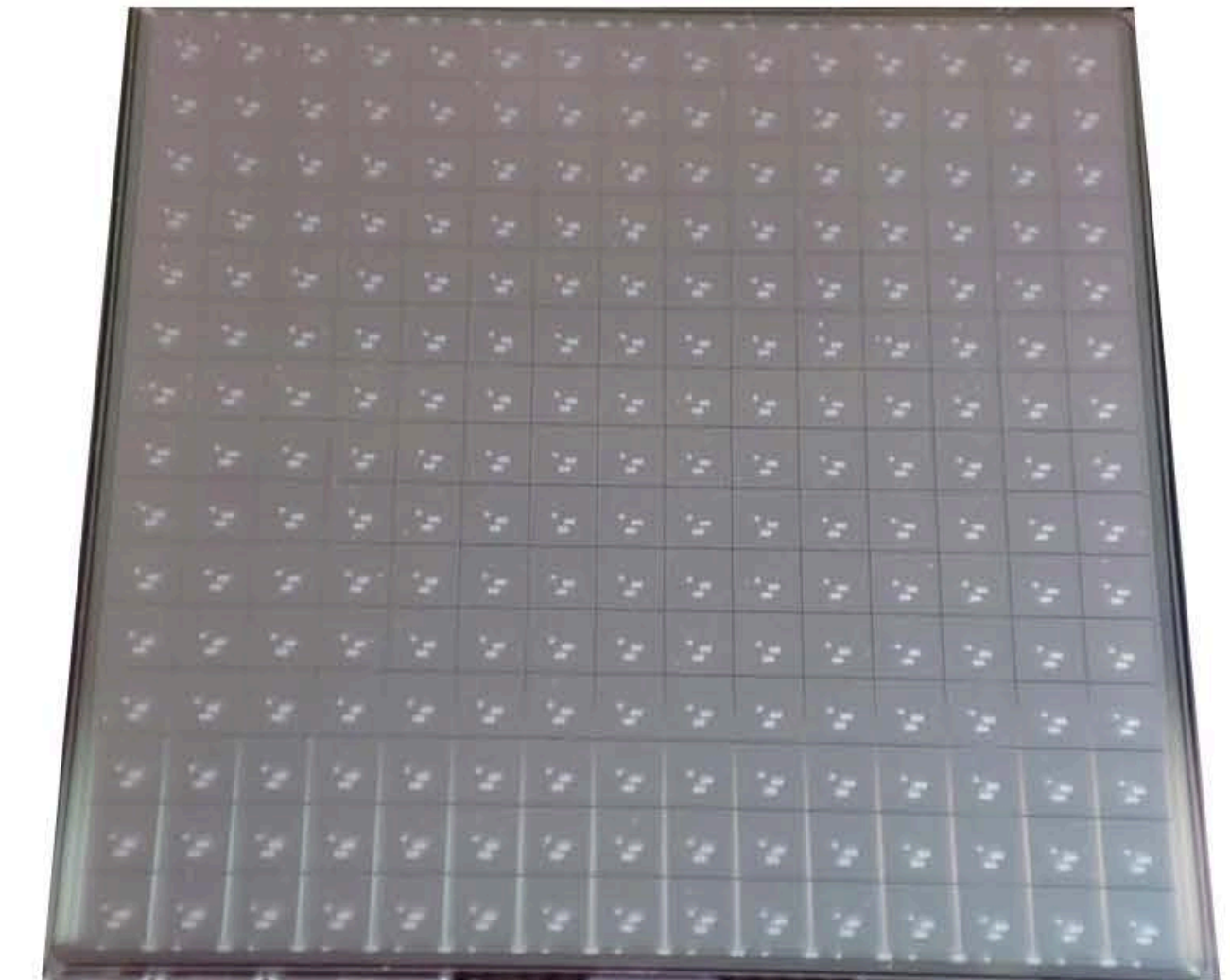
ATLAS - HGTD



CMS - ETL



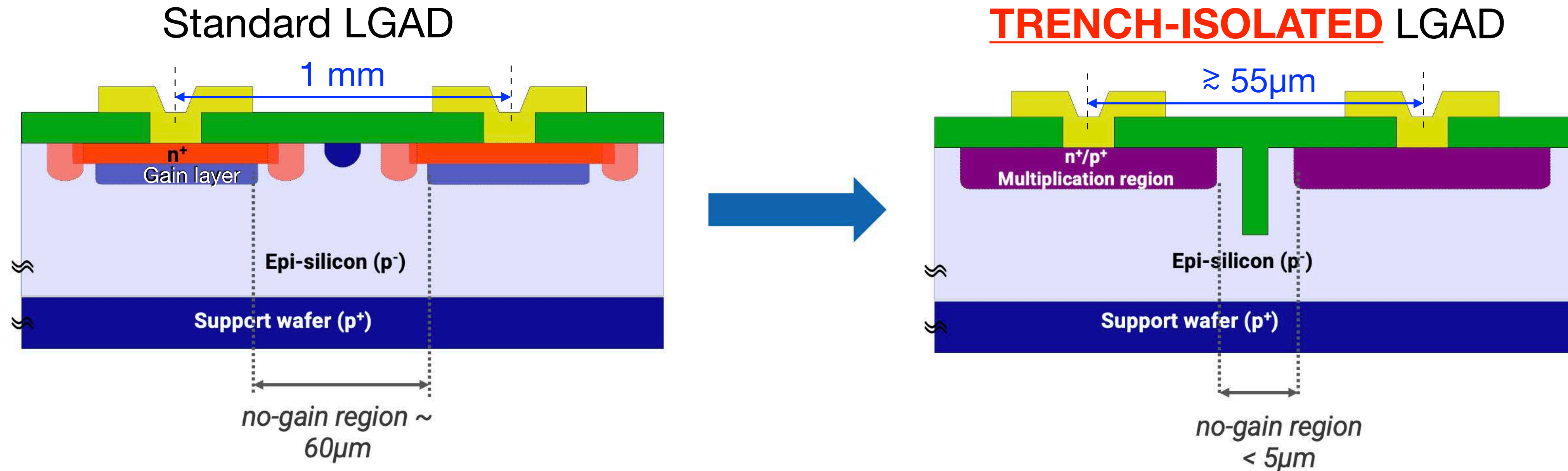
- Full sensors $\sim 2 \times 2 \text{ cm}^2$
- 15 x 15 and 16 x 16 arrays
- 1.3 mm^2 pads



UFSD 4 batch for final sensor qualification

(Courtesy of G. Paternoster)

LGAD: from pads to pixels

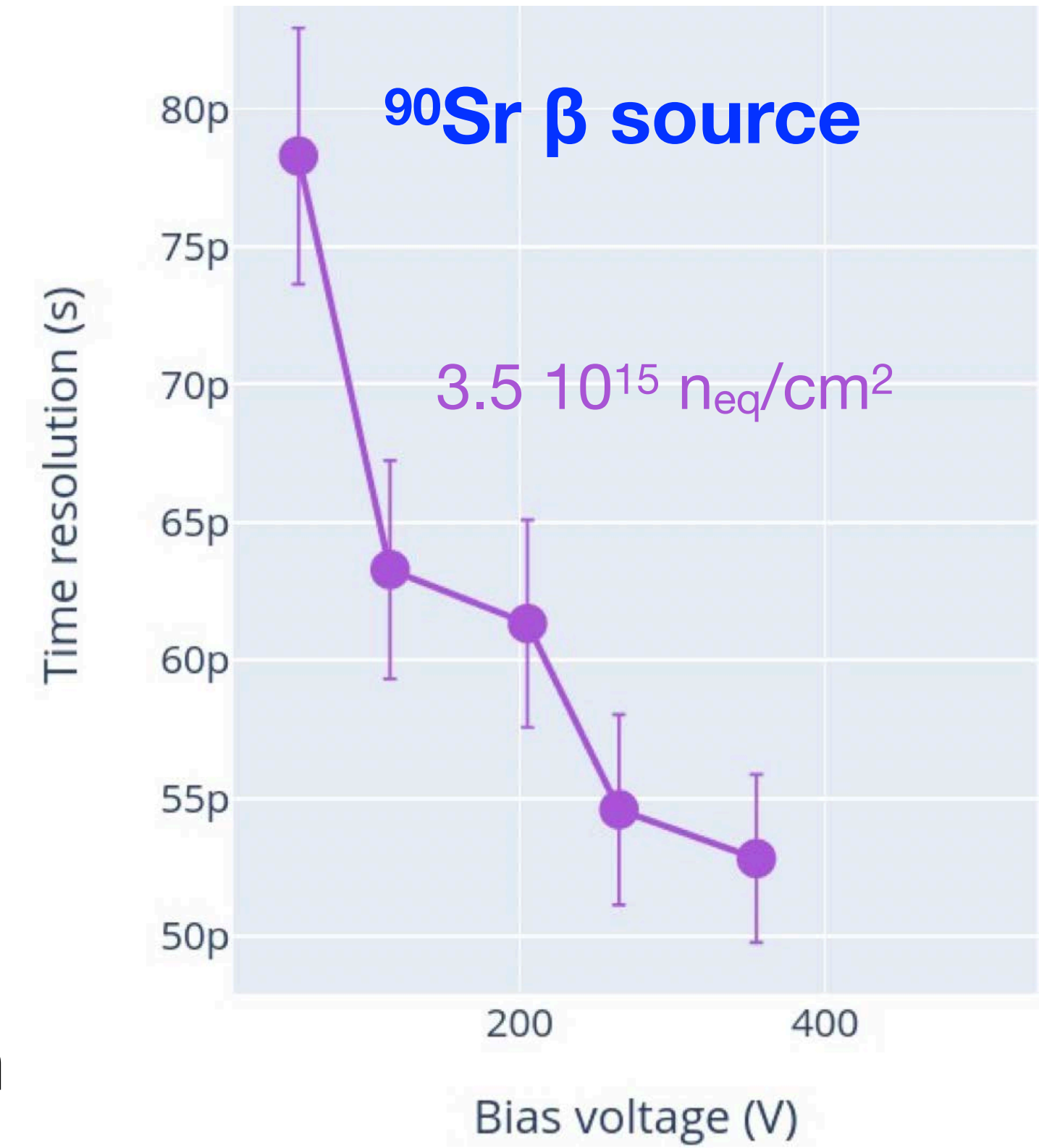
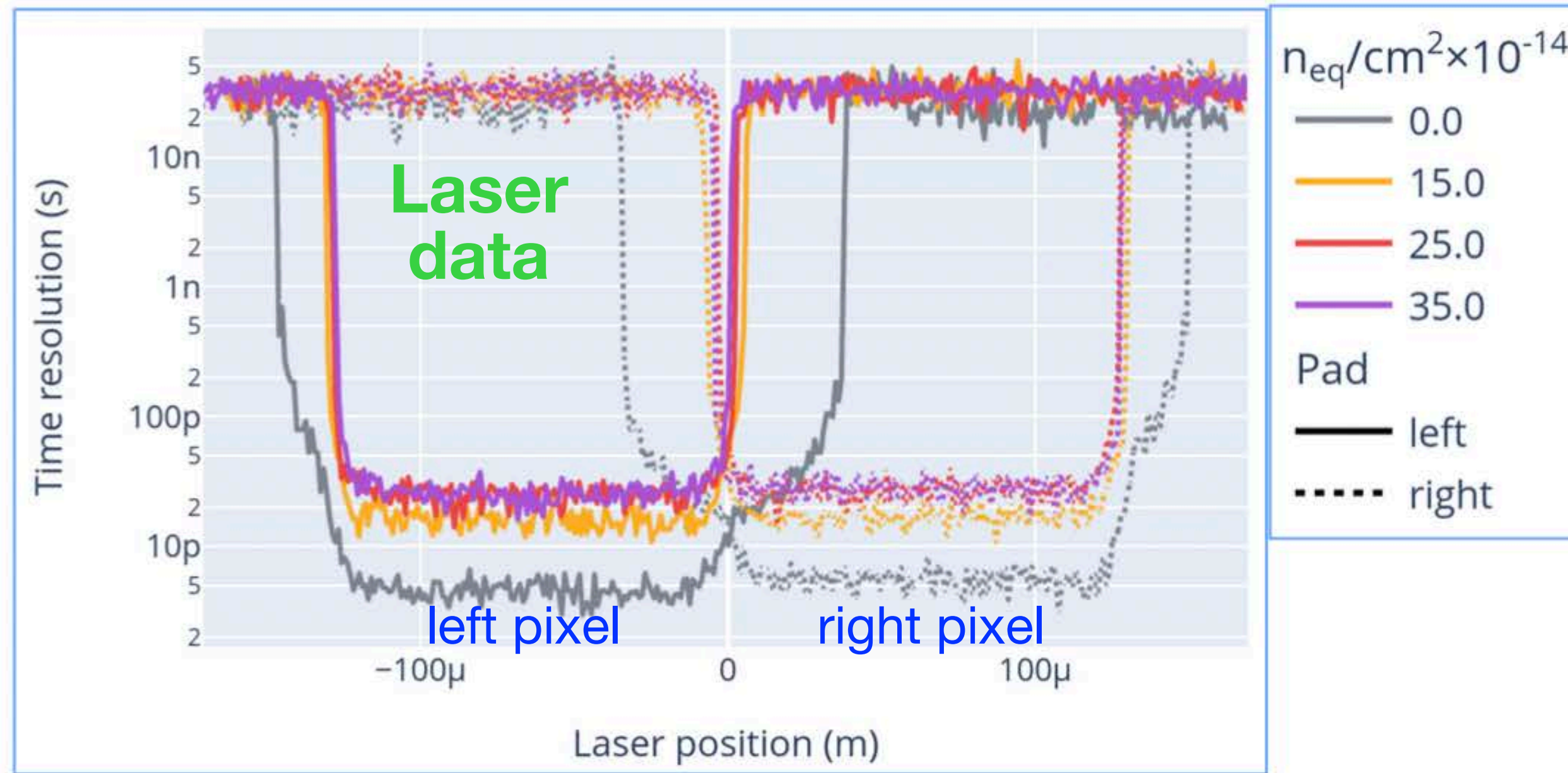


Pixel isolation and termination structures are replaced by a **trench** that:

- ▶ is a **few μm deep** and **~1 μm wide**, filled with silicon oxide
- ▶ acts as a **drift/diffusion barrier for electrons** and **isolates adjacent pixels**
- ▶ reduces the **inactive region in-between pixels** from ~60 μm to **few μm**

Prototypes already produced with pixel pitch down to 55 μm

TI-LGAD radiation tolerance



Pixel isolation by **trenches**: **good before and after irradiation**
 Inter-pixel distance remains of few μm before and after irradiation

Time resolution degraded after irradiation, but still uniform until the edges:

NIEL level: 0 $3.5 \cdot 10^{15} \text{ n}_{\text{eq}}/\text{cm}^2$

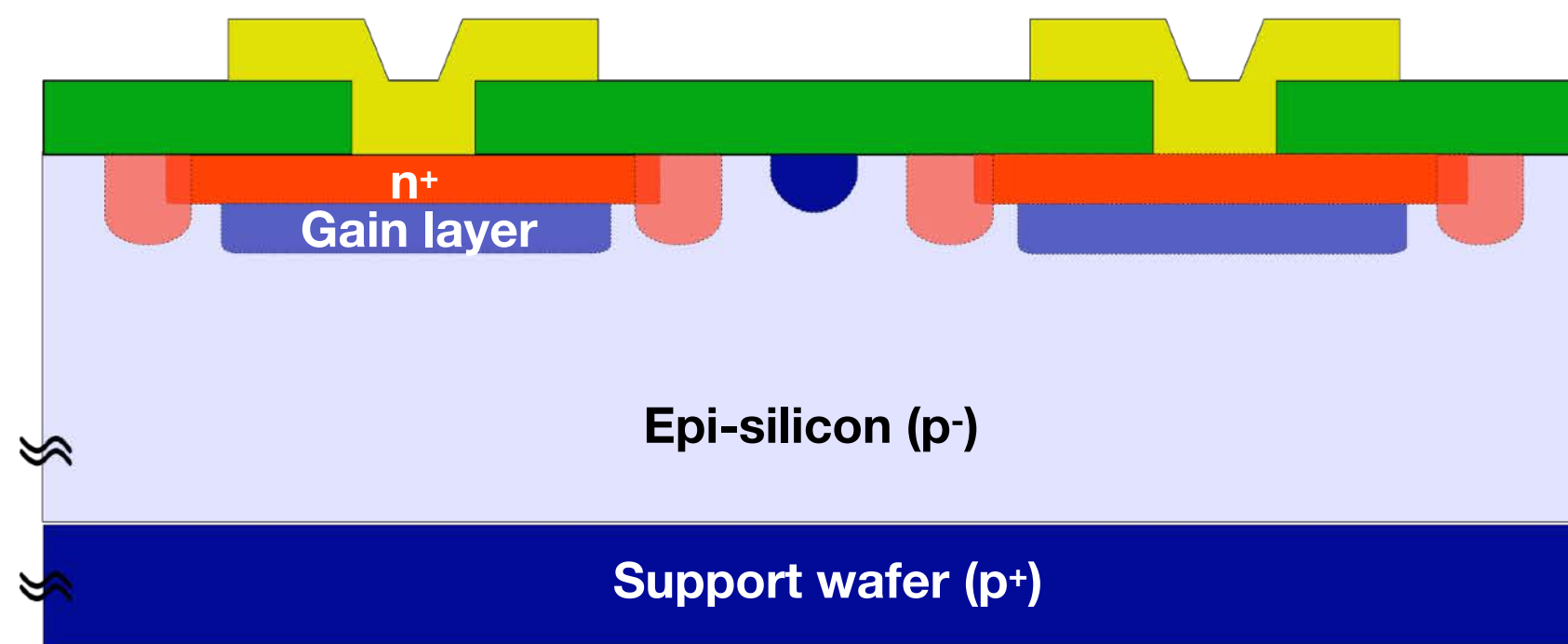
with **laser**: **5ps** \rightarrow **30ps**

with **^{90}Sr** : **35ps** \rightarrow **60ps**

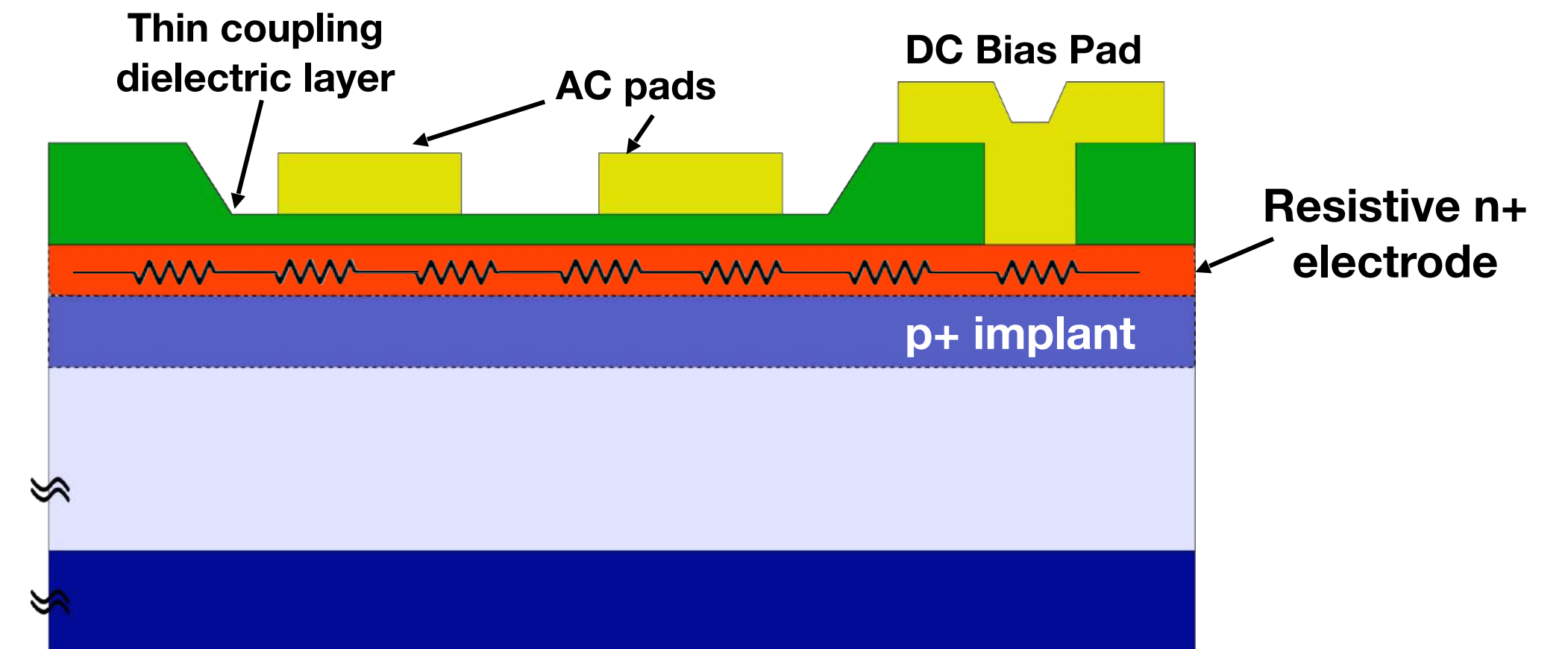
M. Senger – VCI 2022

Resistive AC-Coupled LGADs

Standard LGAD



AC-Coupled Resistive LGAD



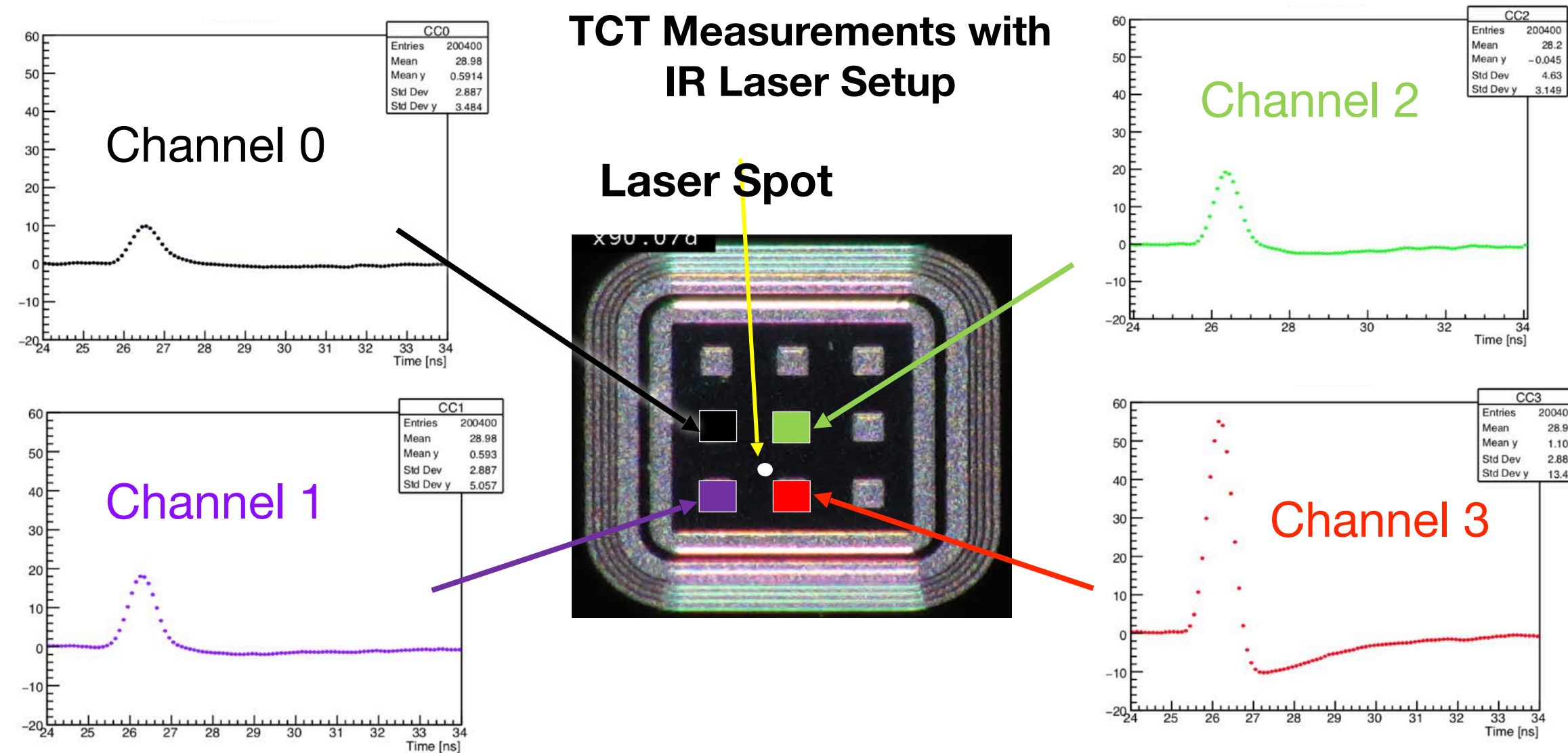
- ▶ **AC-coupled** to the **resistive n+ layer** via dielectric coupling
- ▶ Gain layer **NOT** segmented: **100% fill factor**
- ▶ Note that it is a **different way** to read out the signal and segment the sensor, since the **signal spreads over adjacent pixels**



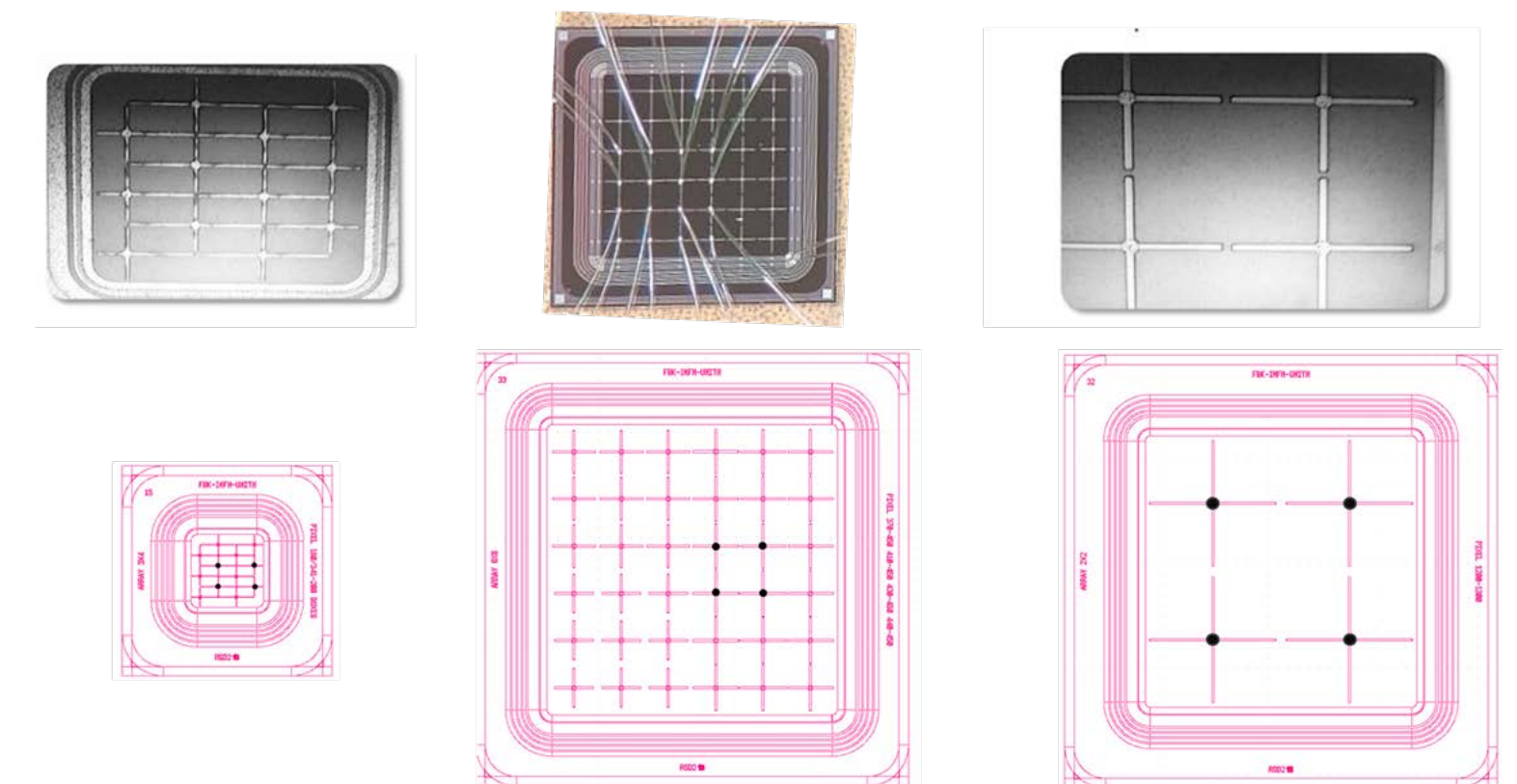
AC-Coupled LGAD: How does it work ?

Signal spreads over adjacent pixels, with **amplitude inversely proportional to the hit distance**

M. Tornago et al., NIMA 1003 (2021) 165319

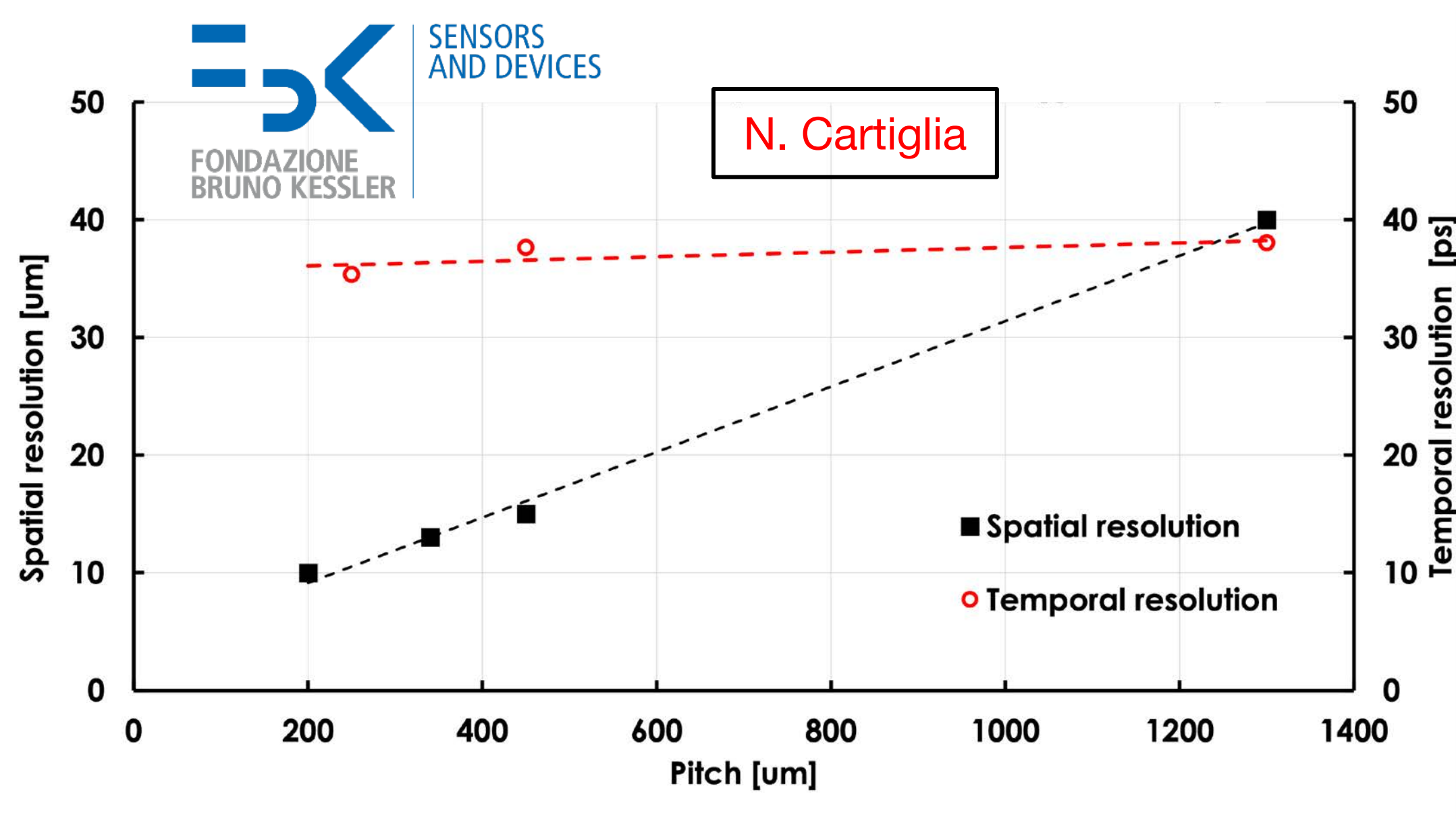


RSD2 production

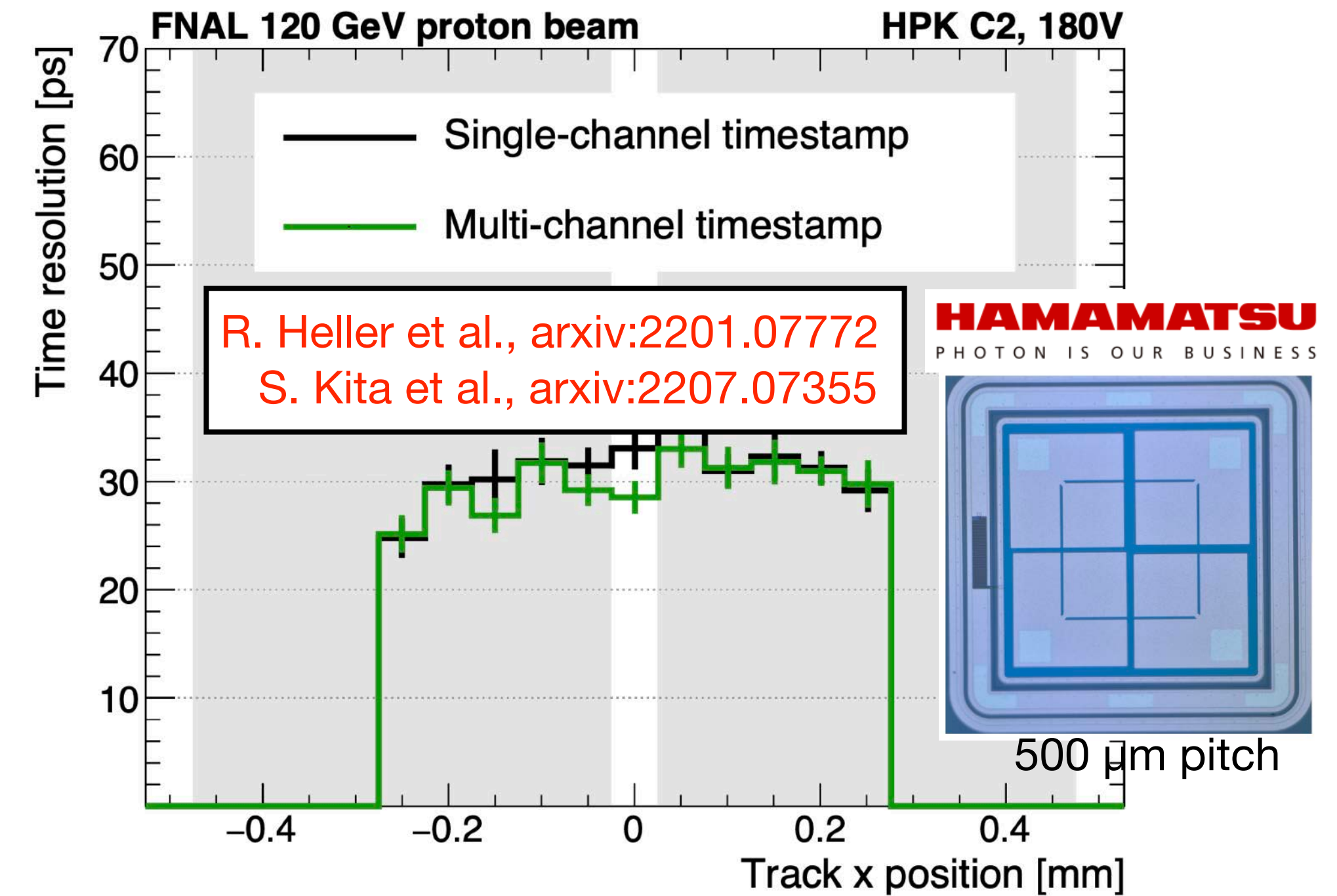


AC-Coupled LGAD

Pixel AC-LGAD by **FBK**

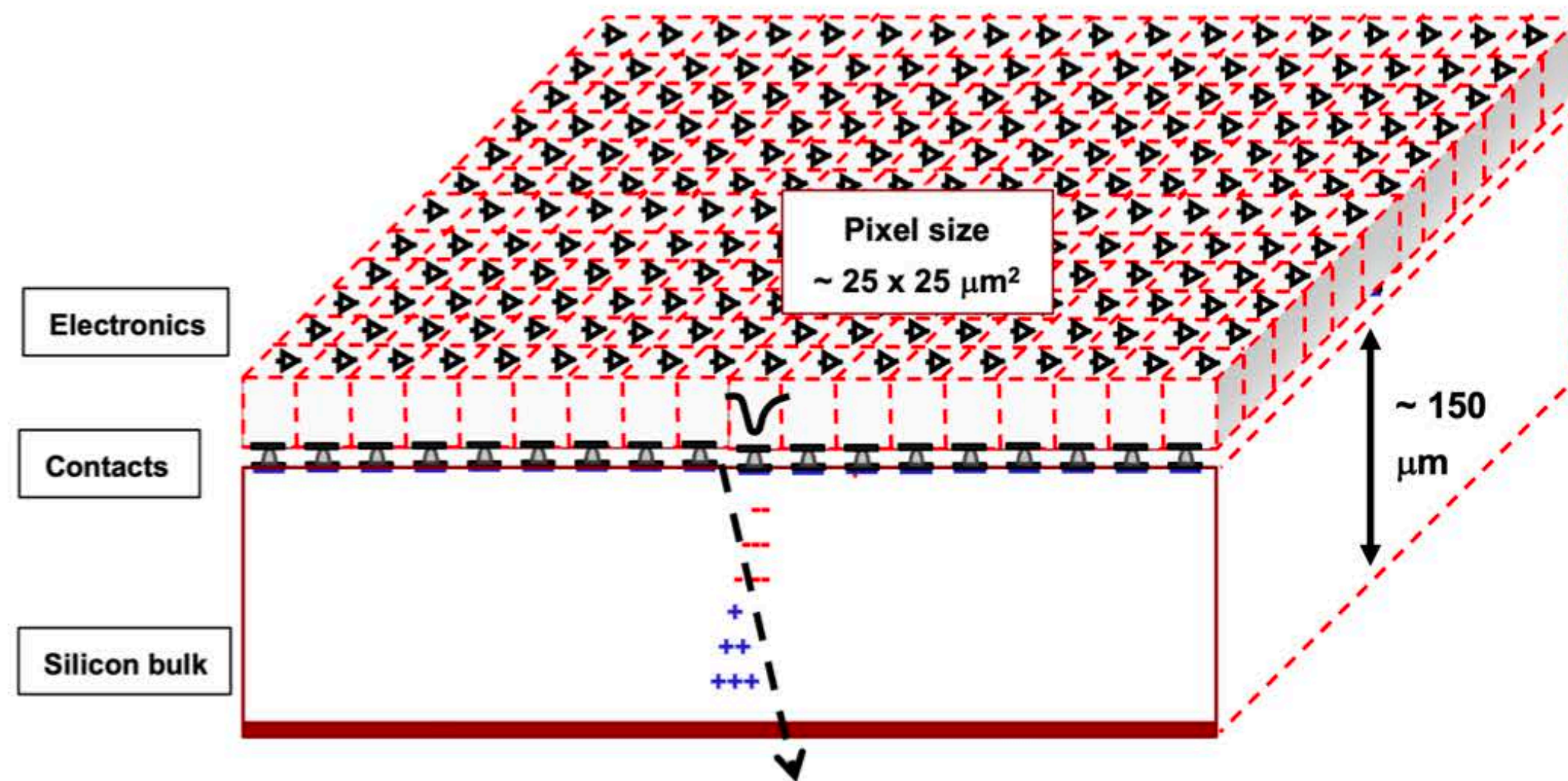


Pixel AC-LGAD by



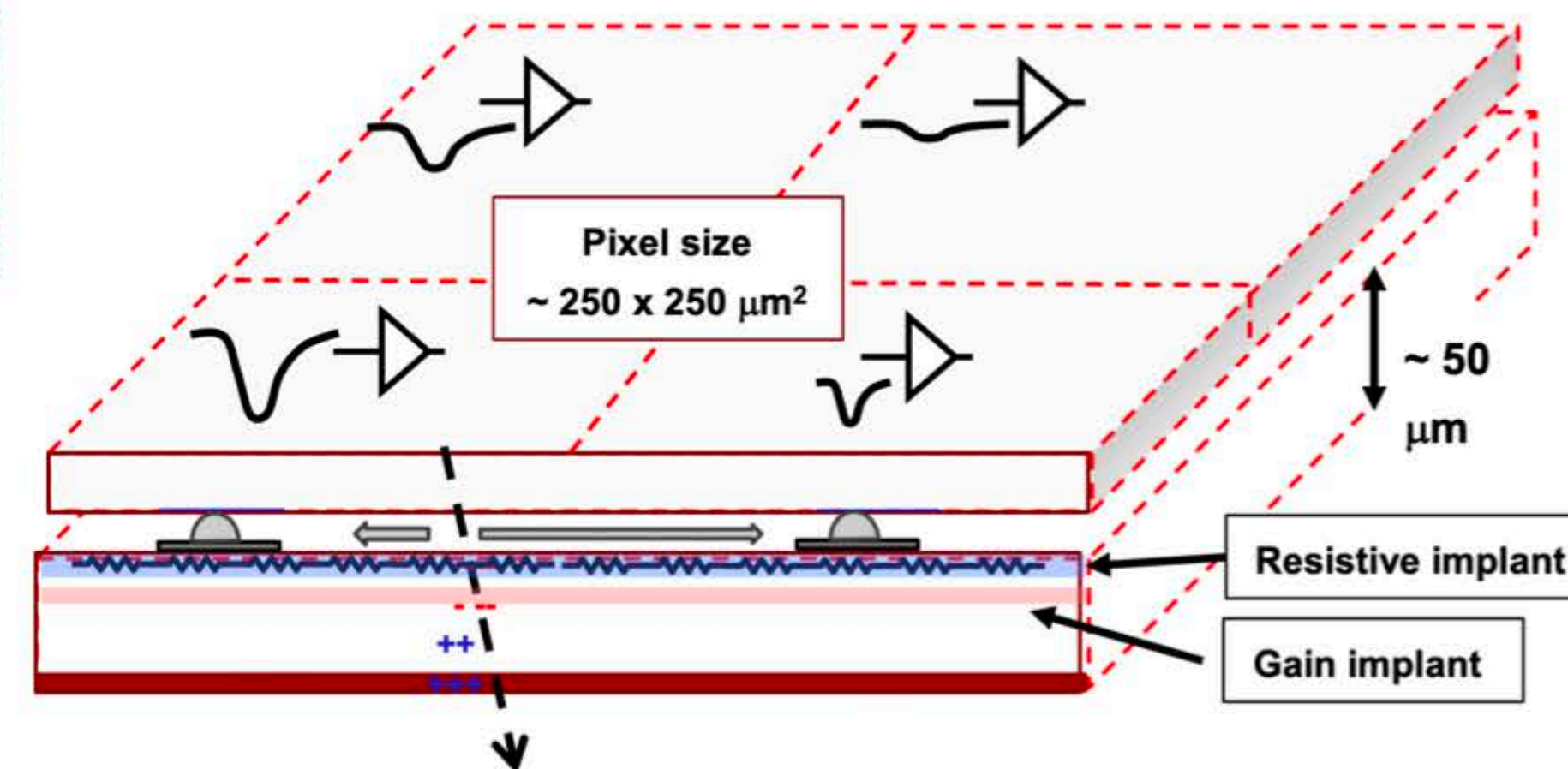
Time resolution: **30-35 ps**, regardless of pixel pitch
 Spatial resolution: **$\approx 4\mu\text{m} + 3\%$ of pixel pitch**

AC-Coupled LGAD is a candidate to combine in future experiments 30ps timing and few μm spatial resolution with a **reduced number of readout channels**



Standard Silicon Detector

Figure from N. Cartiglia et al., arxiv:2204.06536



Resistive Silicon Detector

Figure 10: Sketches of a standard silicon detector and of an RSD with the same spatial resolution of about 5-10 μm .

The TIMESPOT Project

3D sensors

“Gain? no thanks! go... Geometric!”

(A. Lai, INFN)

3D sensors: no gain, but geometry

Original idea by Sherwood Parker (1997)

Hybrid sensor in which **collection electrodes** are vertical highly doped **columns**

1. Very short drift distance to collection electrode

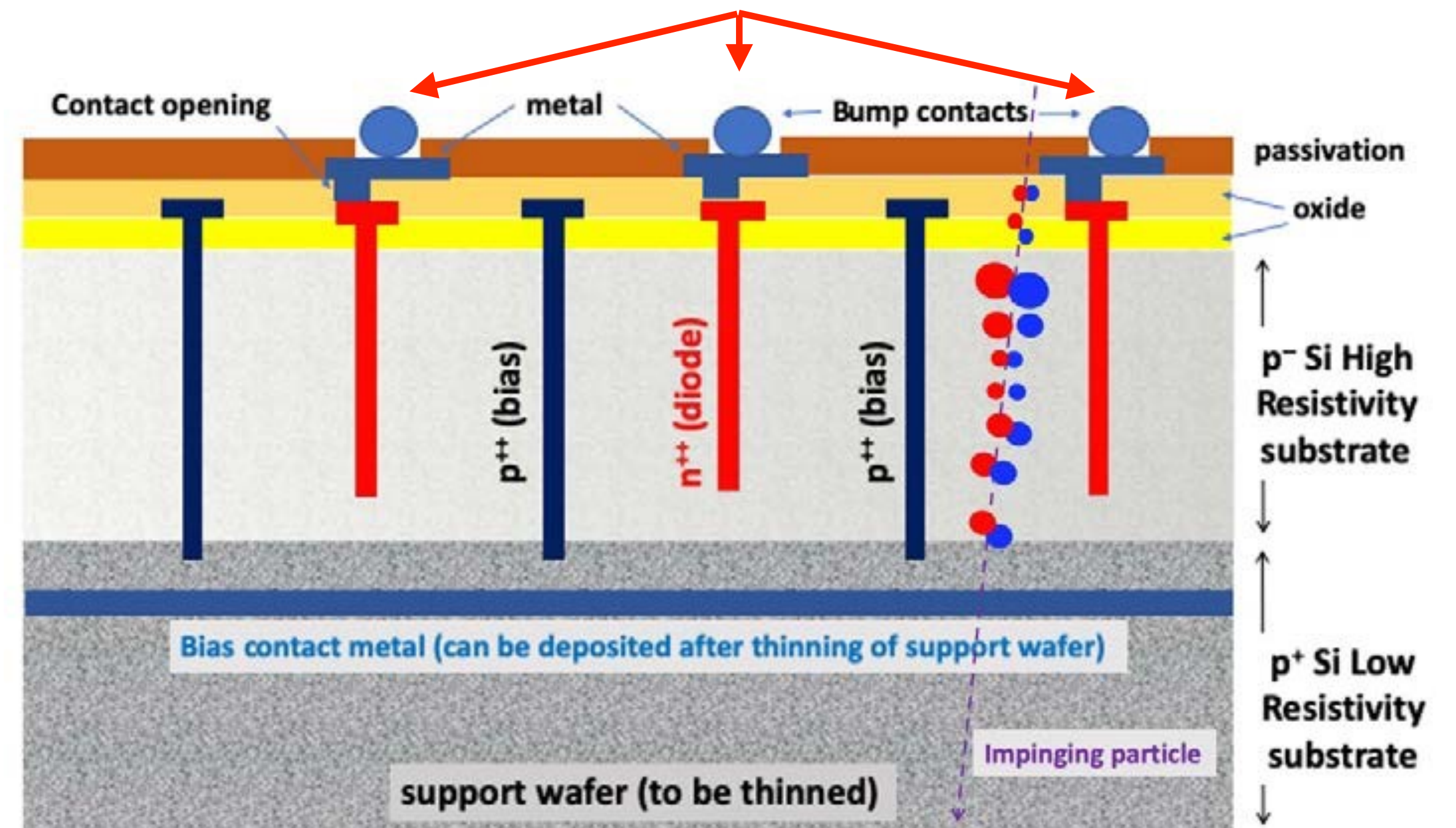
➔ *Fast charge collection*

2. Reduced distance to ohmic contacts

➔ *High drift field*

➔ *High weighting field*

➔ *Precise timing*

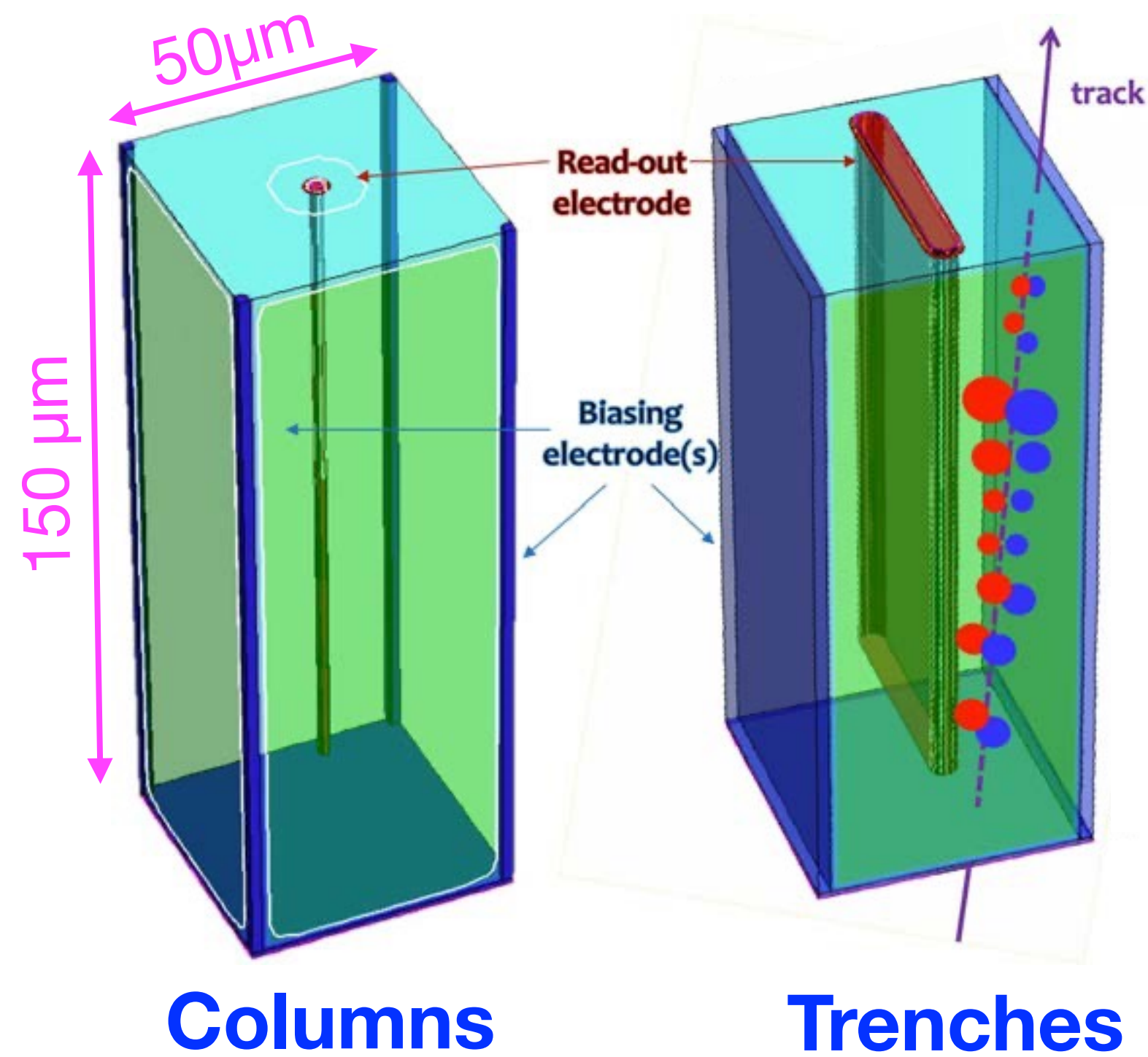


Columns produced by Deep Reactive Ion Etching (Bosch technology developed for MEMS)

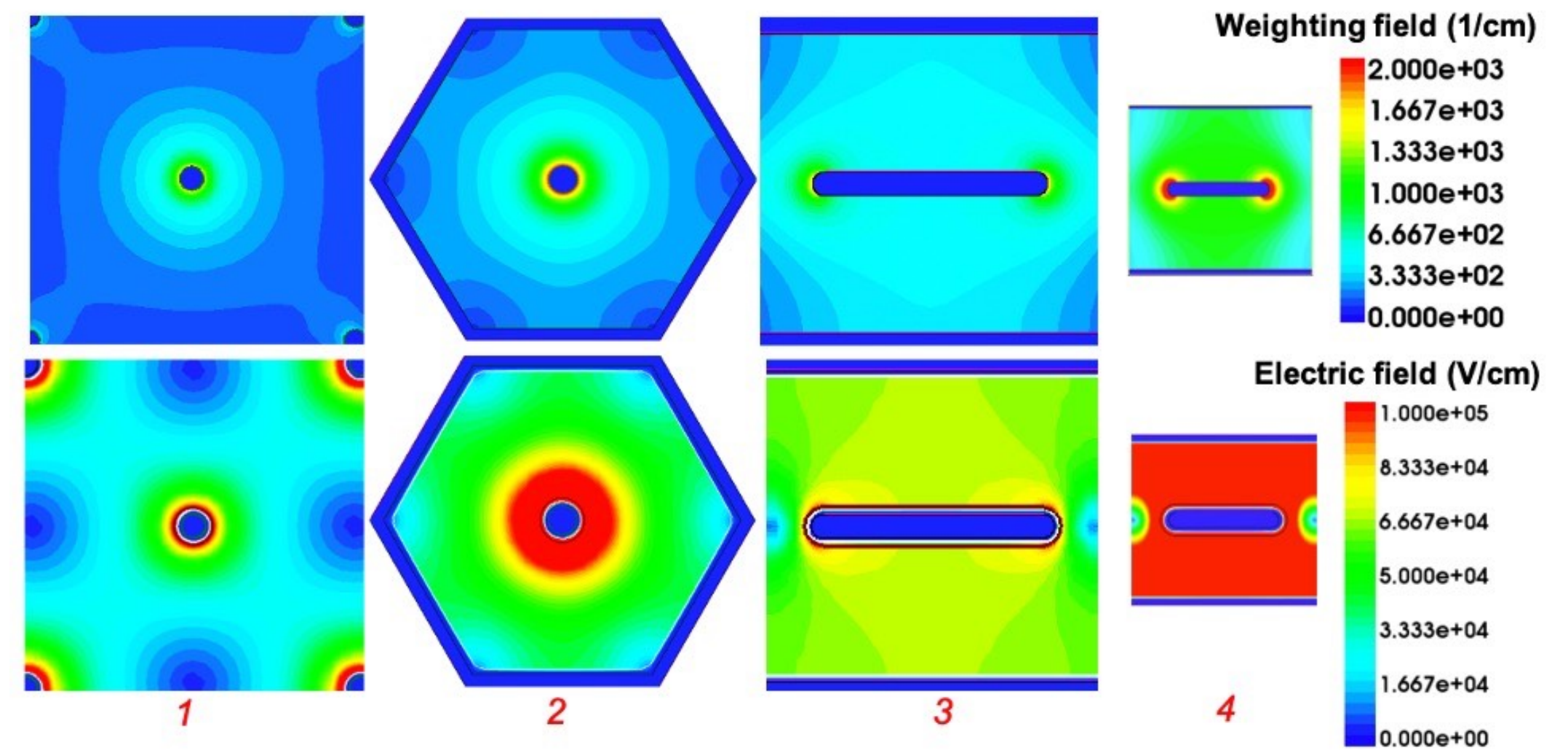
Challenge:

Inefficiency in region of collection electrode at perpendicular particle incidence

Sensitive volume and electrode shapes designed for maximum performance:



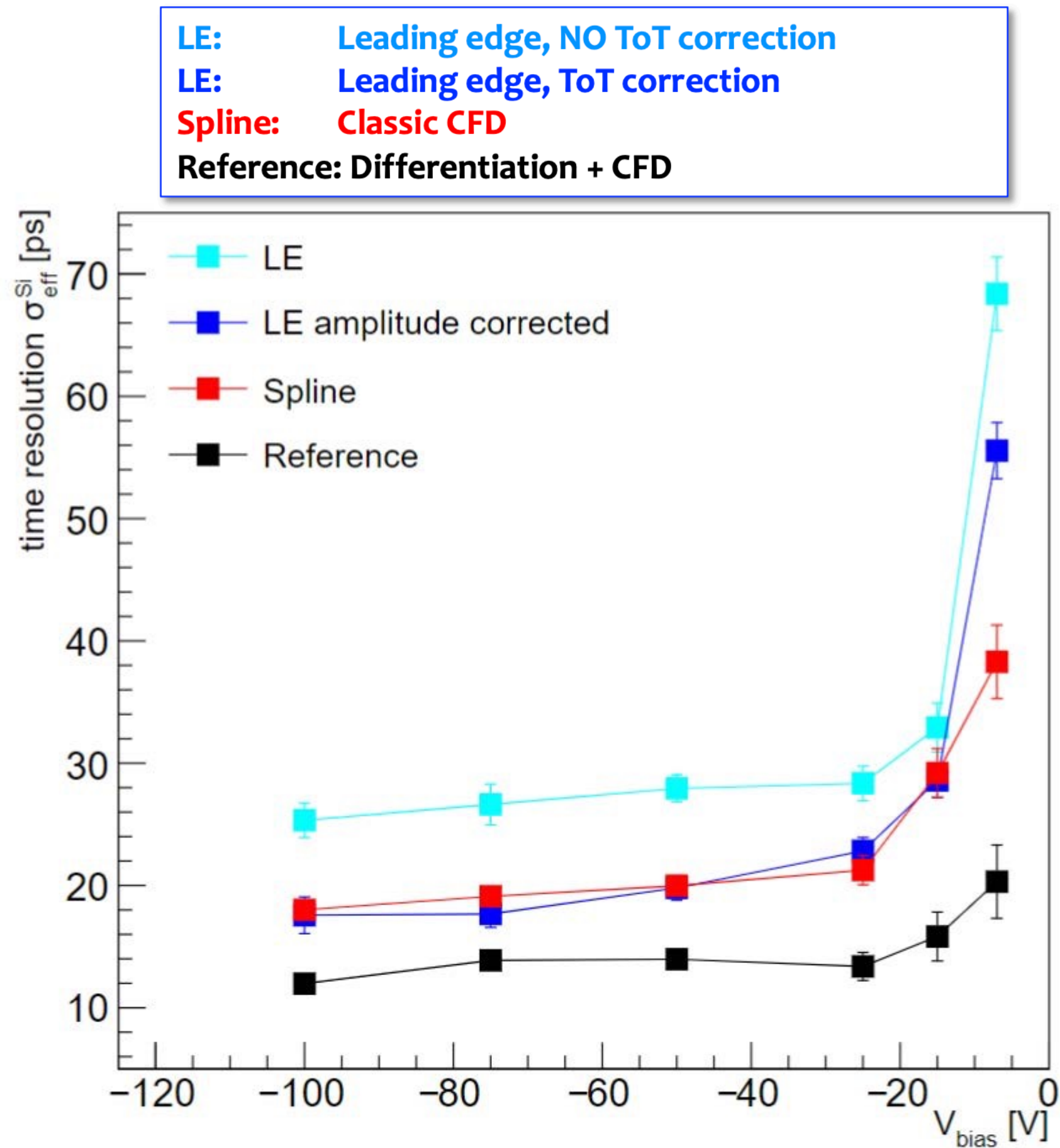
TCAD simulation of three electrode geometries:



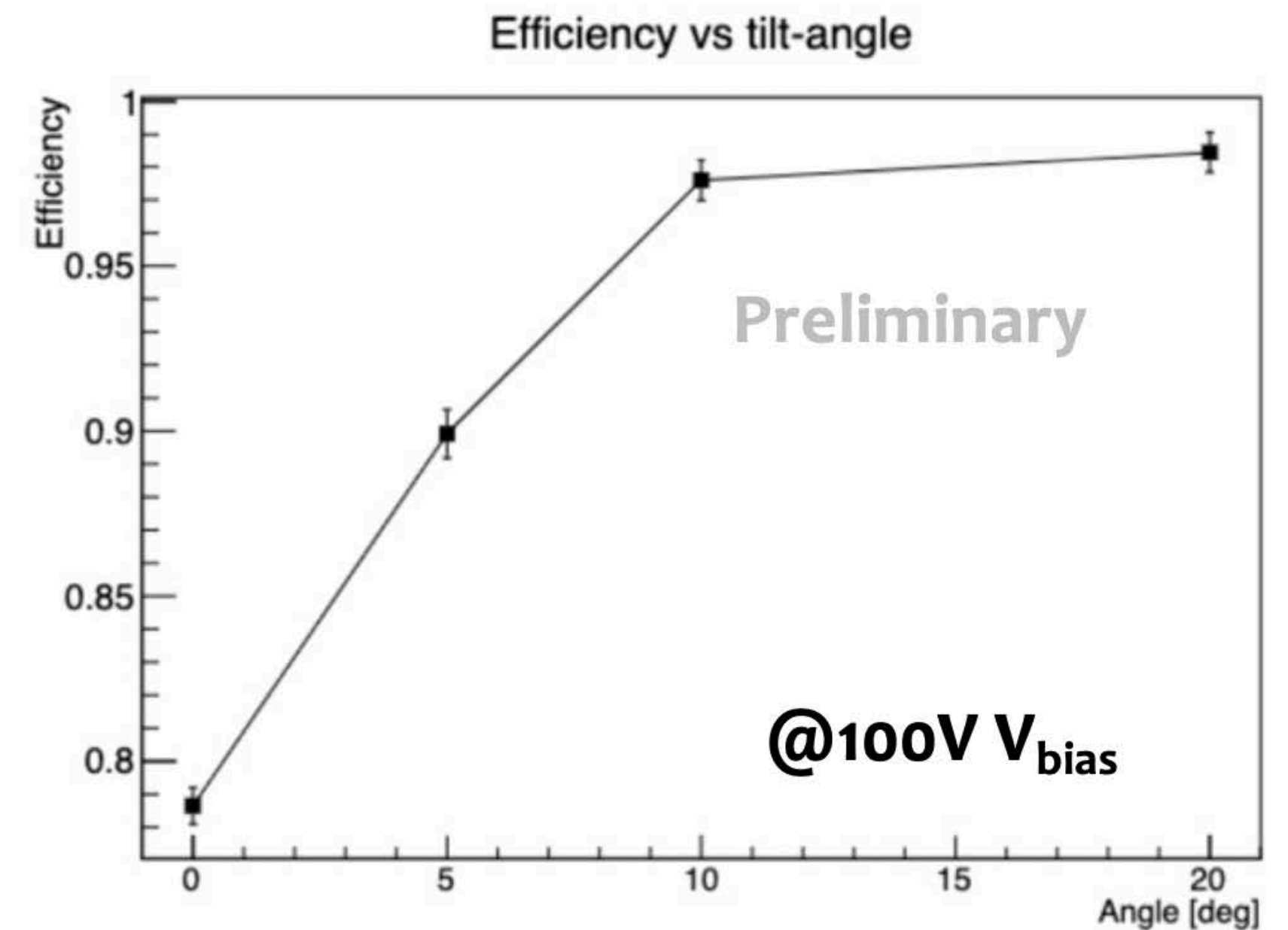
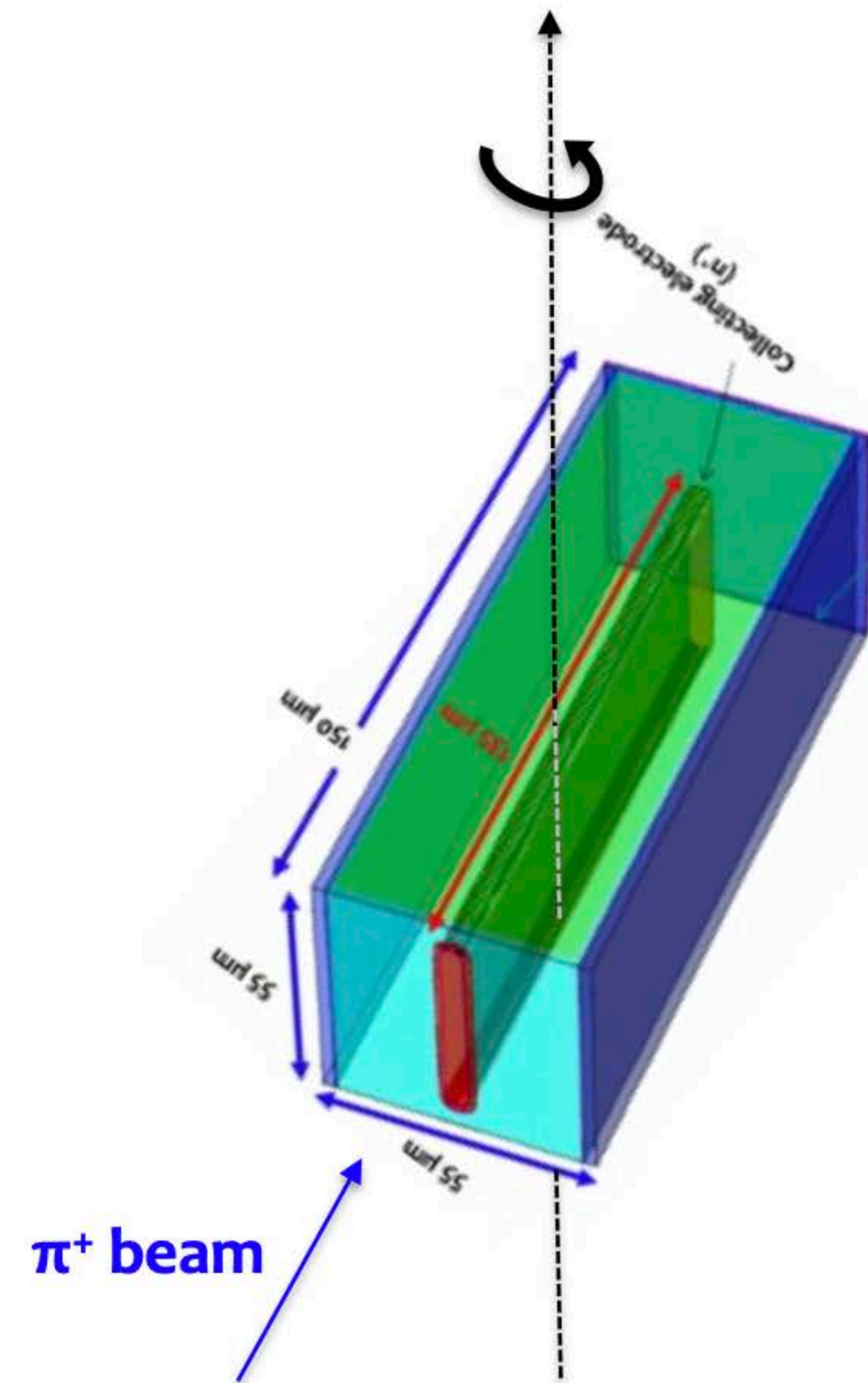
Trench geometry offers the best configuration



Timespot: testbeam results

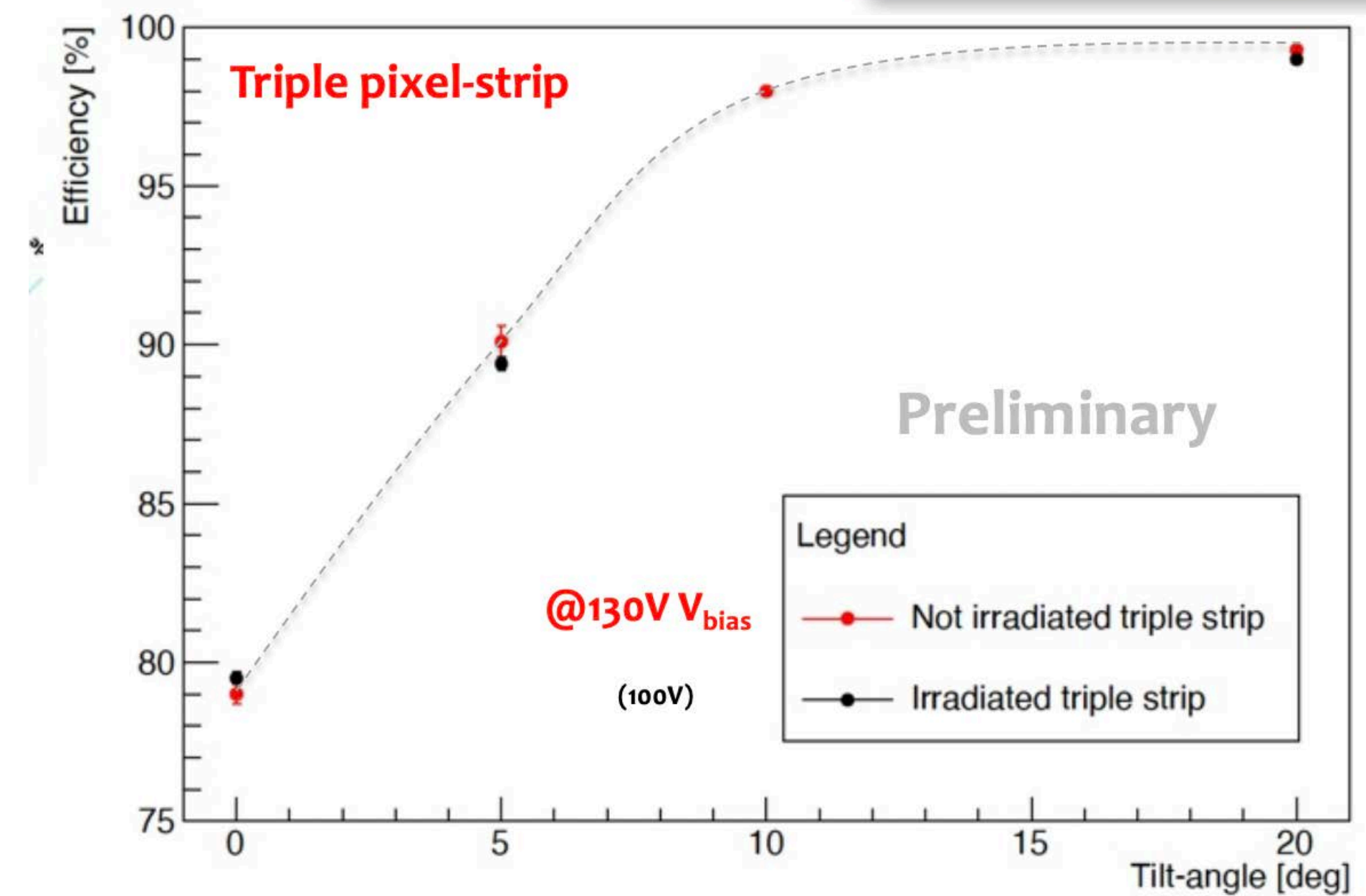
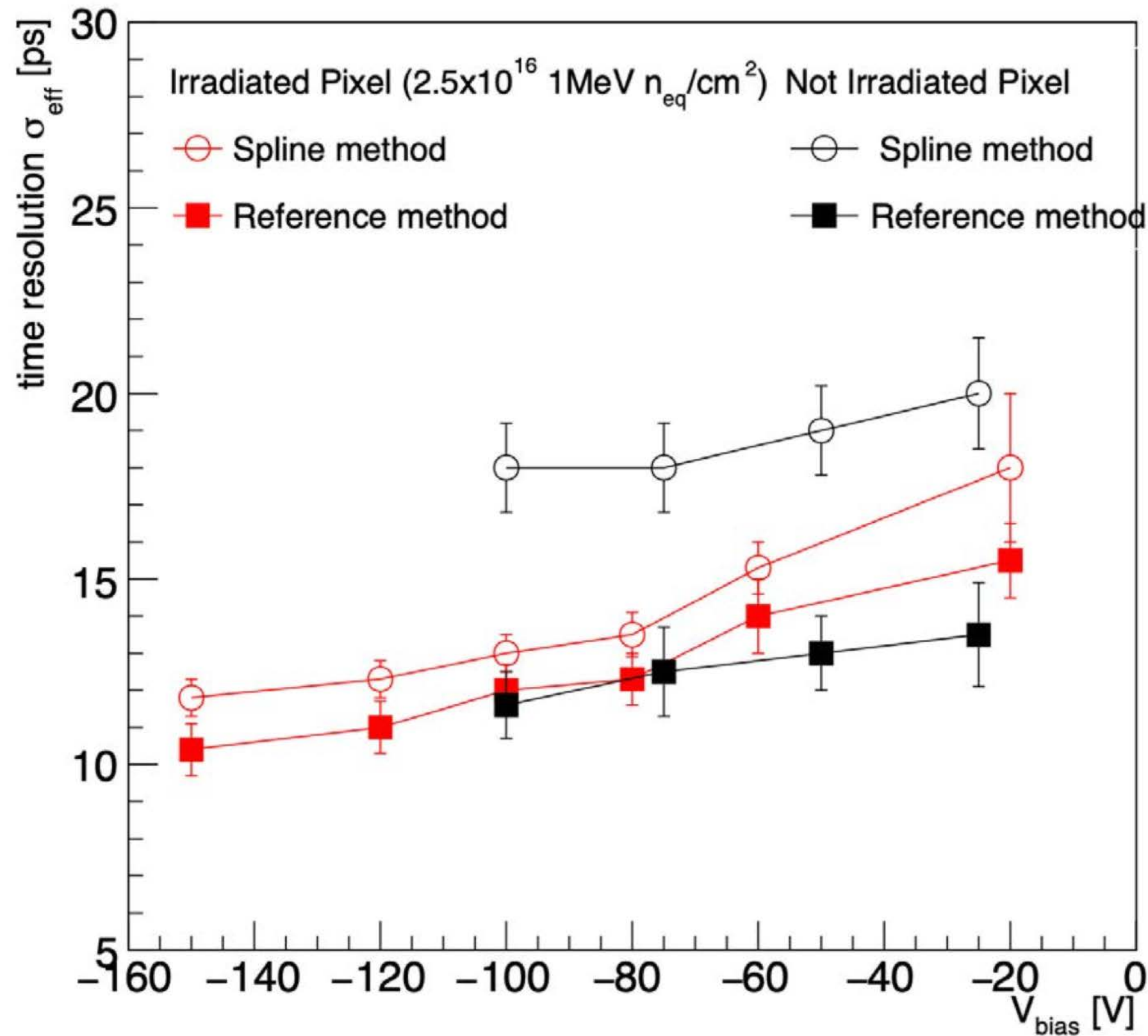


Time Resolution: down to ≈ 12 ps



Efficiency $\sim 80\%$ for particle angle = 0° ,
due to **trenches dead area**.
Recovered for angles $\gtrsim 10^\circ$

Timespot: irradiated sensors



3D sensors are **intrinsically radiation hard**:

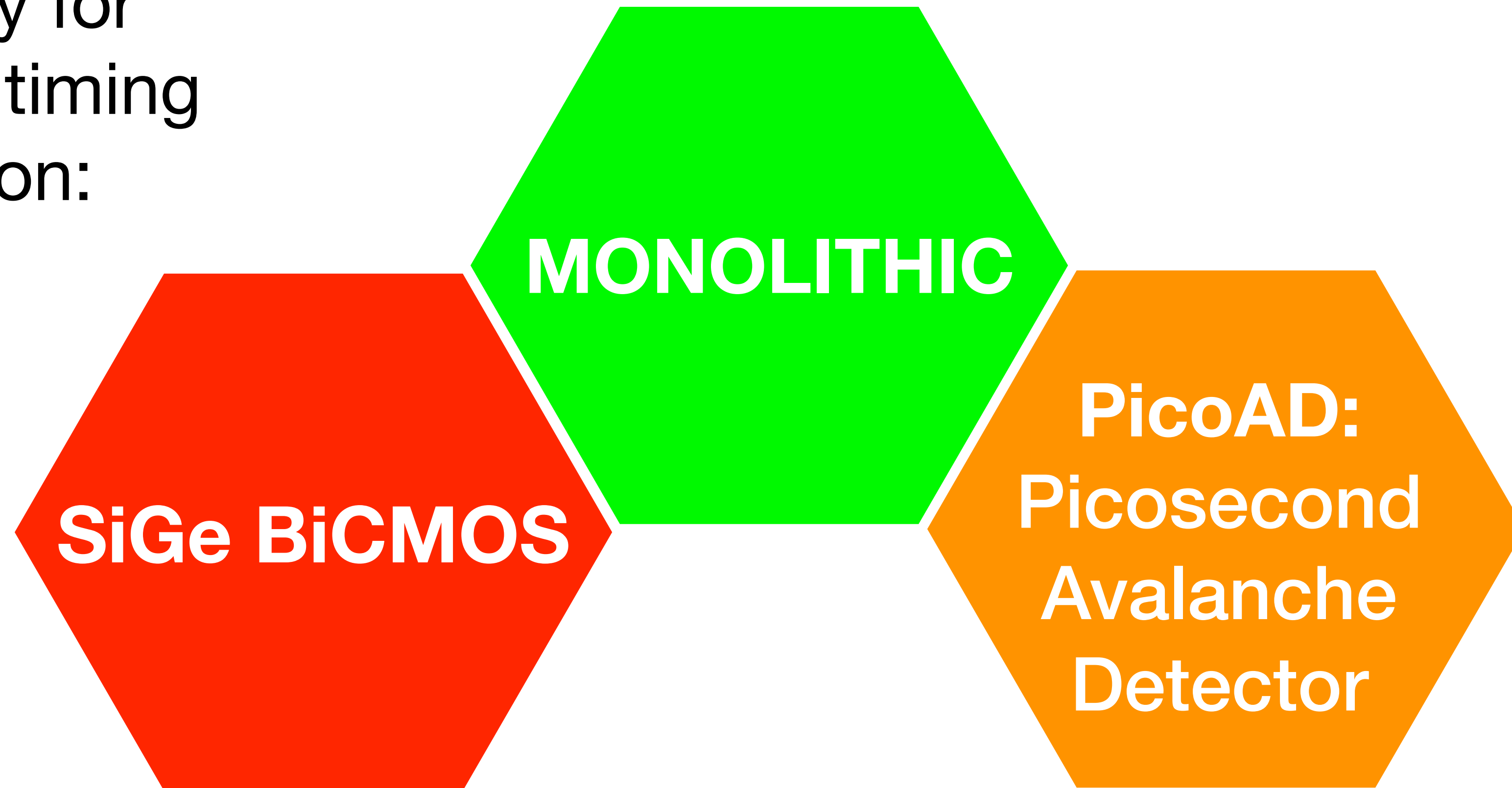
time resolution and efficiency maintained even after the extreme fluence of $2.5 \cdot 10^{16}$ $n_{\text{eq}}/\text{cm}^2$



European Research Council
Established by the European Commission

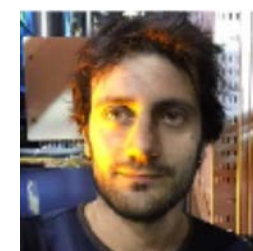
The **MONOLITH** Project

Our recipe for
picosecond timing
with silicon:



**Giuseppe Iacobucci**

- project P.I.
- System design

**Lorenzo Paolozzi**

- Sensor design
- Analog electronics

**Didier Ferrere**

- System integration
- Laboratory test

**Sergio Gonzalez-Sevilla**

- System integration
- Laboratory test

**Thanushan Kugathasan**

- Lead chip design
- Digital electronics

**Magdalena Munker**

- Sensor design
- Laboratory test

**Yannick Favre**

- Board design
- RO system

**Stéphane Débieux**

- Board design
- RO system

**Roberto Cardella**

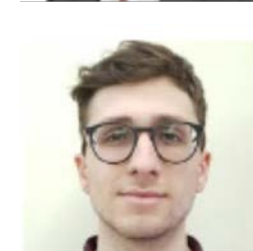
- Sensor design
- Laboratory test

**Stefano Zambito**

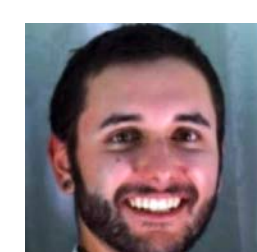
- Laboratory test
- Data analysis

**Mateus Vicente**

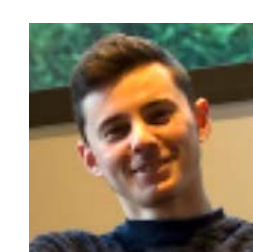
- System integration
- Laboratory test

**Fulvio Martinelli**

- Chip design
- Firmware

**Matteo Milanesio**

- Laboratory test
- Data analysis

**Théo Moretti**

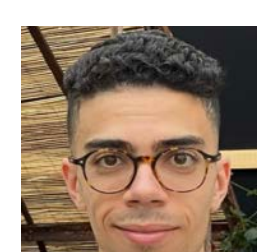
- Laboratory test
- Data analysis

**Antonio Picardi**

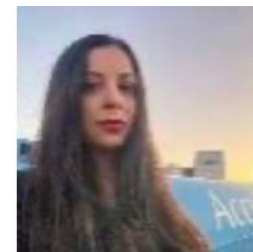
- Chip design
- Firmware

**Chiara Magliocca**

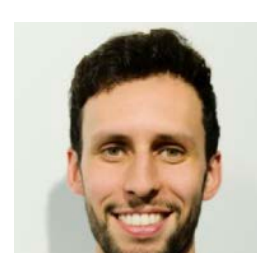
- Laboratory test
- Data analysis

**Jihad Saidi**

- Laboratory test
- Data analysis

**Rafaella Kotitsa**

- Sensor simulation

**Carlo Alberto Fenoglio**

- Chip design
- Firmware

**Luca Iodice**

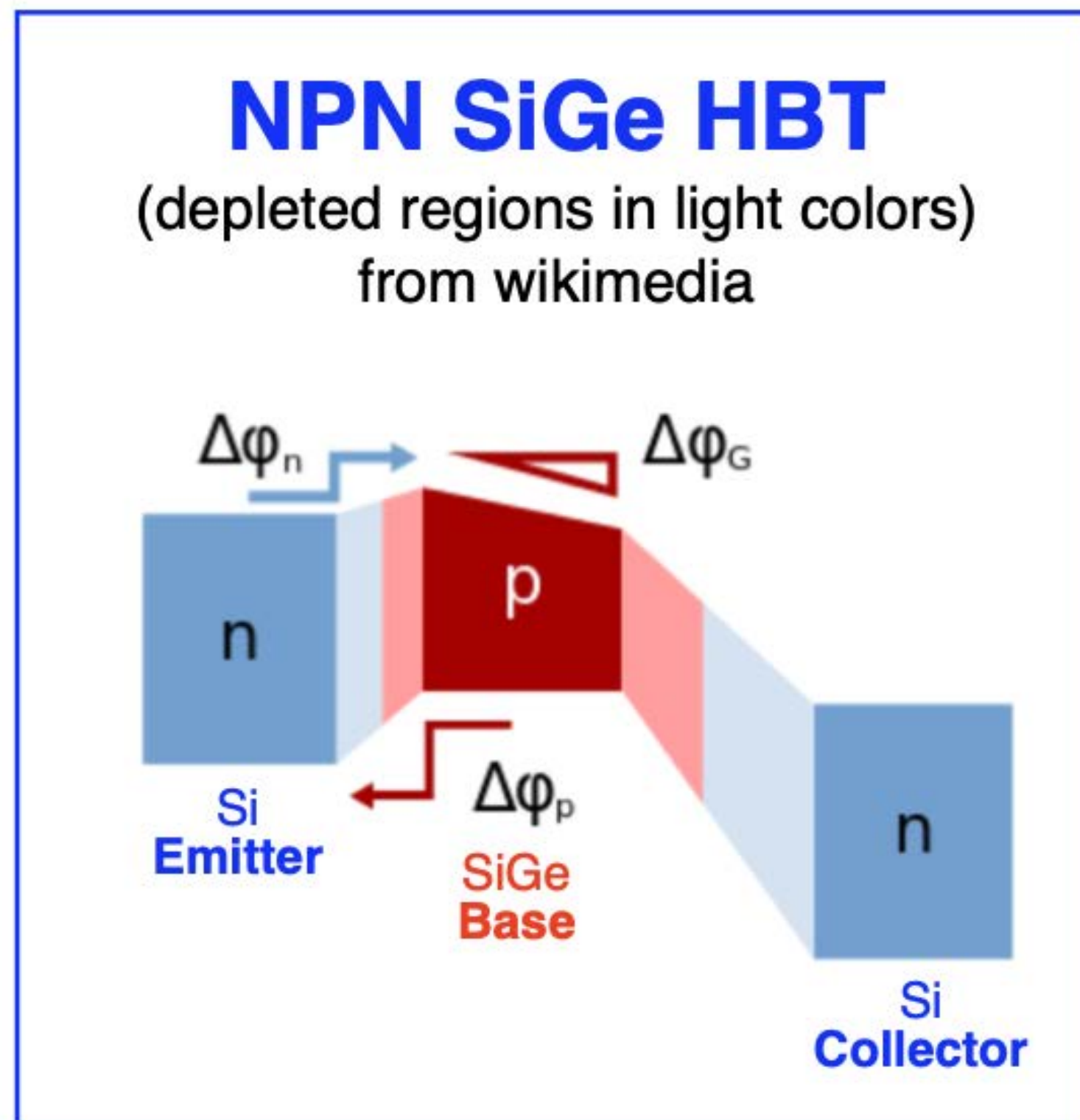
- Chip design
- Firmware

Main research partners:

**Roberto Cardarelli**
INFN Rome2 & UNIGE**Holger Rücker**
IHP Mikroelektronik**Marzio Nessi**
CERN & UNIGE**Bernd Heinemann**
IHP Mikroelektronik

Funded by:

**Swiss National
Science Foundation****Sinergia**



SiGe HBT = BJT with Germanium as base material.

Grading of Ge doping in base:

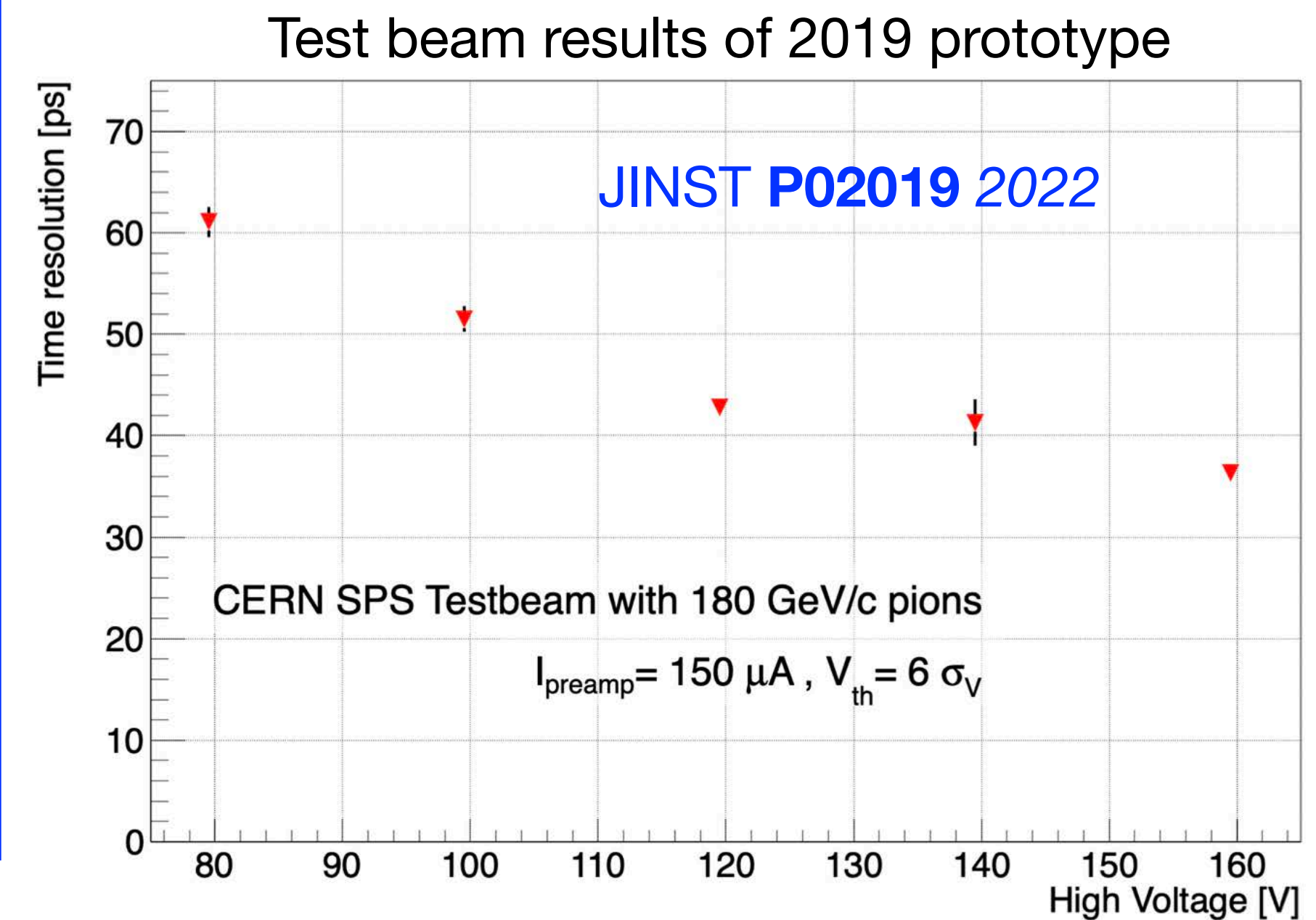
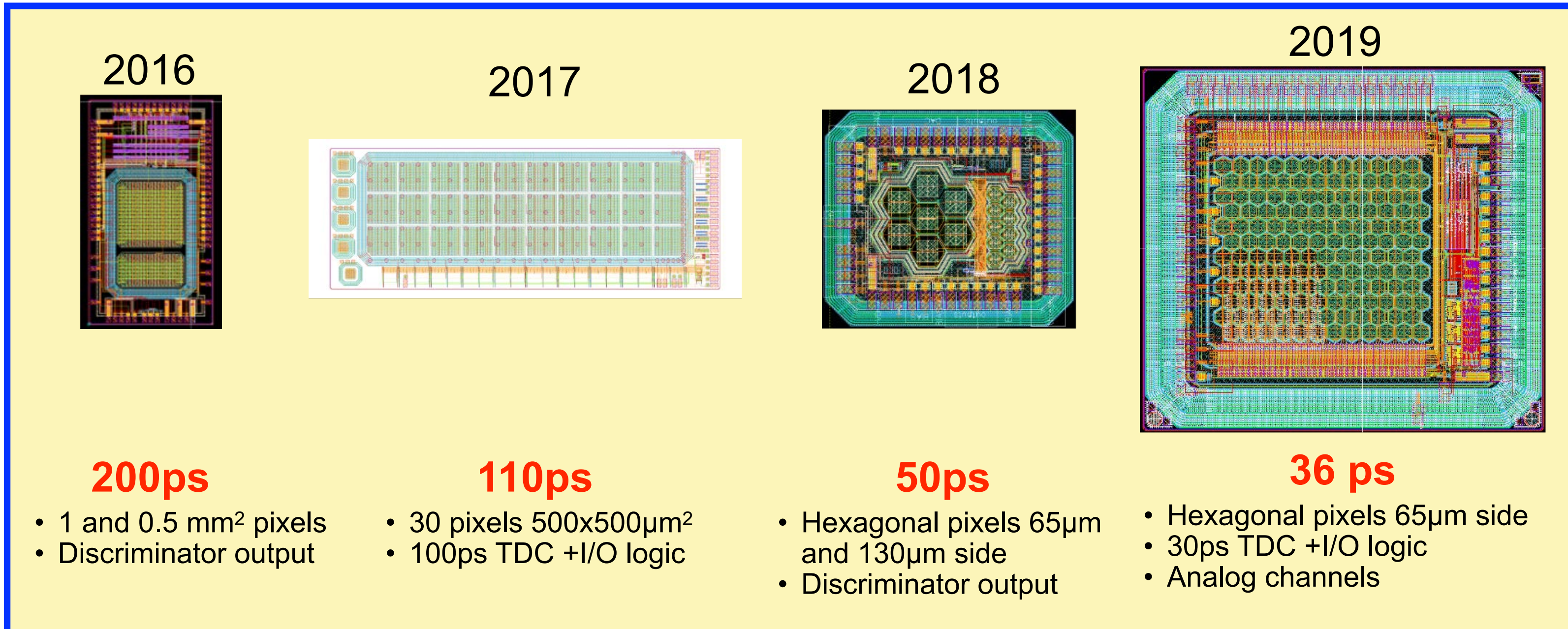
- charge-transport in base via **drift**
 - reduced charge-transit-time in base
 - **high current gain β**
- **Higher doping** in base is possible:
 - thinner base
 - **reduced base resistance R_b**

$$ENC_{series\ noise} \propto \sqrt{k_1 \frac{C_{tot}^2}{\beta} + k_2 R_b C_{tot}^2}$$



Leading-edge **IHP SG13G2** technology, **130 nm** process featuring **SiGe HBT**

Monolithic prototypes with SiGe BiCMOS (without internal gain layer)



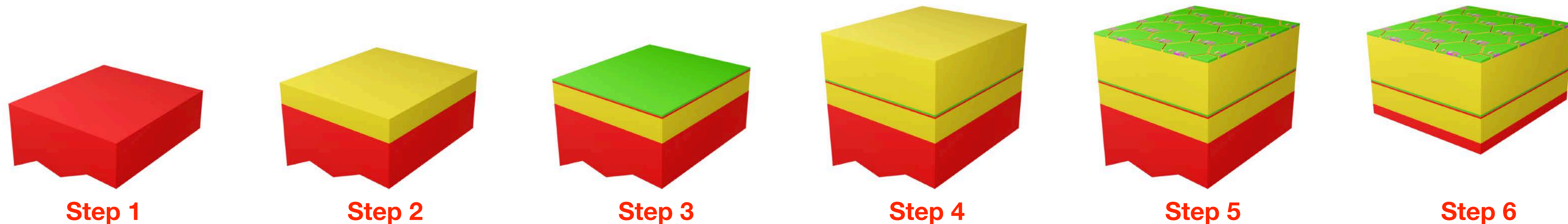
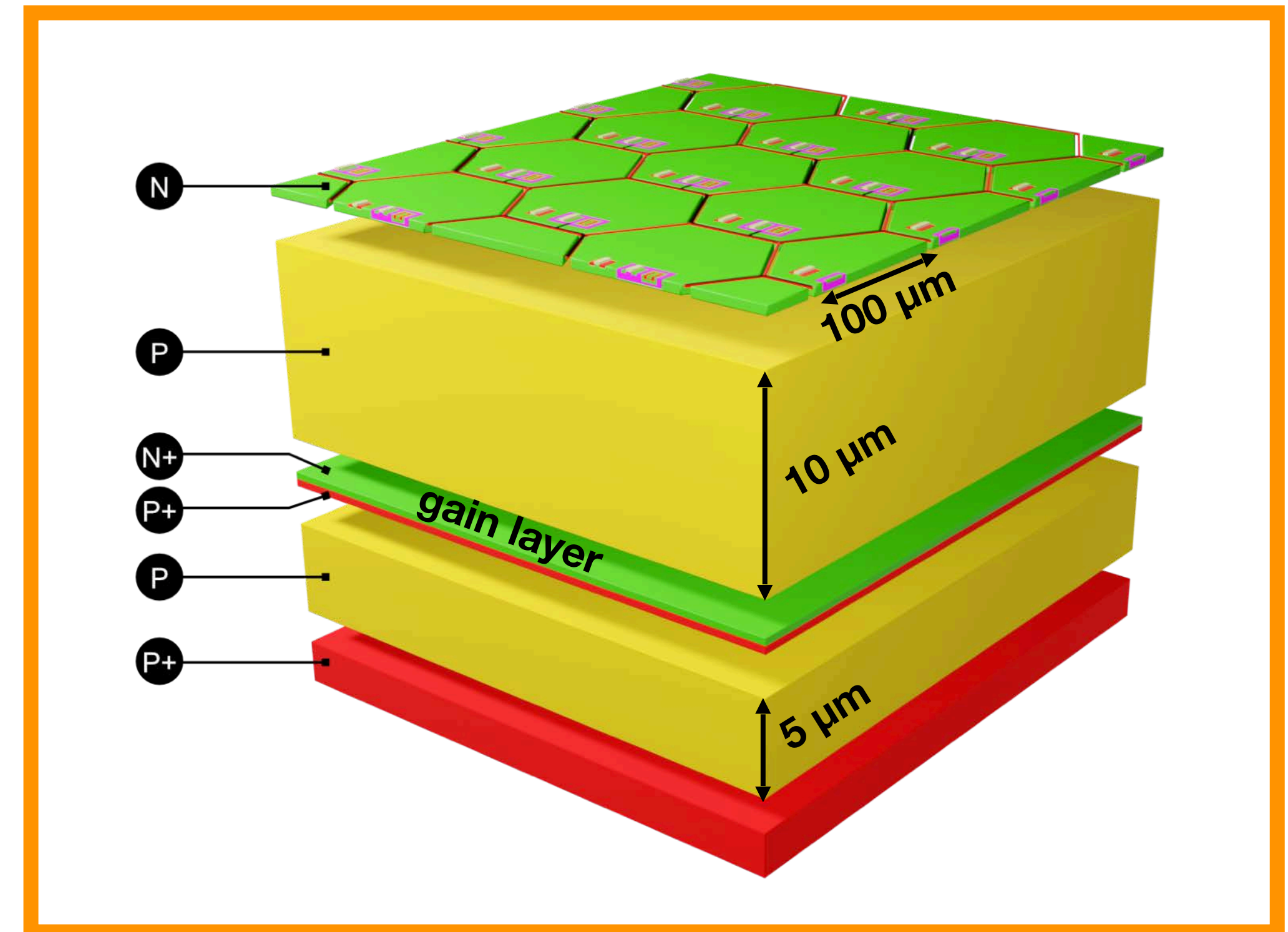
PicoAD:

Multi-Junction Picosecond-Avalanche Detector©

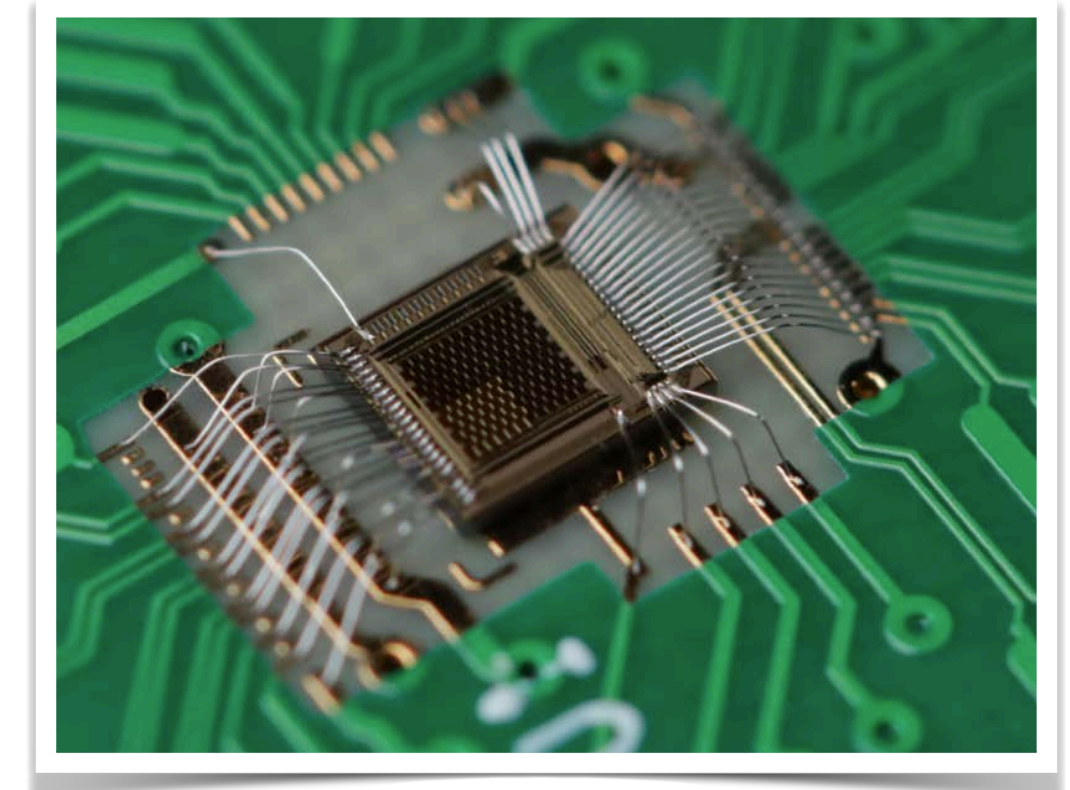
with continuous and deep gain layer:

- De-correlation from implant size/geometry
→ **high pixel granularity and full fill factor**
(high spatial resolution)
- Only small fraction of charge gets amplified
→ **reduced charge-collection noise**
(enhance timing resolution)

© G. Iacobucci, L. Paolozzi and P. Valerio. Multi-junction pico-avalanche detector;
European Patent EP3654376A1, US Patent US2021280734A1, Nov 2018



The proof-of-concept monolithic ASIC was produced by IHP in their SG13G2 SiGe BiCMOS process.

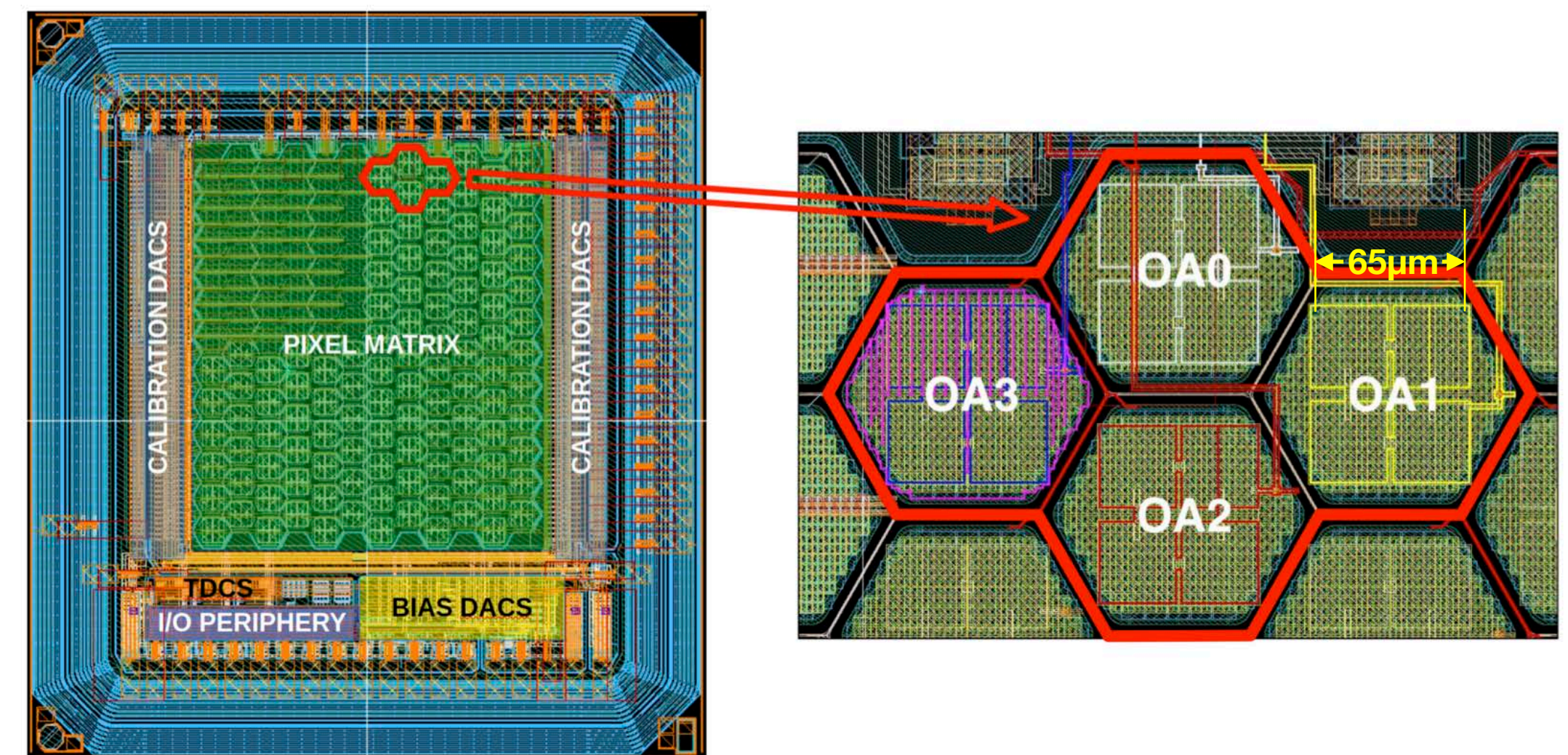


The ASIC contains:

- **Four matrices** of **hexagonal pixels** with $\approx 100\mu\text{m}$ pitch
 - ▶ with different electronics configurations
- **Four analog pixels**
 - ▶ tested with ^{55}Fe source and in testbeam

IHP also produced **PicoAD special wafers** with **four different gain-layer implant doses**

PicoAD Proof-Of-Concept Prototype (2021)

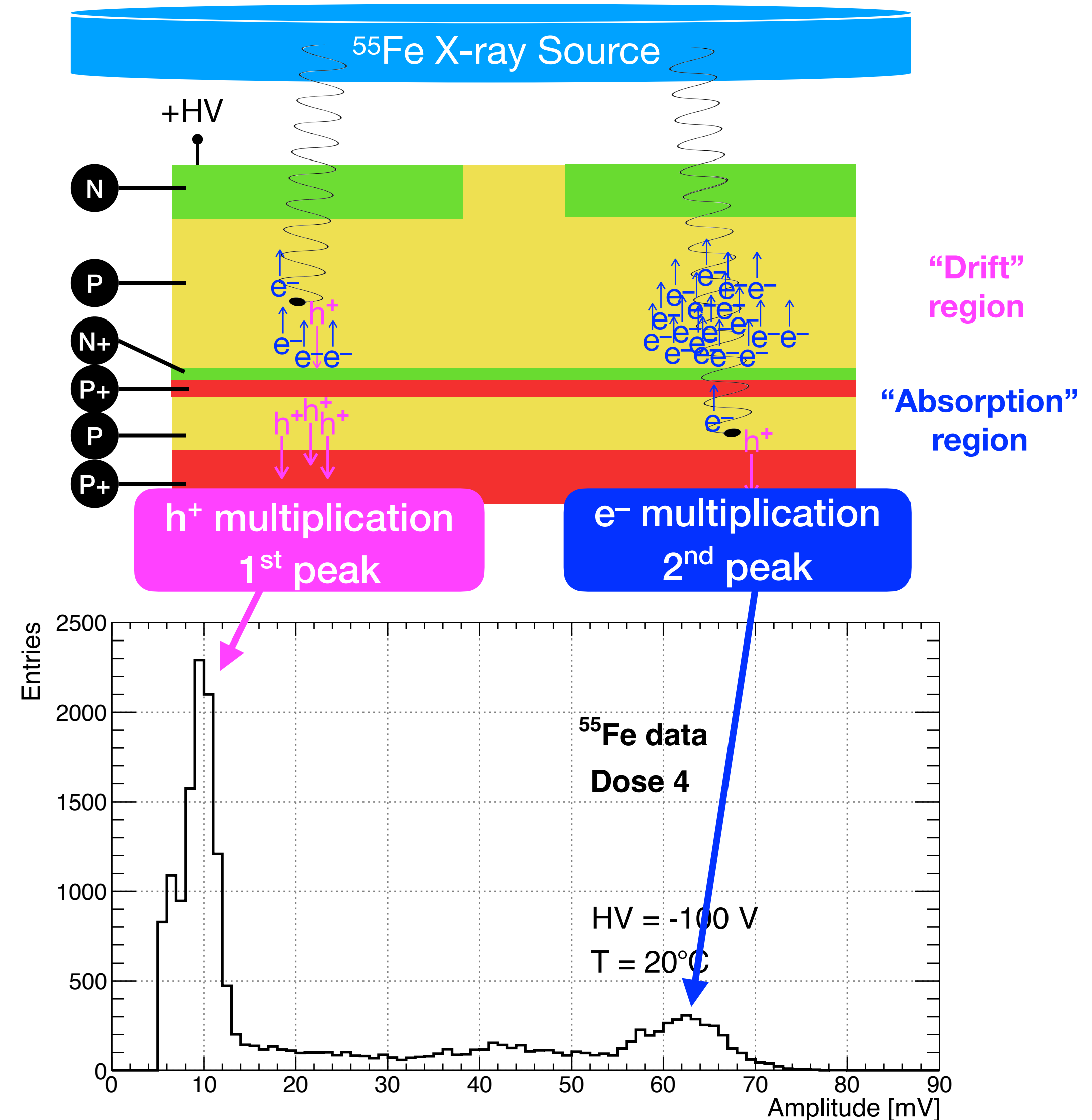


X-rays from ^{55}Fe radioactive source:

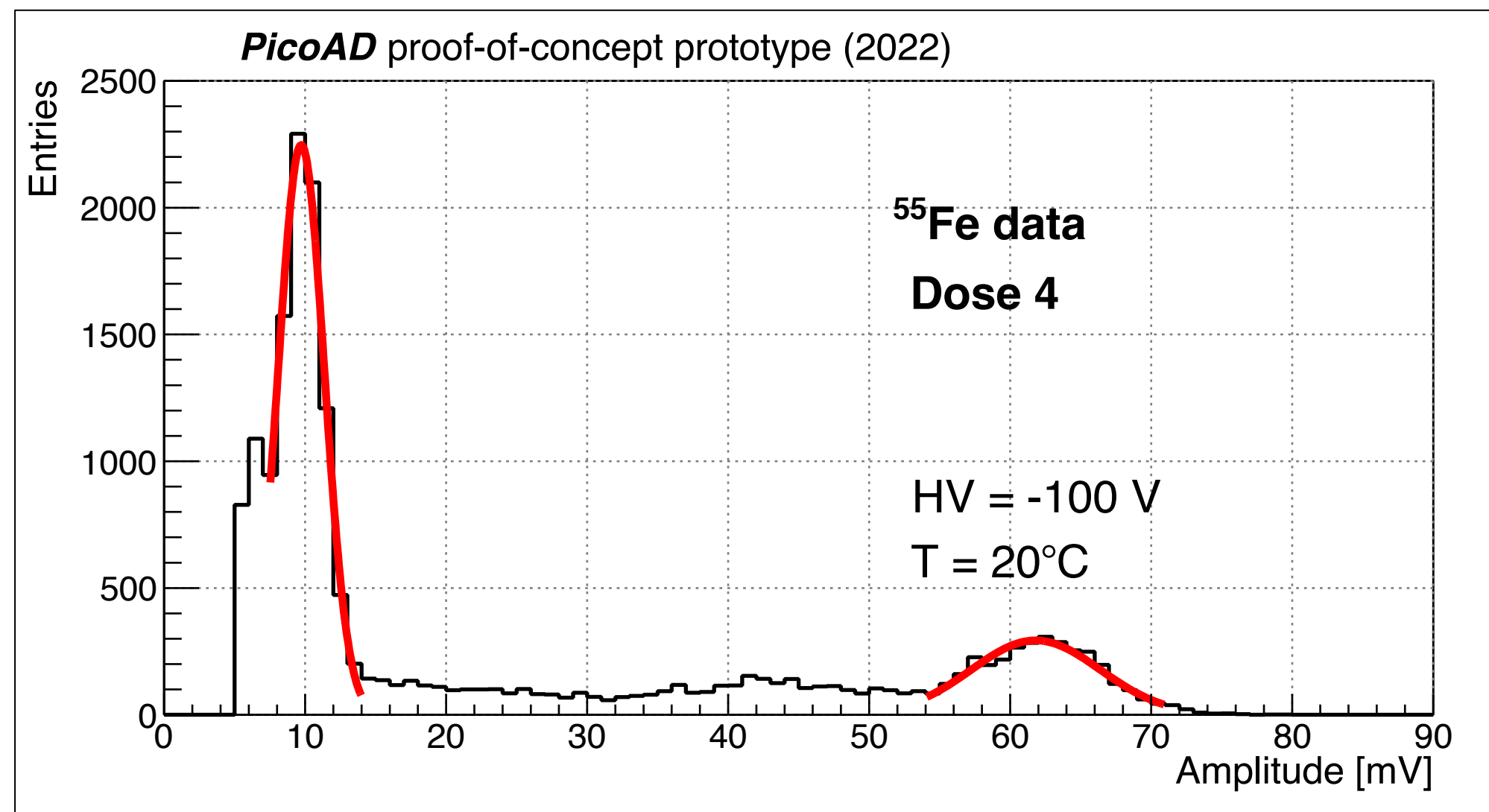
- ▶ mainly ~ 5.9 keV photons
- ▶ point-like charge deposition

Characteristic **double-peak spectrum**

- ▶ photon absorbed in **drift region**
 - ➔ **holes** drift through gain layer & multiplied
 - ➔ **first peak** in the spectrum
- ▶ photon absorbed in **absorption region**
 - ➔ **electrons** through gain layer & multiplied
 - ➔ **second peak** in the spectrum



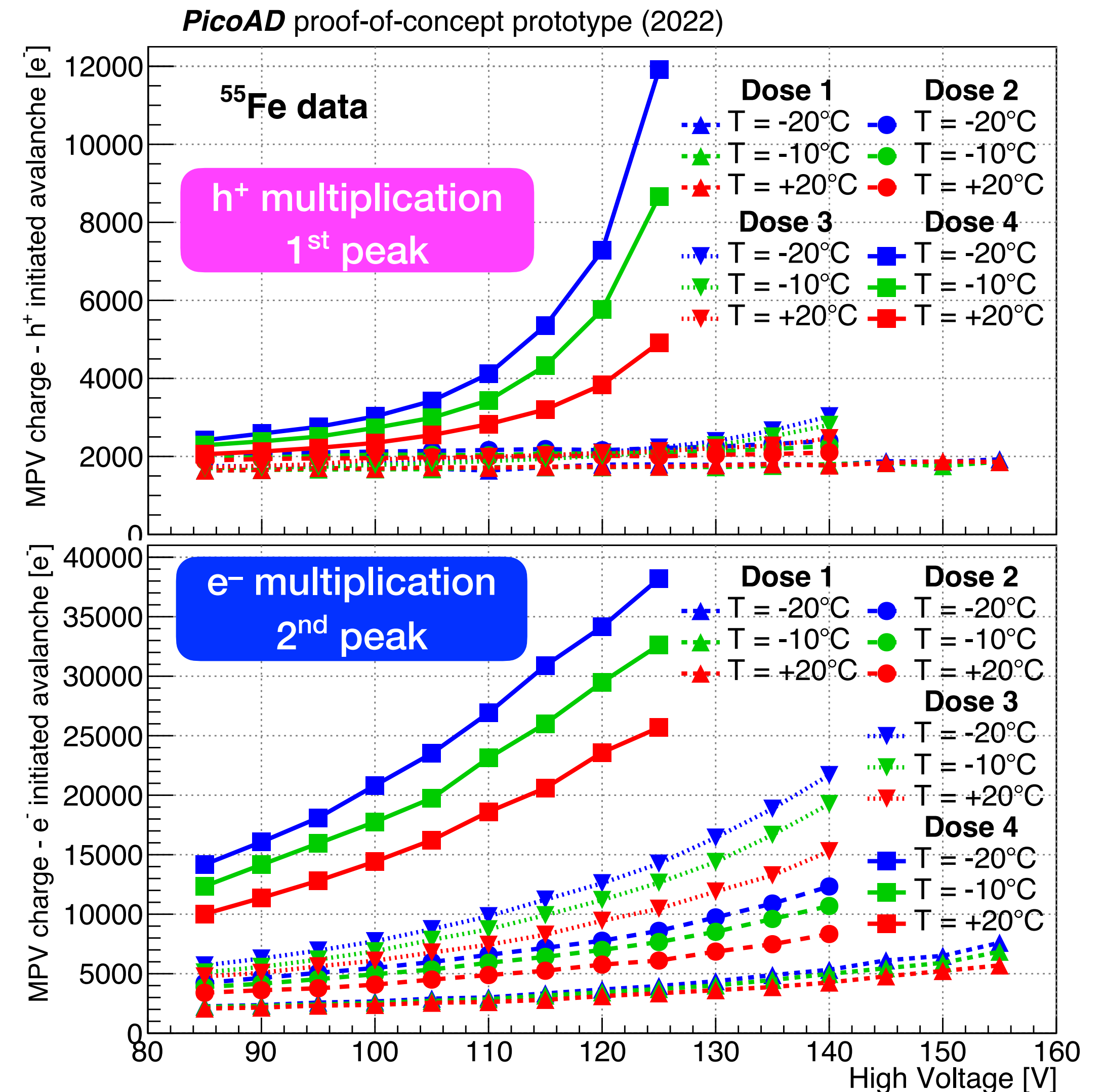
Average amplitudes of h^+ and e^- gains extracted via gaussian fit around local maxima



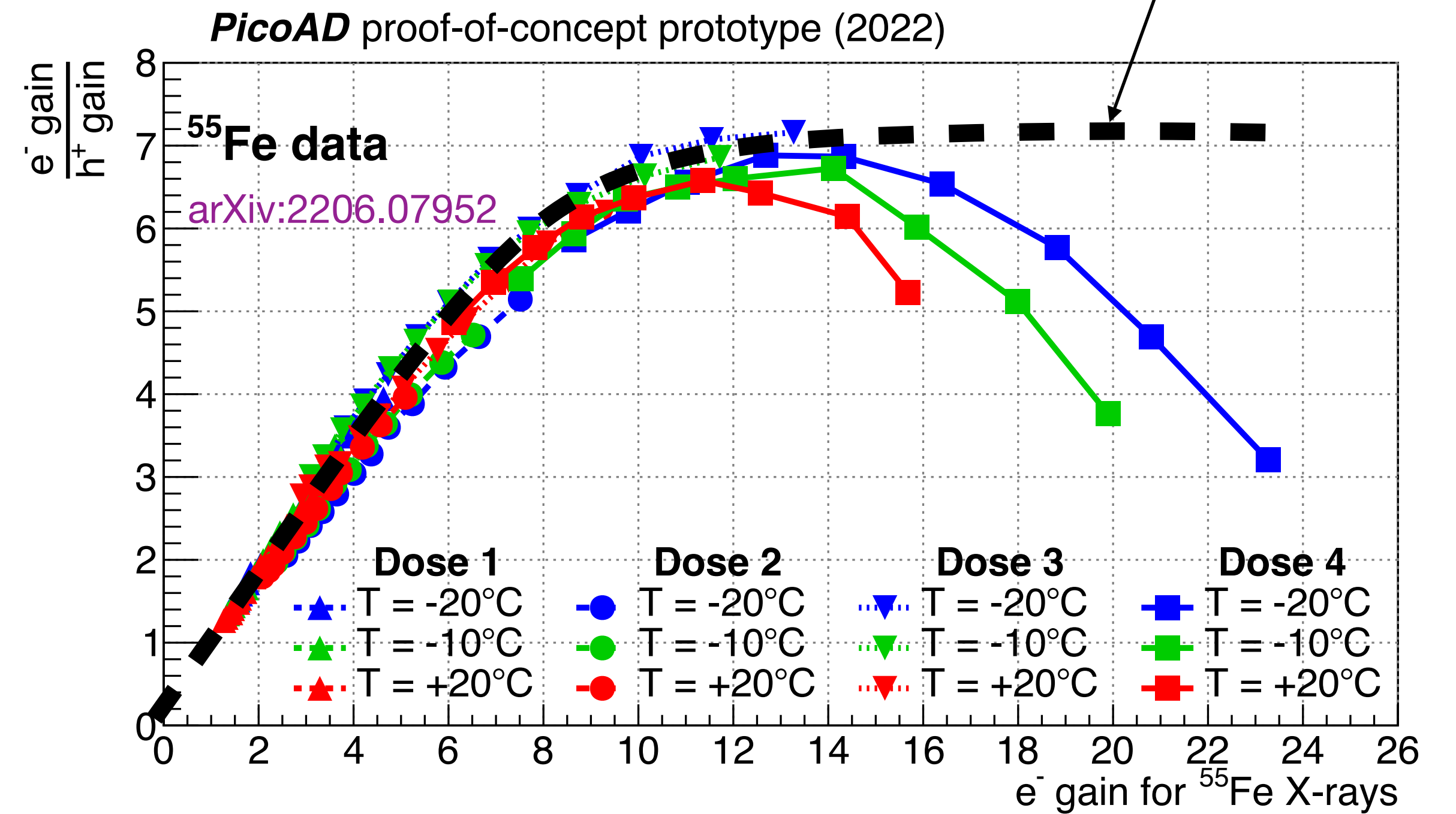
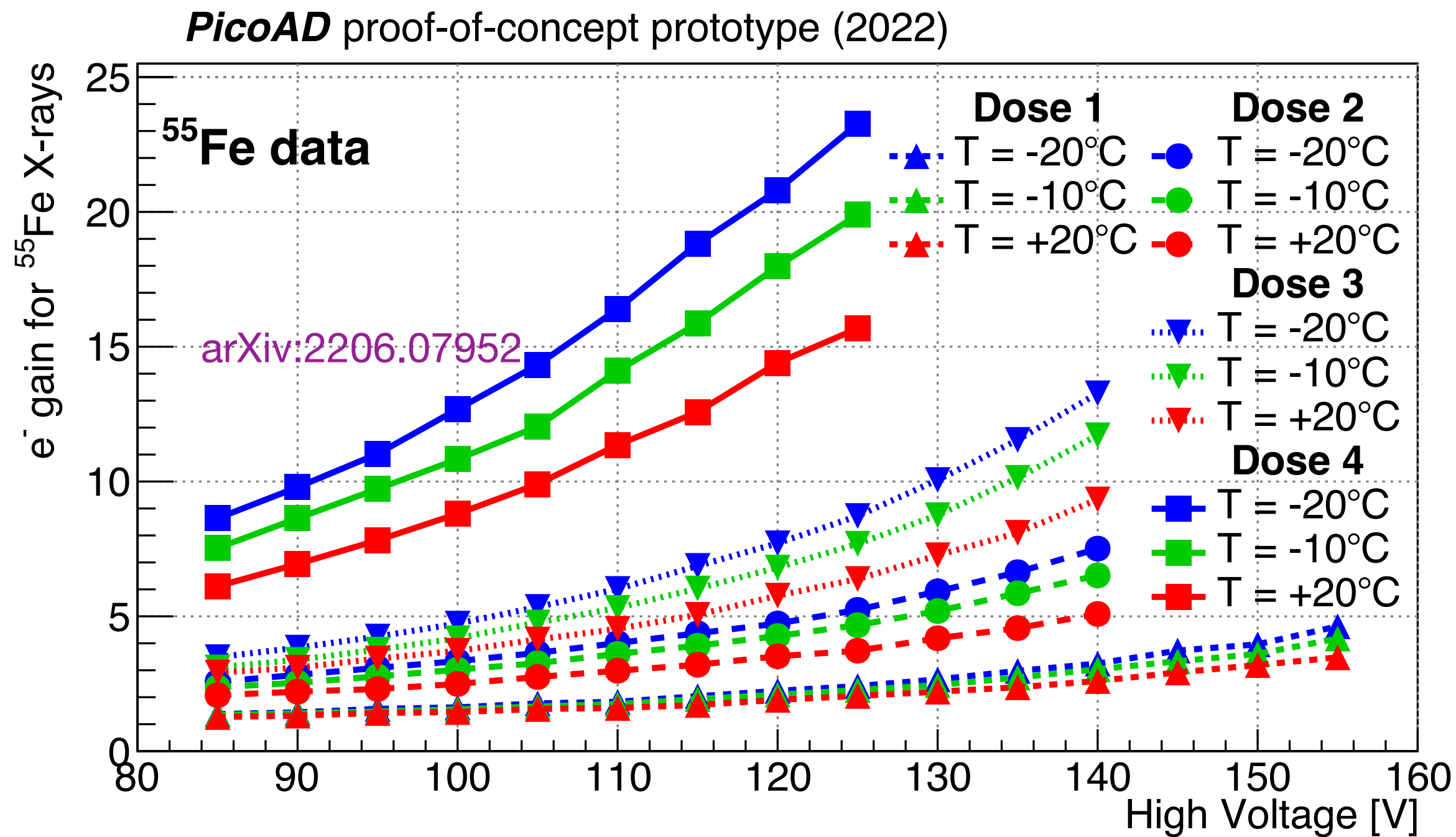
Assumption of no gain multiplication when:

- photon absorbed in drift region
- lowest voltage (85 V)
- lowest dose (dose 1)

⇒ **normalization value**



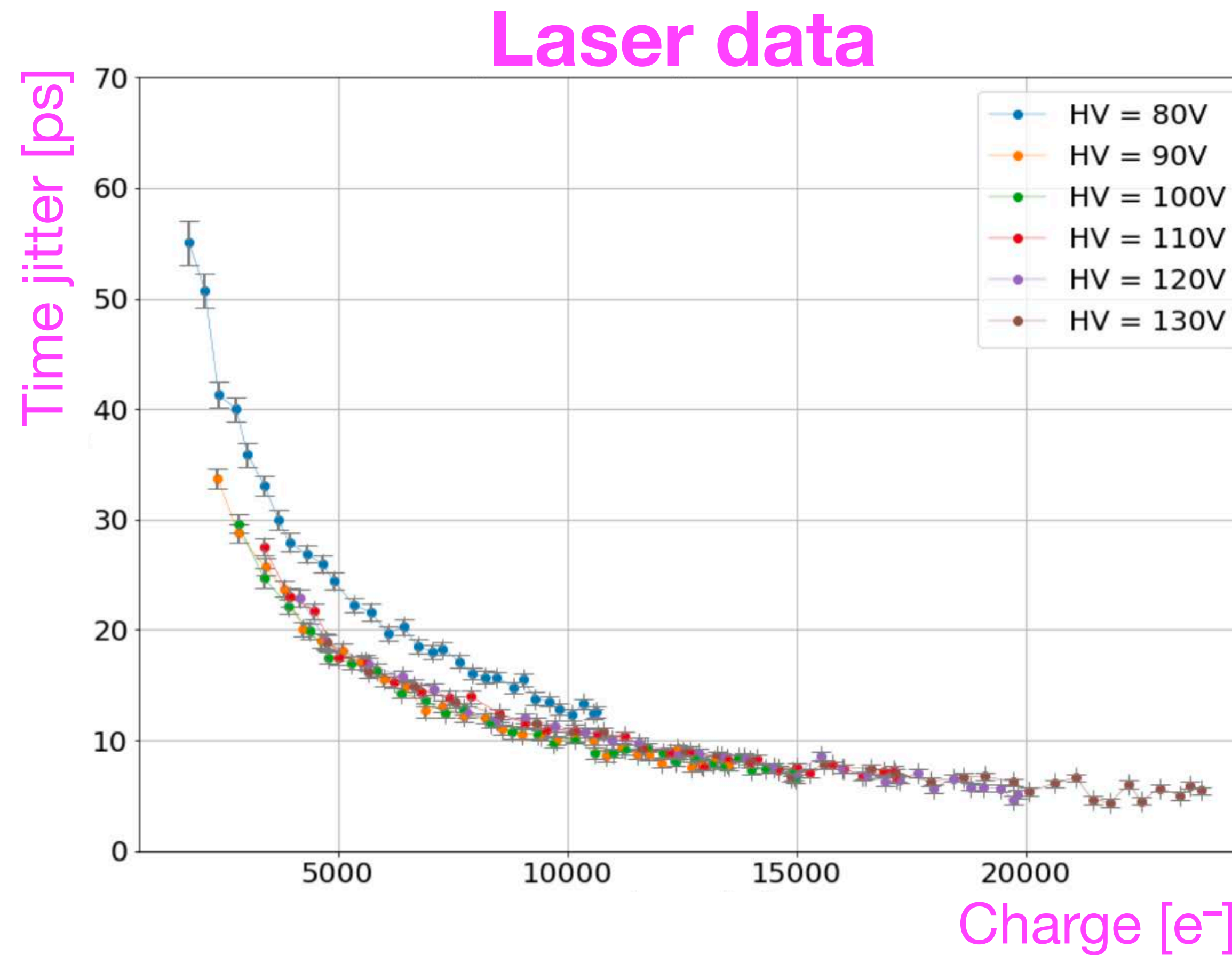
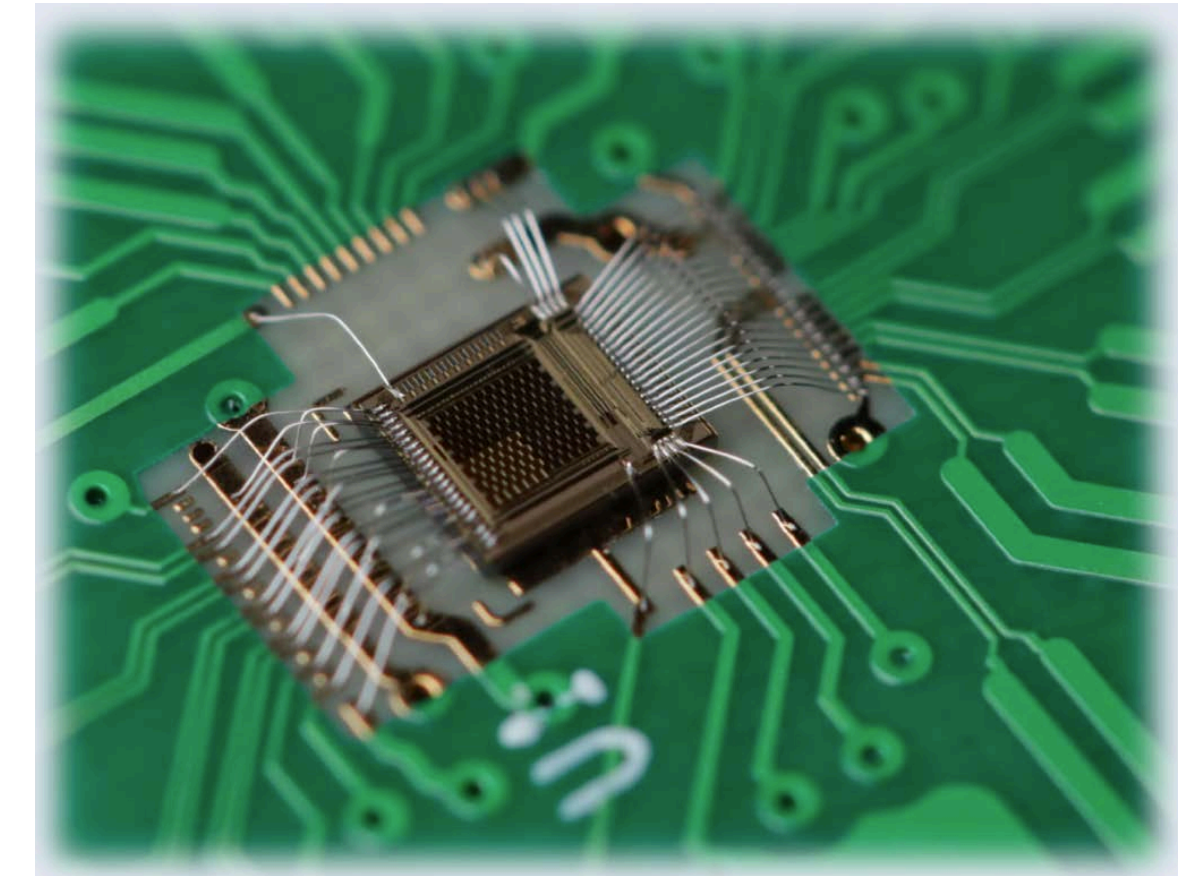
R. J. McIntyre, IEEE Trans. Electr. Dev.,
Vol. 46, no. 8, 1623-1631, Aug. 1999



A **gain up to ≈ 20 for ^{55}Fe X-rays** obtained at HV = 120 V and T = -20 °C

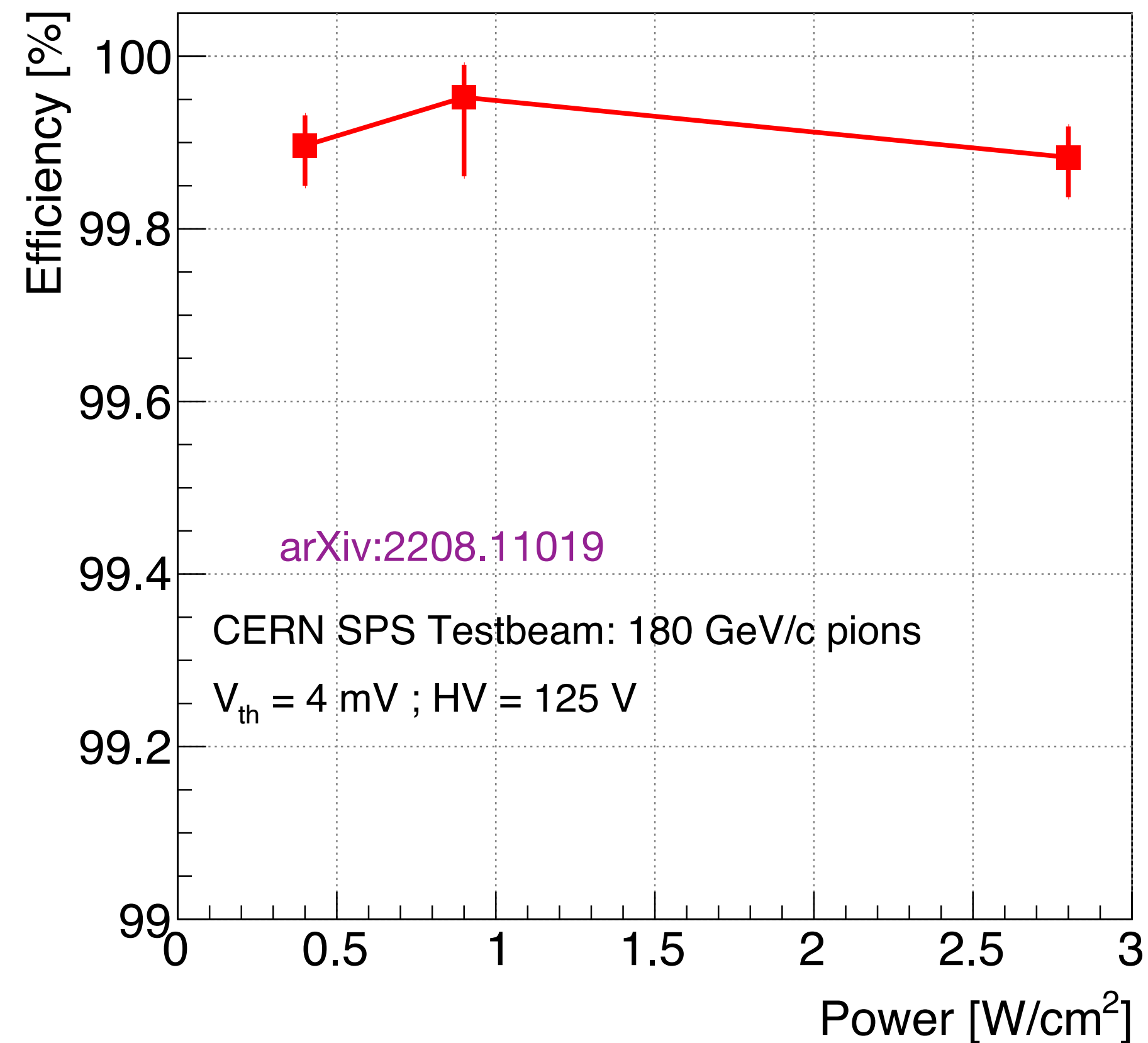
Evidence for **gain suppression** due to space-charge effects **in the case of ^{55}Fe X-rays**

PicoAD proof-of-concept prototype:



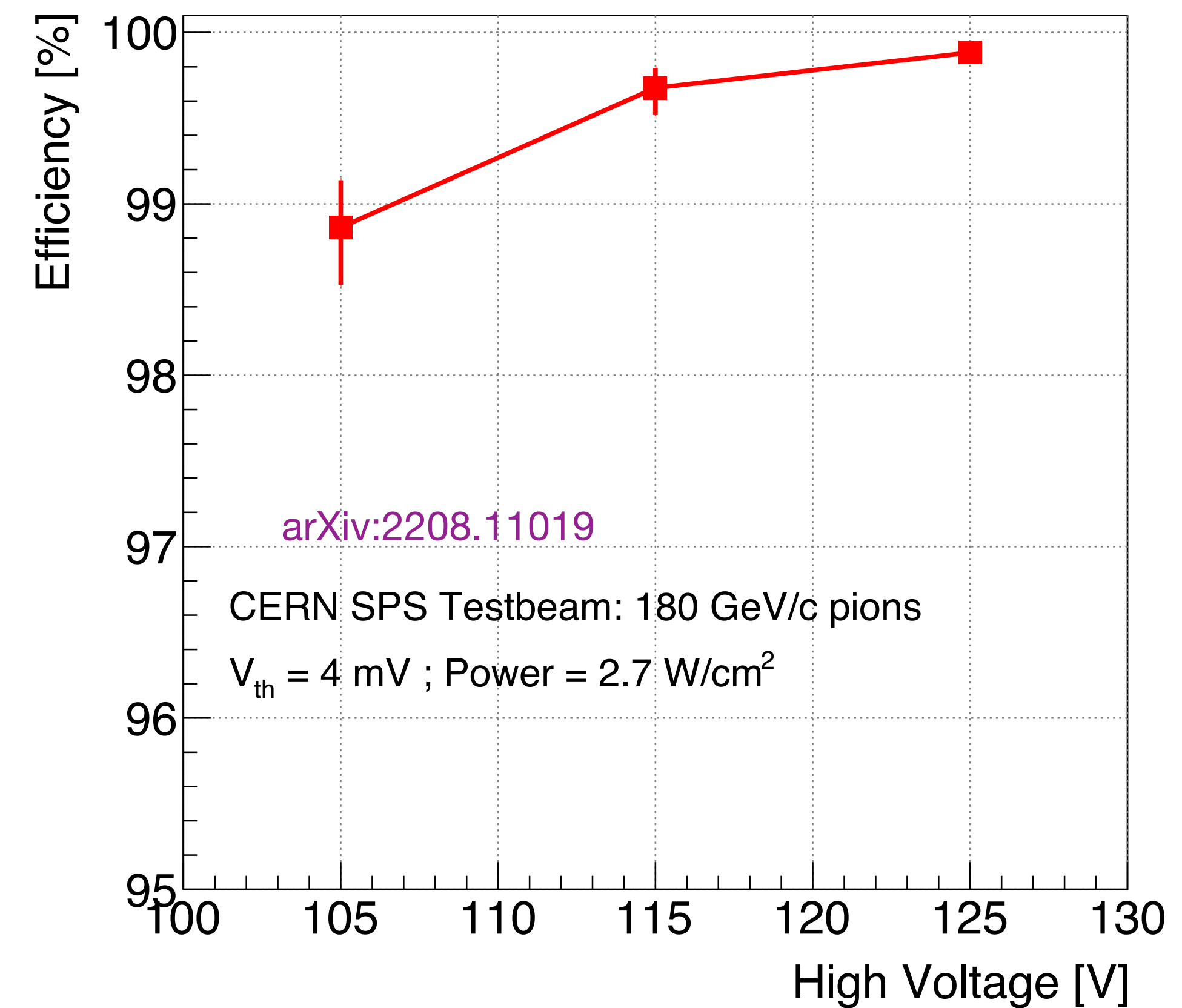
99.9% for all power consumptions

PicoAD proof-of-concept prototype (2022)



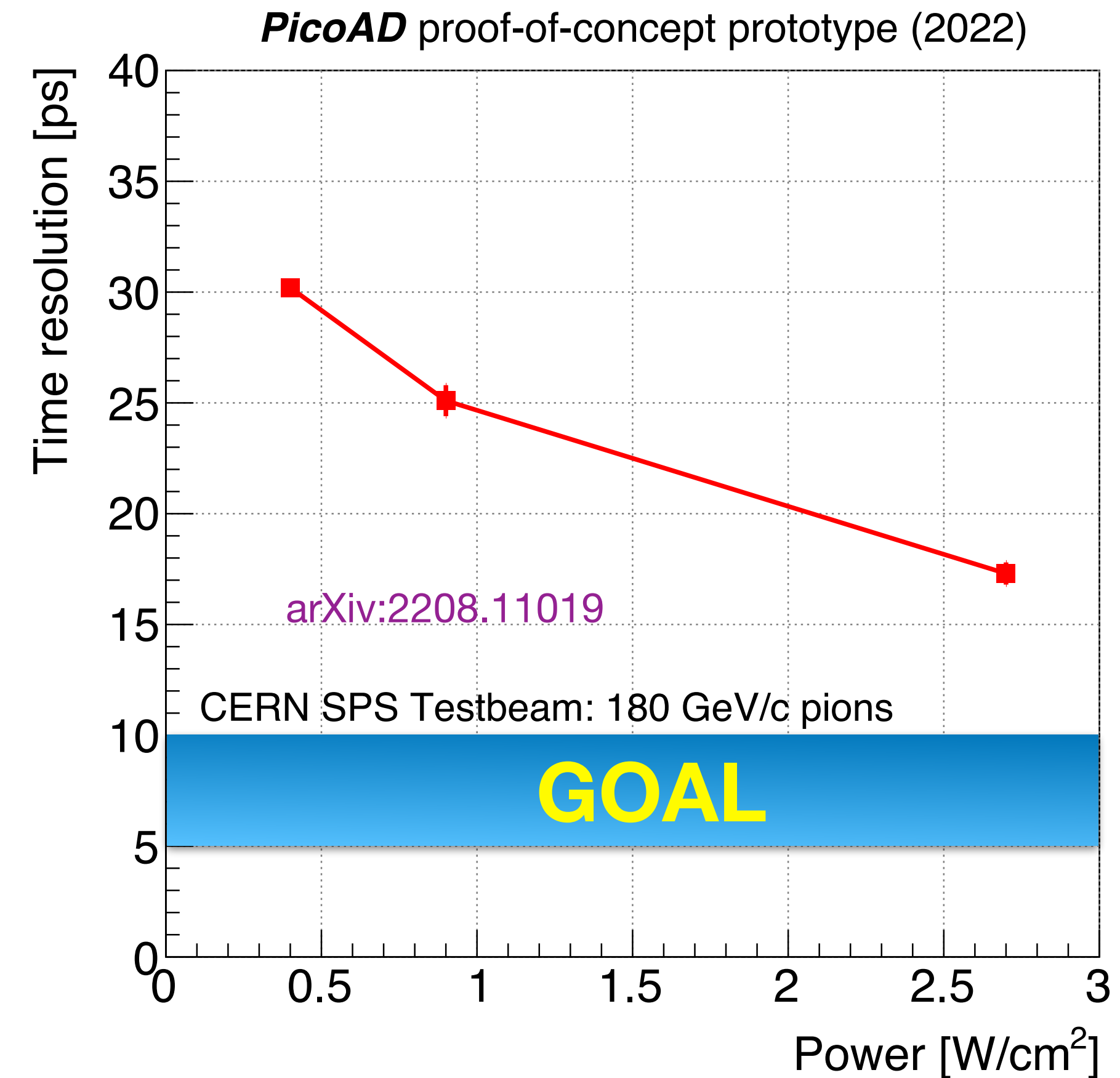
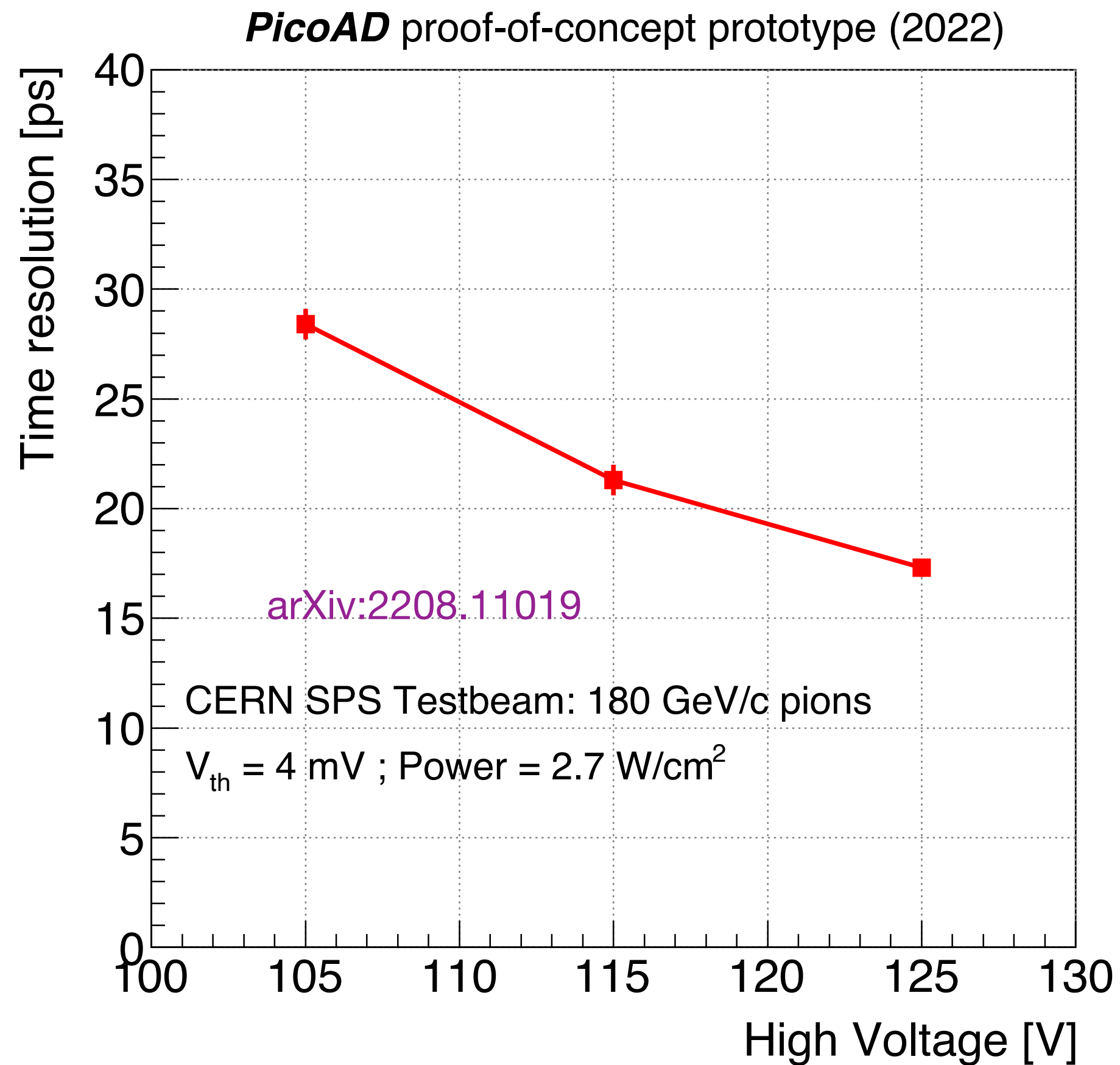
Drops to 99% for HV=105 V

PicoAD proof-of-concept prototype (2022)

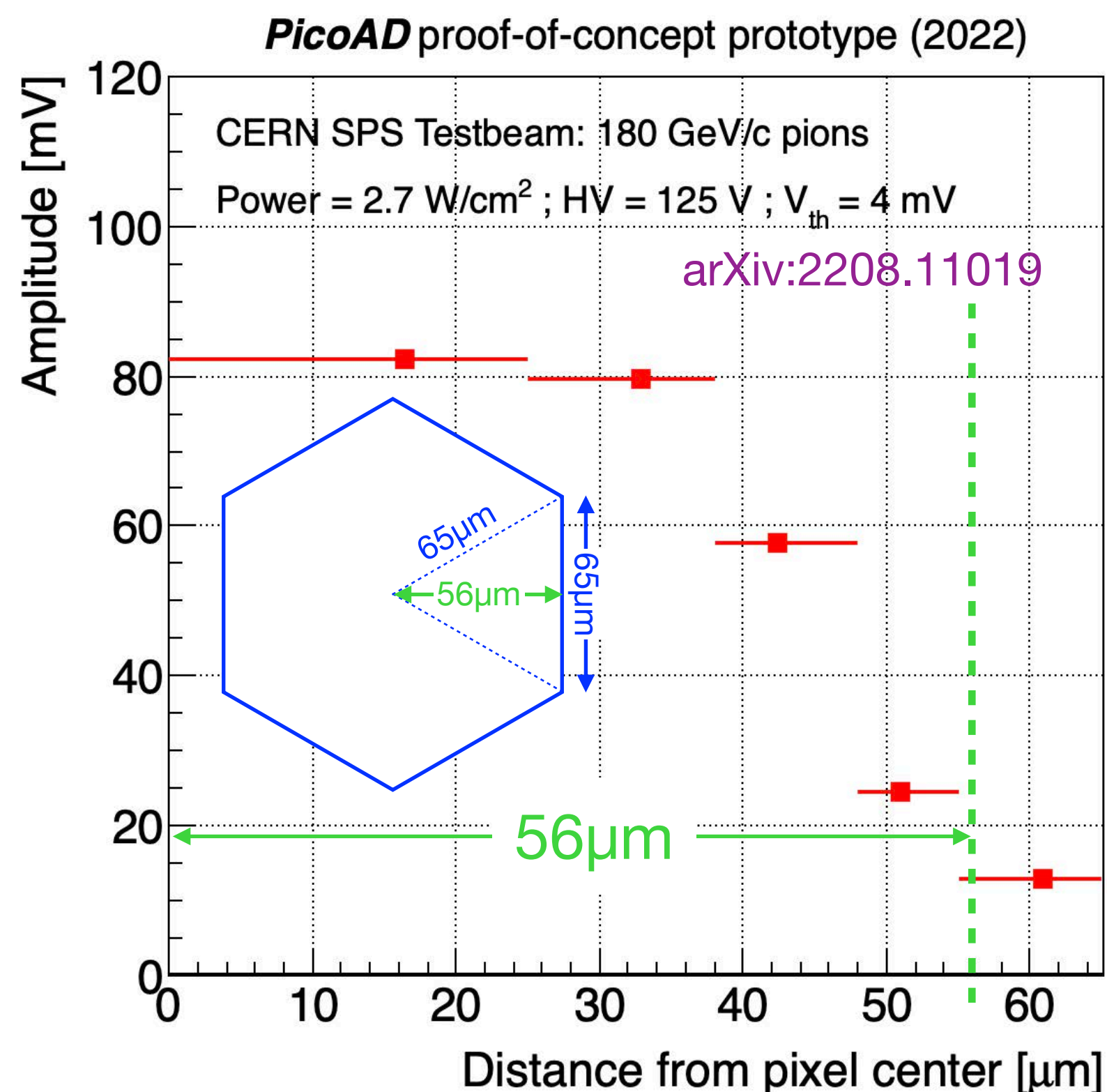


Best performance: (17.3 ± 0.4) ps
for HV=125 V and Power = 2.7 W/cm^2

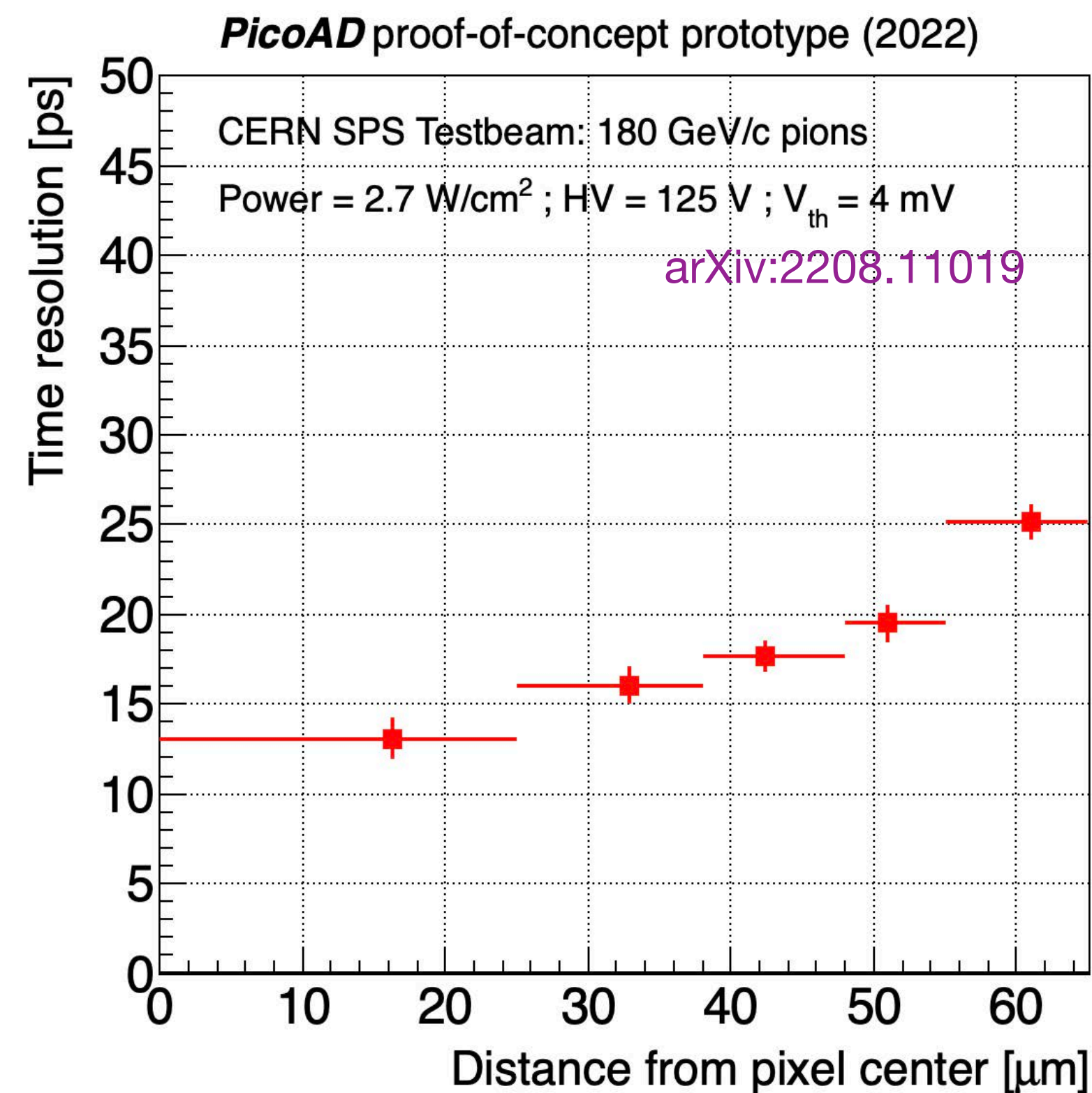
Timing resolution of **30 ps** even
at power consumption of **0.4 W/cm^2**



Signal MPV amplitude

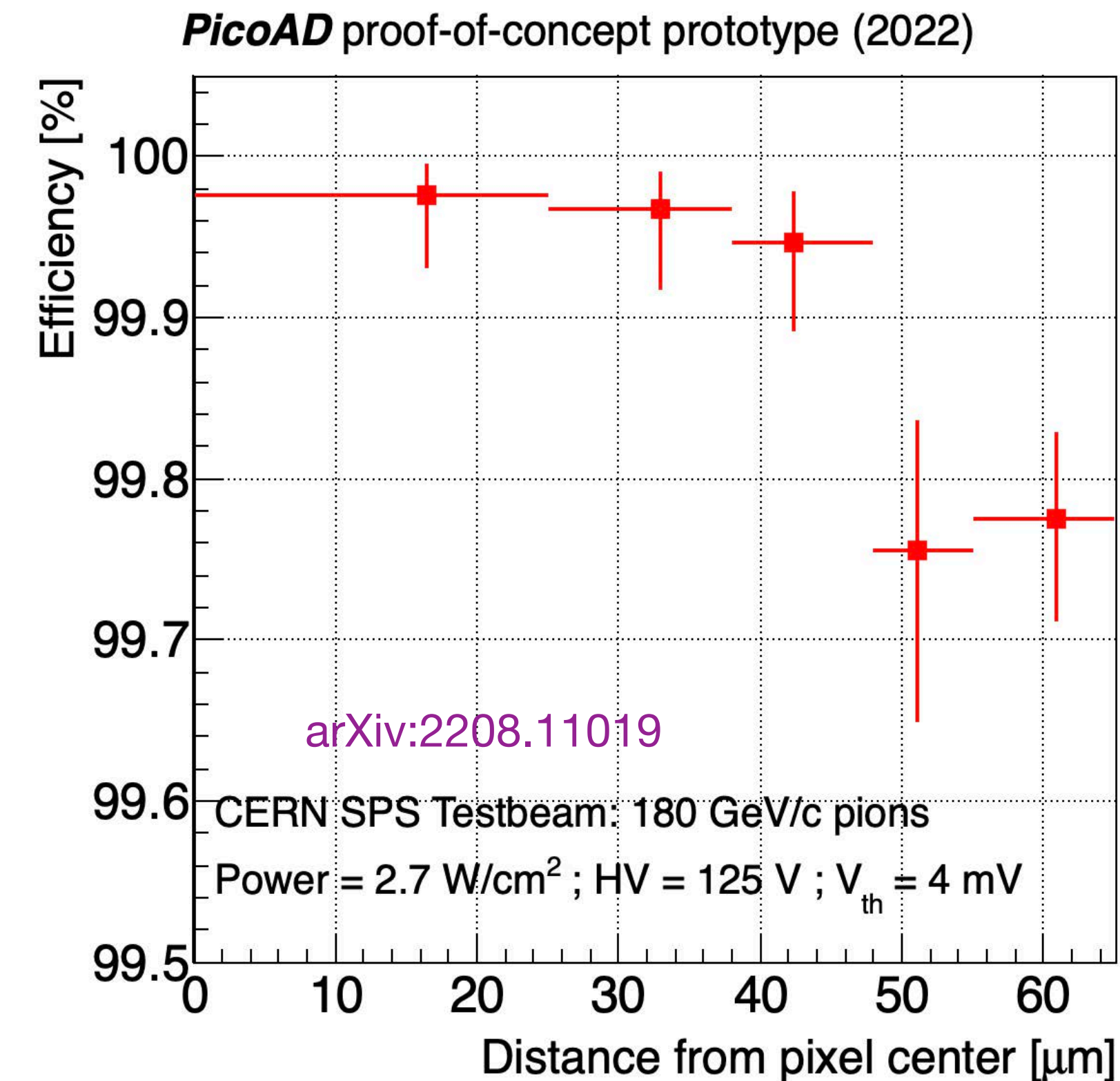


Time resolution



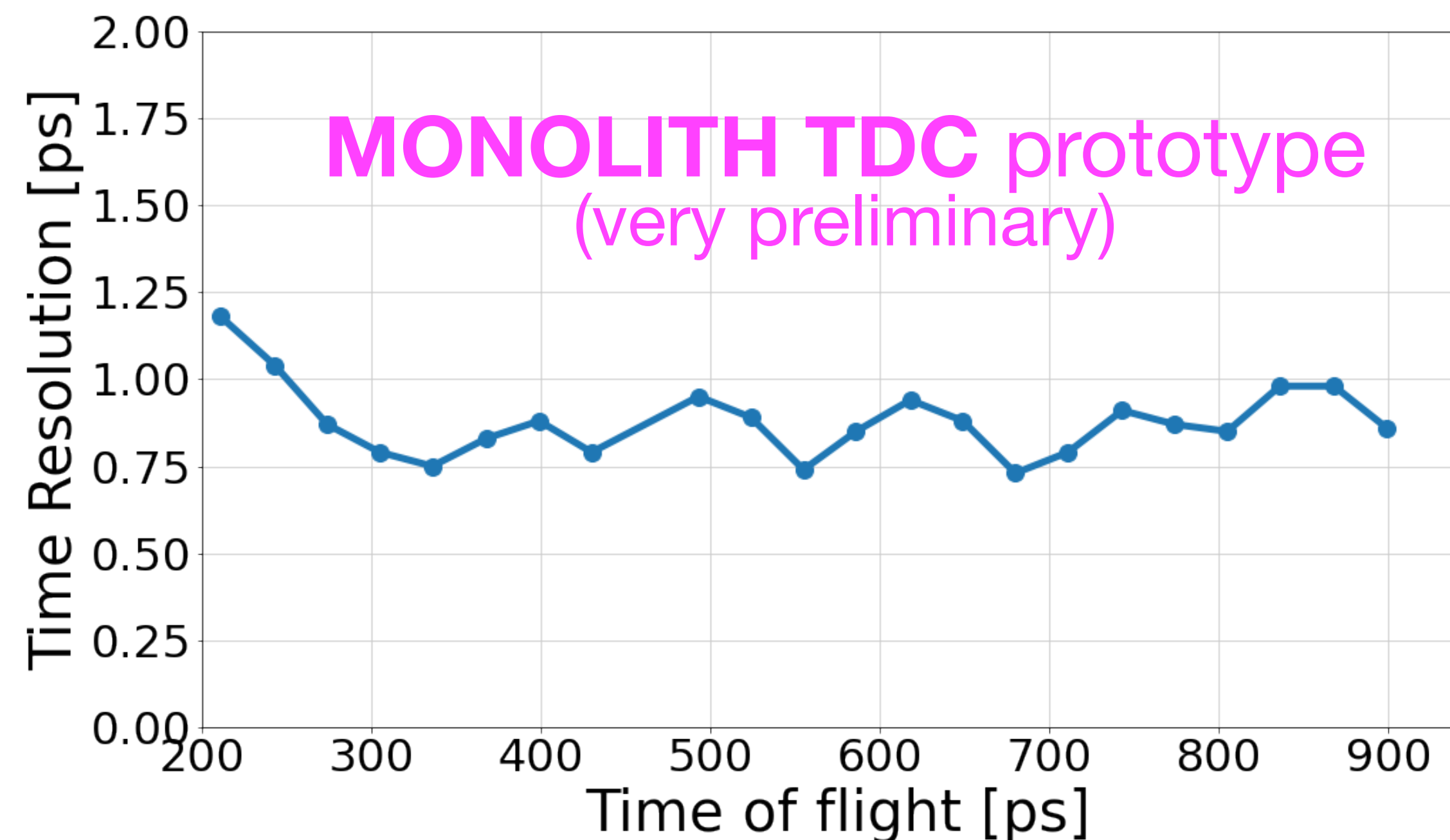
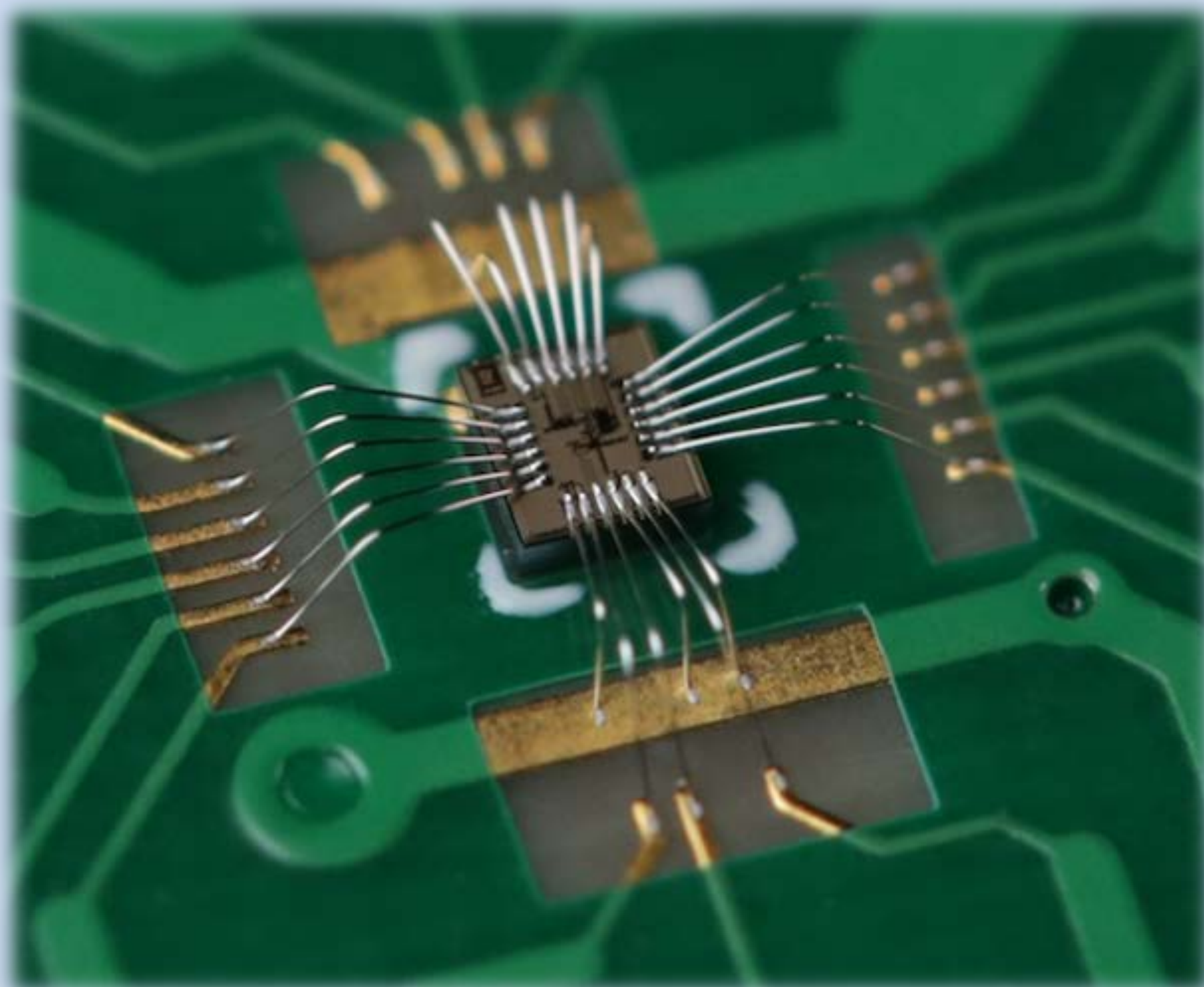
(13.2 ± 0.8) ps at the pixel center

Efficiency



We are developing a sub-picosecond TDC based on a novel design (our patent[©] & more):

© R. Cardarelli, L. Paolozzi, P. Valerio and G. Iacobucci, European Patent Application / Filing - UGKP-P-001-EP, Europe Patent EP 18181123.3. 2 July 2018.



Standalone prototype still under test at UNIGE.
Integrated in MONOLITH 2022 monolithic ASIC.

Triggered by the needs of the **HL-LHC and beyond**, the HEP community is working on precise timing with silicon to produce **4D trackers**.

Hybrid **LGAD** pads will be used in ATLAS & CMS, with **30 ps time capabilities**

Evolving towards : - **TI-LGAD** to obtain small-pitch pixels
- **resistive AC-Coupled LGAD** to reduce the number of channels

Two projects are producing results at the level of **10 ps** (below the Landau limit):

- **TIMESPOT**, featuring the intrinsically rad-hard **hybrid 3D sensors**
- **MONOLITH**, featuring **monolithic** implementation of **SiGe BiCMOS** electronics on the novel **PicoAD** sensor

Production of **full systems** with 10 μ m and 10ps resolutions is a long way ahead of us

Extra Material



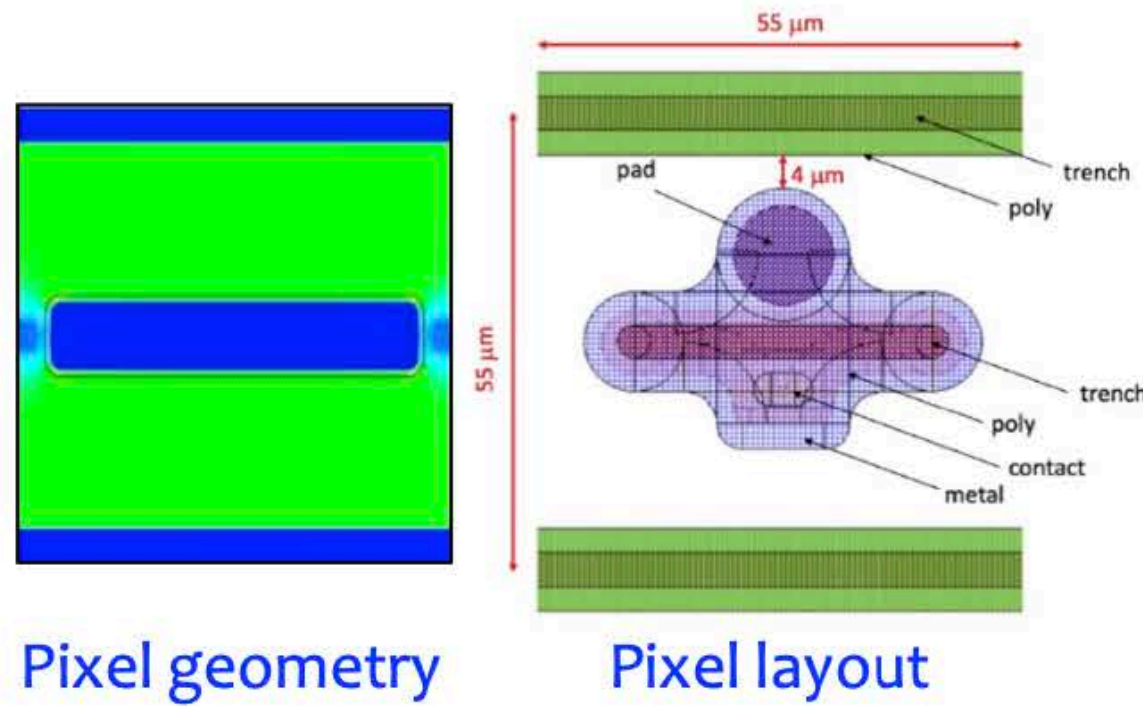
3D trench sensors

Sensor fabrication @ FBK

2 batches (2019 and 2020)

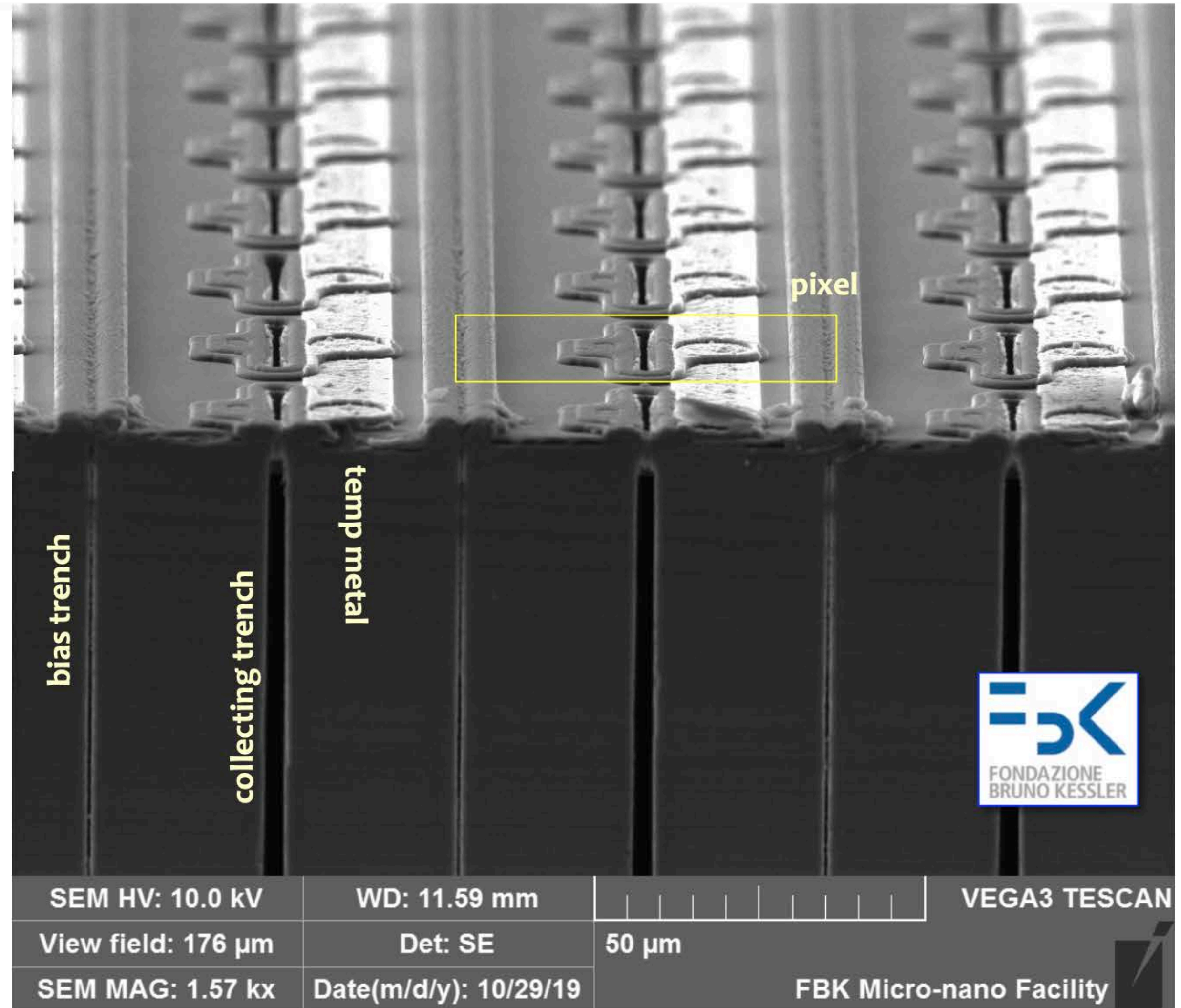
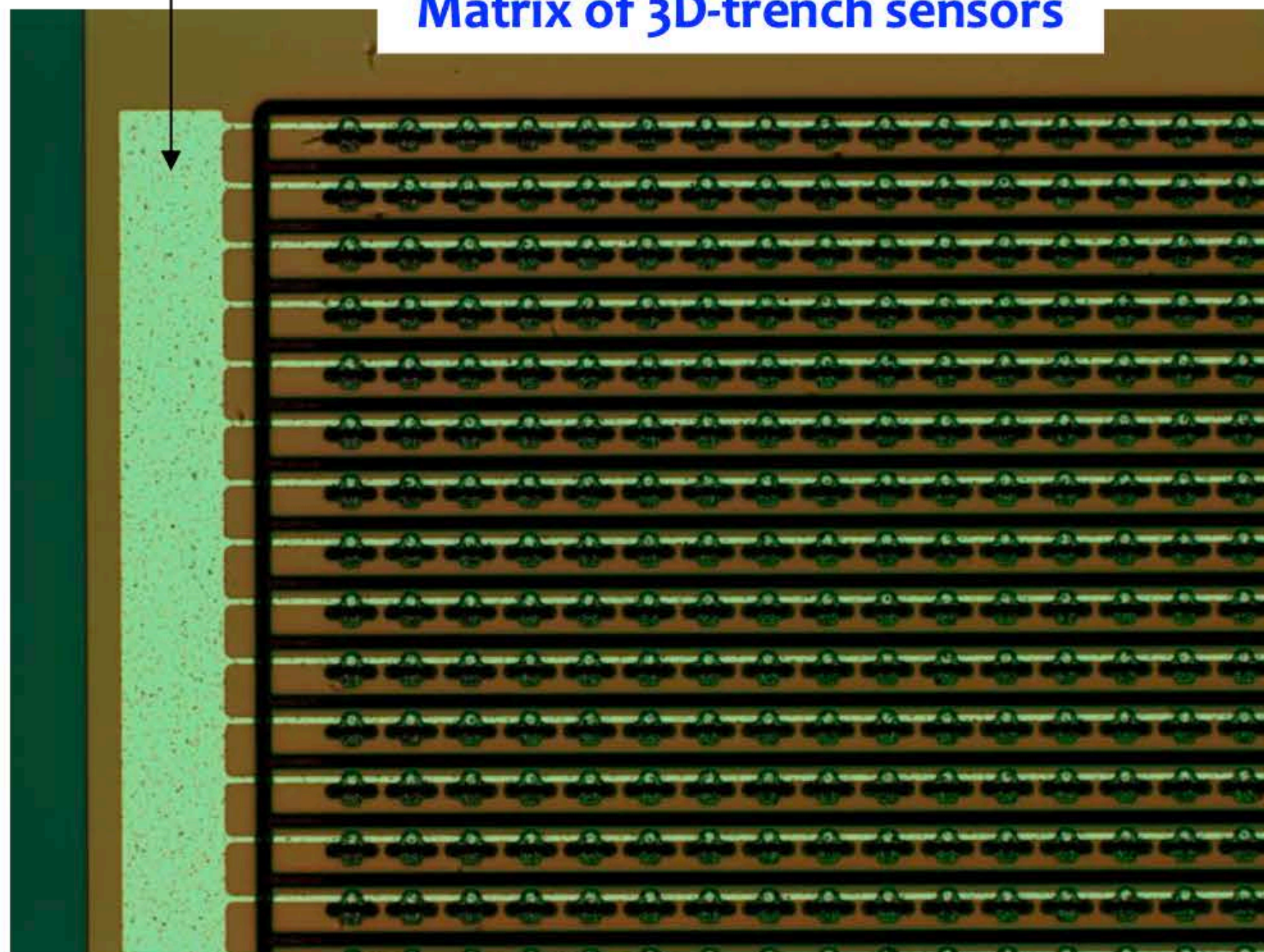
The optimal geometry

- 3D-trench
- $5 \times 40 \times 135 \mu\text{m}^3$ trench
- $150 \mu\text{m}$ pixel depth



temp metal
for static tests

Matrix of 3D-trench sensors



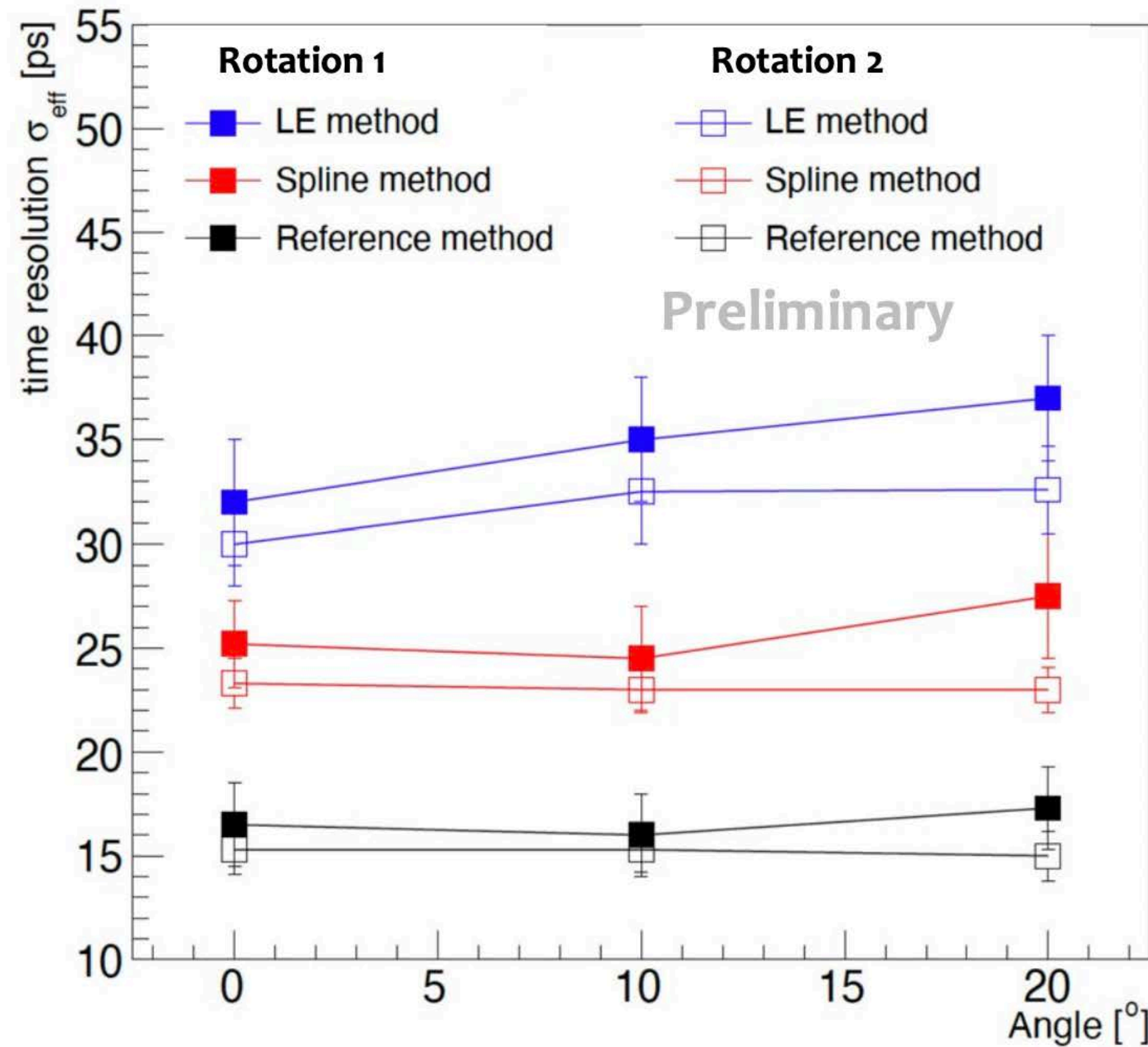
collecting trench

bias trench

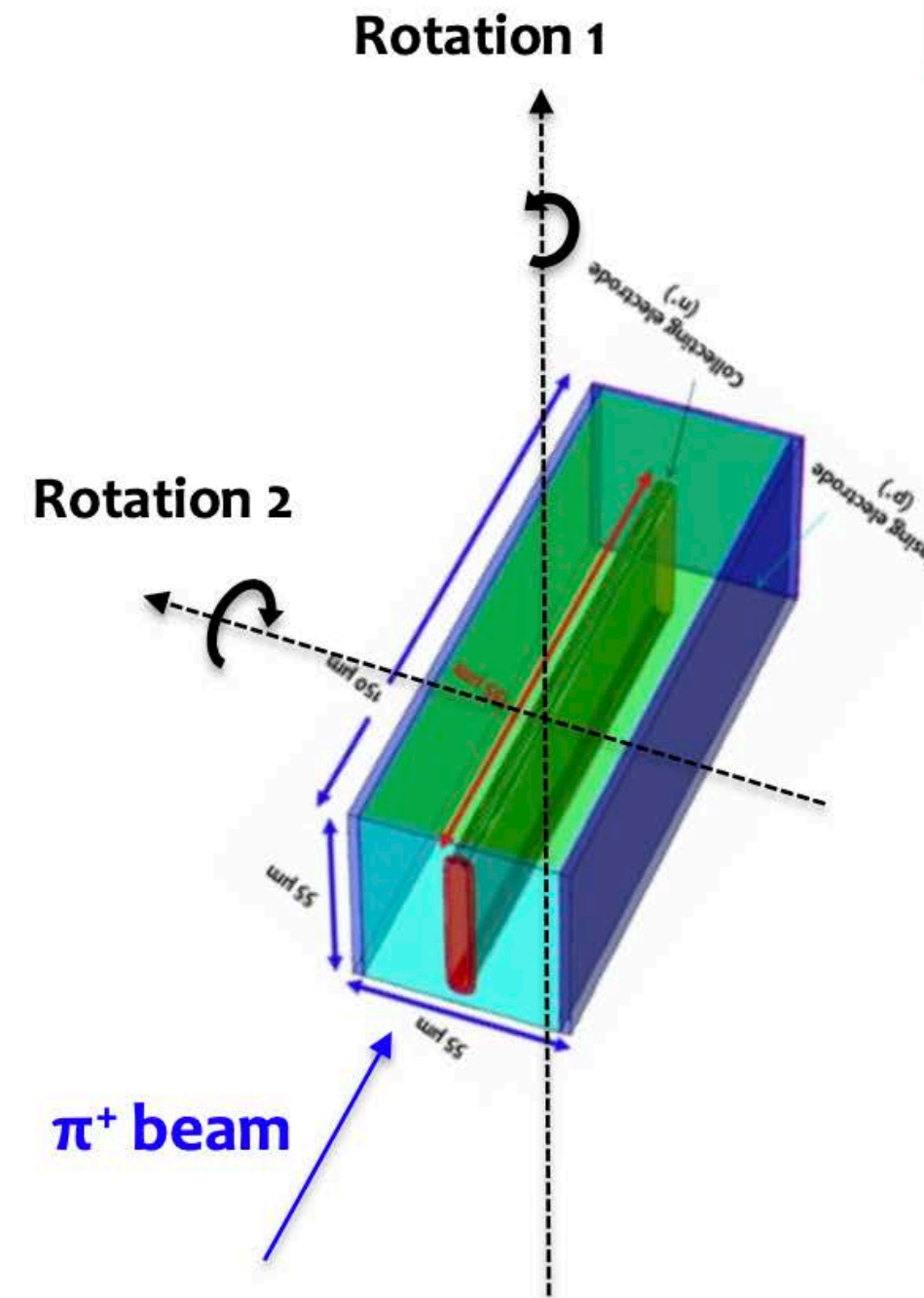
Deep Reactive Ion Etching
 Bosch technology
 (developed for **MicroElectroMechanicalSystem** technology)



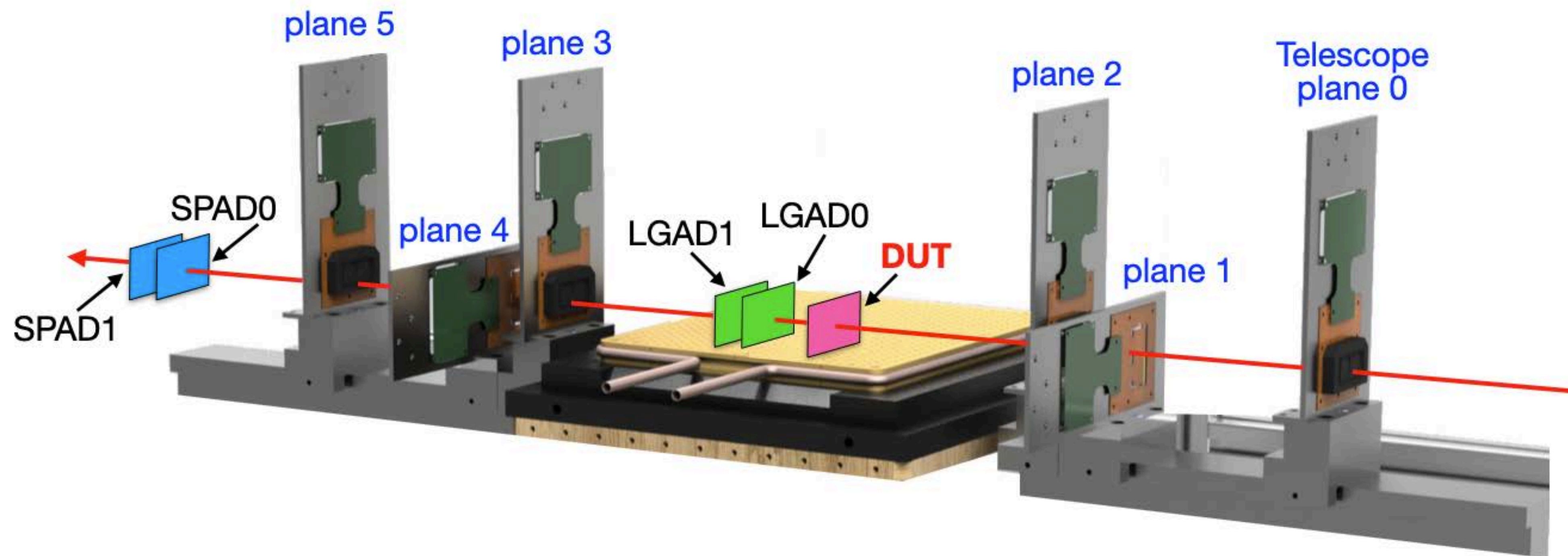
Timespot: timing tilted sensors



Single Pixel @ 50V



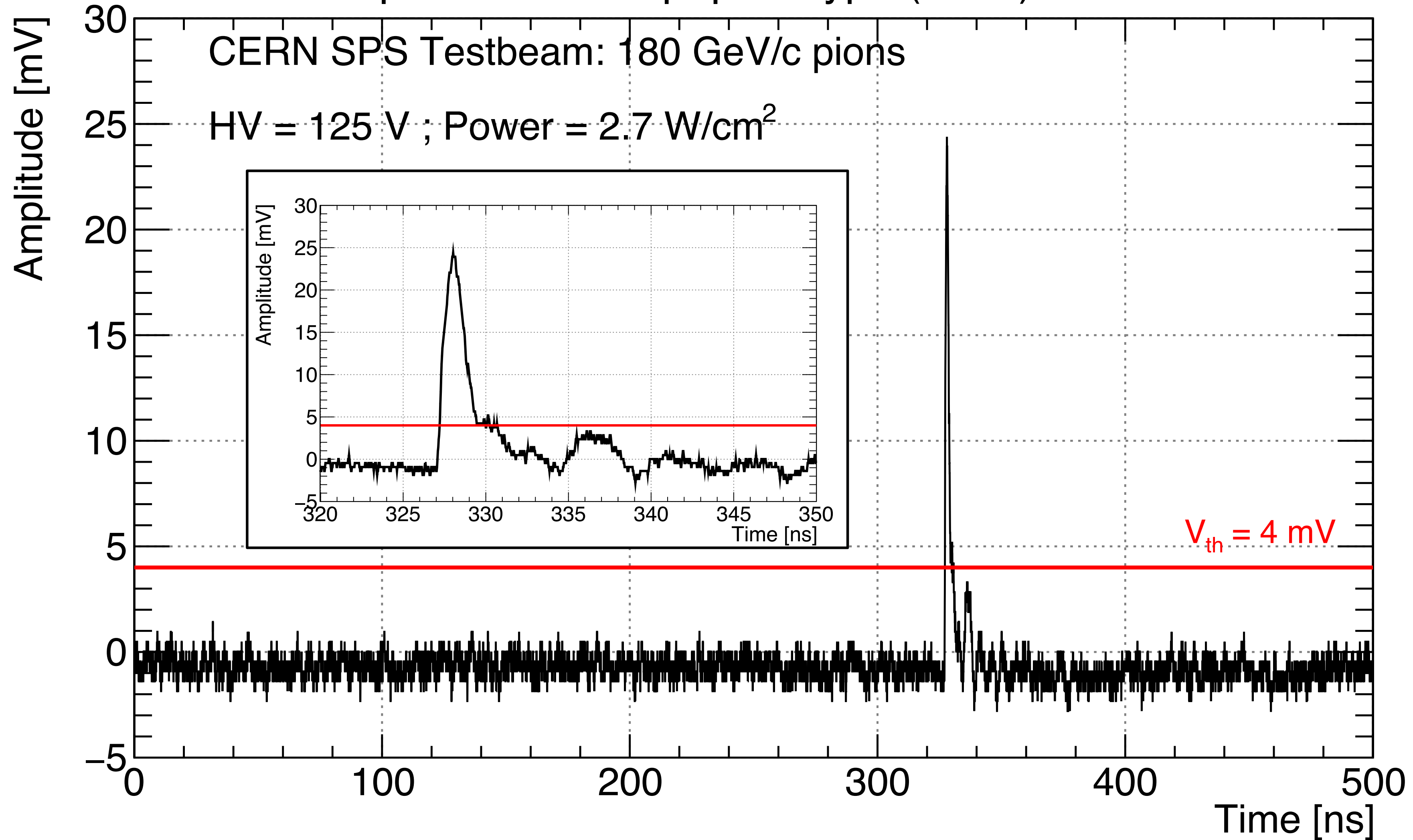
CERN SPS Testbeam with 180 GeV/c pions to measure **efficiency** and **time resolution**



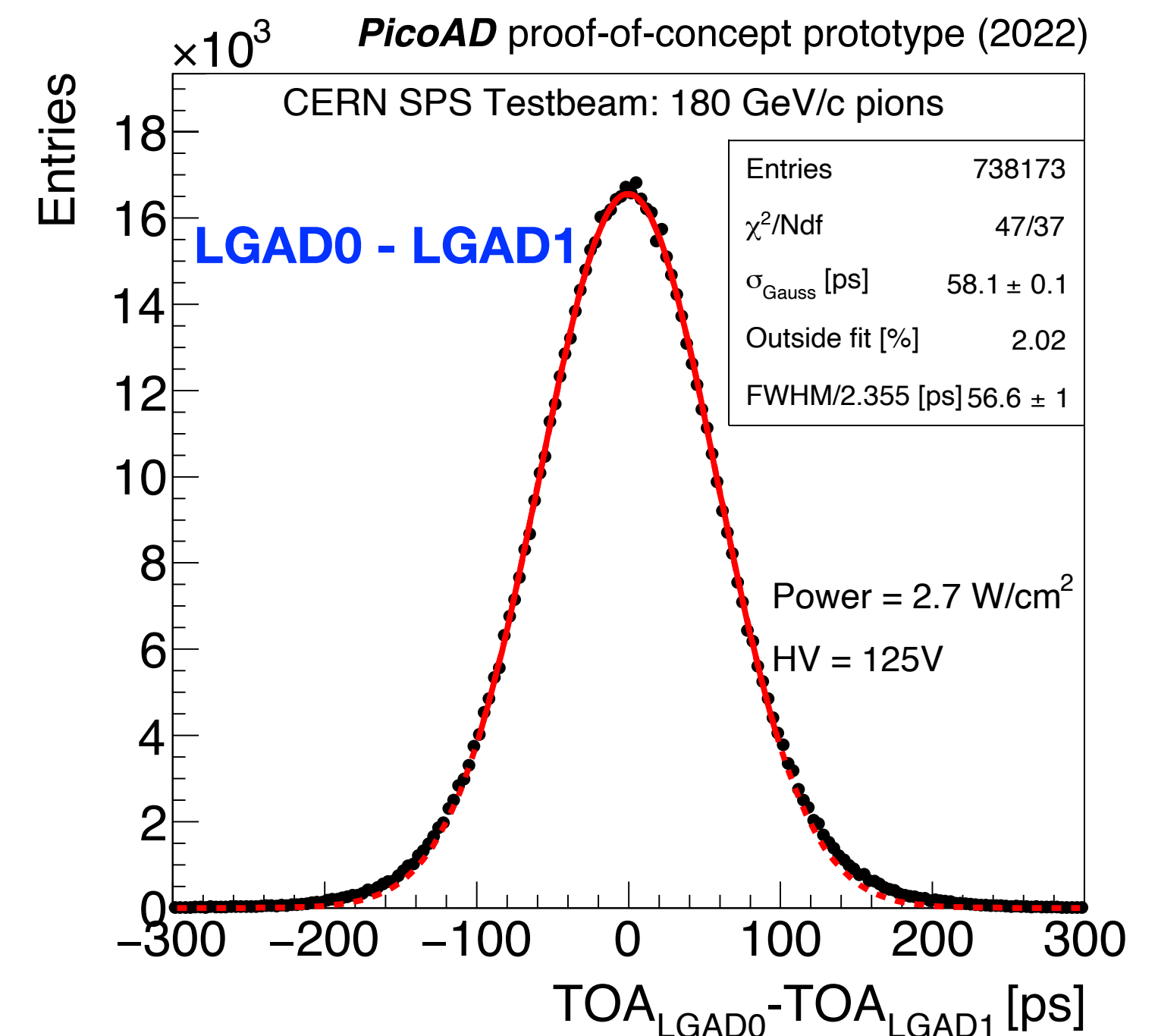
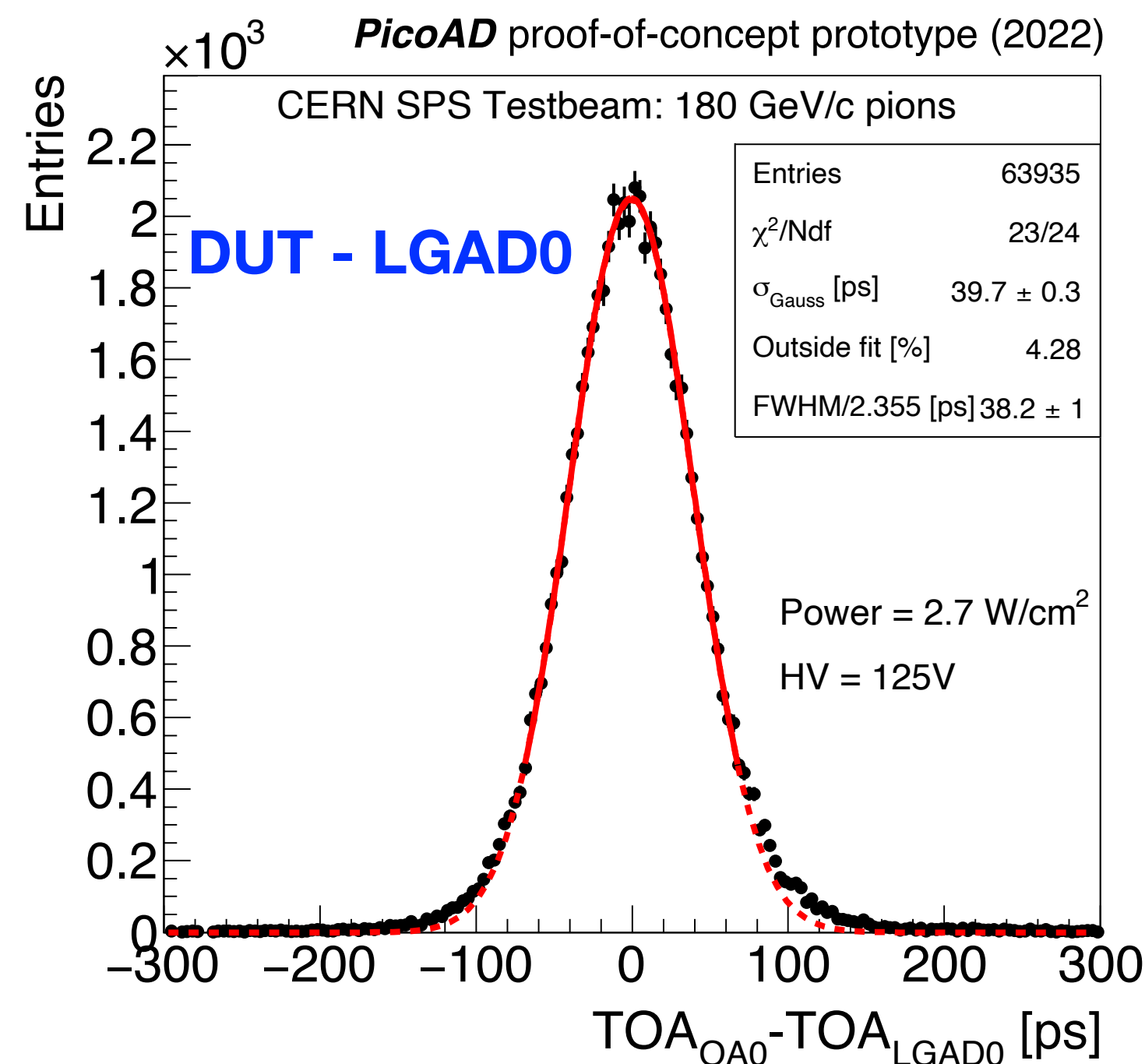
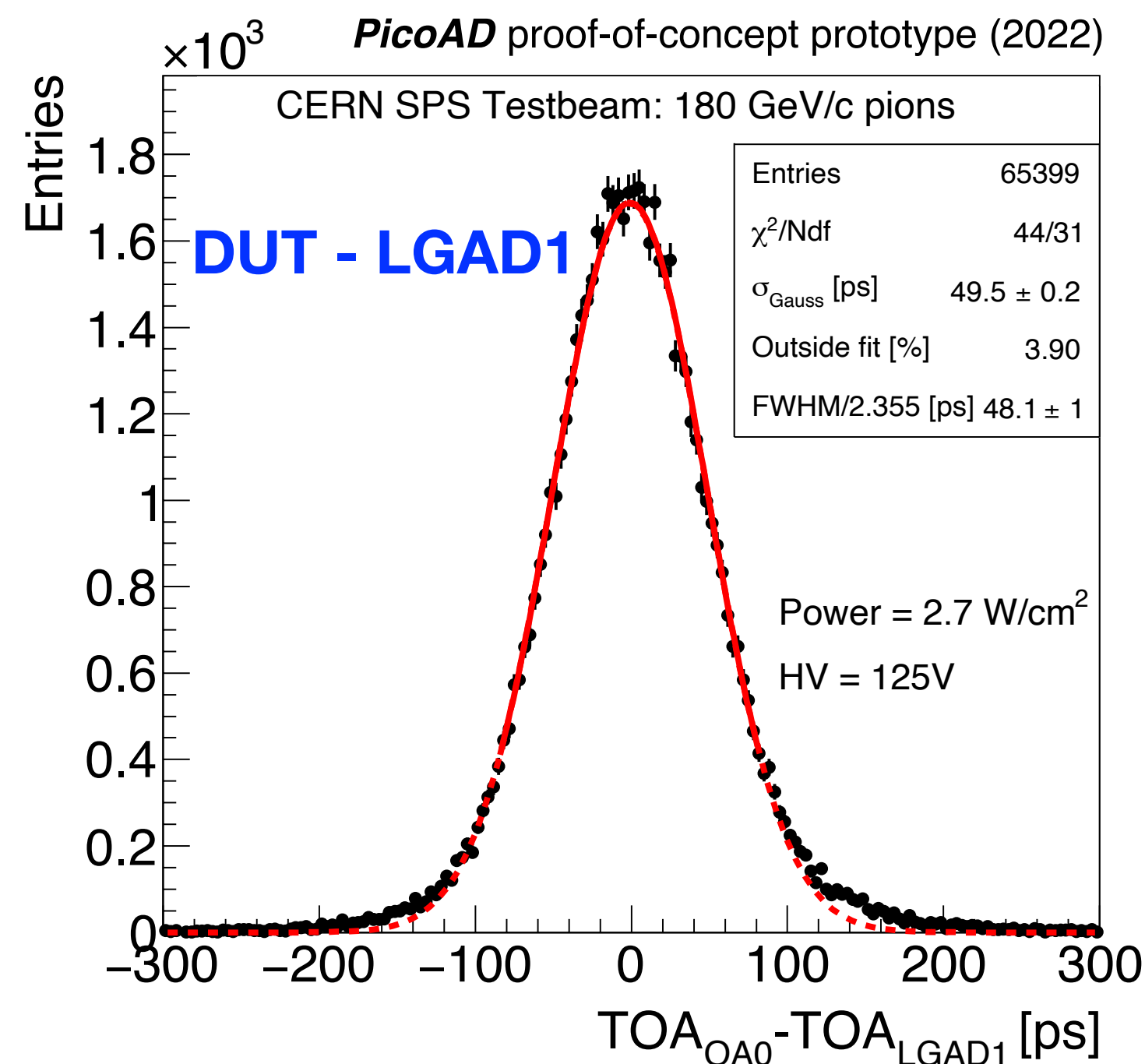
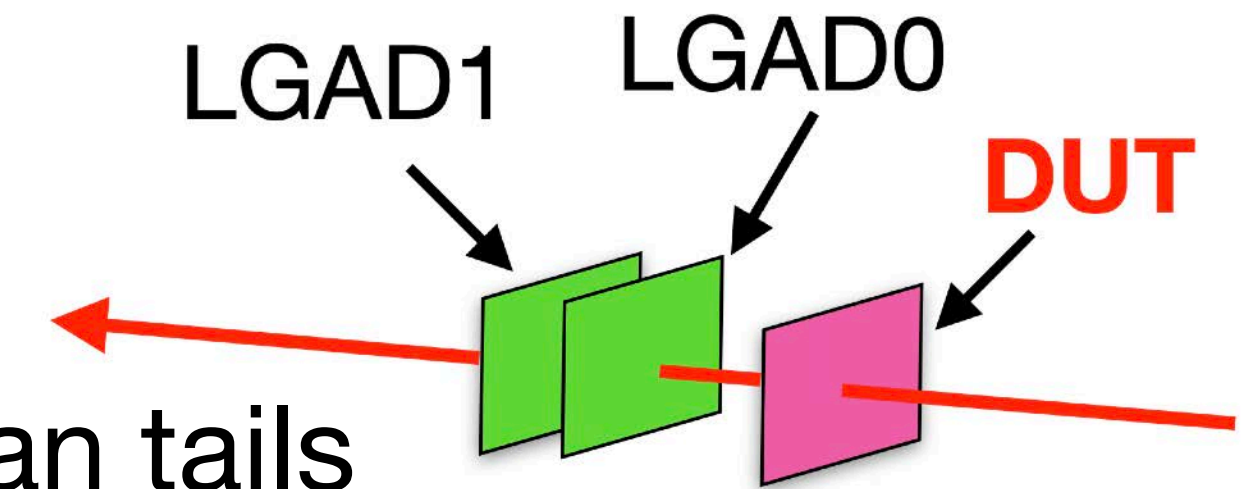
UNIGE FE-I4 telescope to provide spatial information ($\sigma_{x,y} \approx 10 \mu\text{m}$)

Two LGADs ($\sigma_t \approx 35 \text{ ps}$) to provide the timing reference (and **two SPADs** with $\sigma_t \approx 20 \text{ ps}$)

PicoAD proof-of-concept prototype (2022)

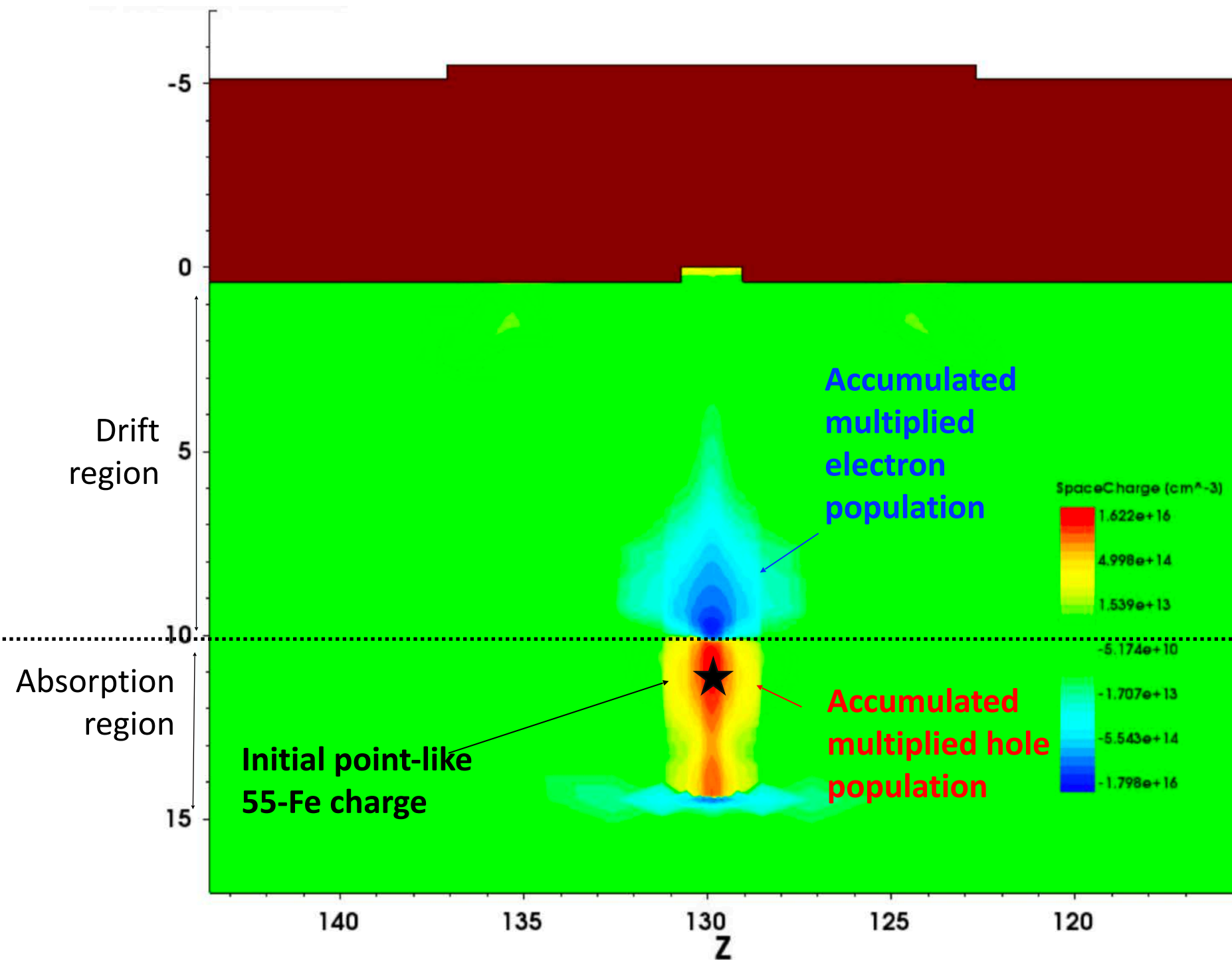


- Time Of Arrival (TOA) as a **time at constant fraction**
- Distributions after **time-walk correction**
- Distributions are **Gaussian**: only $\approx 2-4\%$ of entries in non-gaussian tails
- Simultaneous fit to extract time resolutions of the DUT, LGAD0, LGAD1

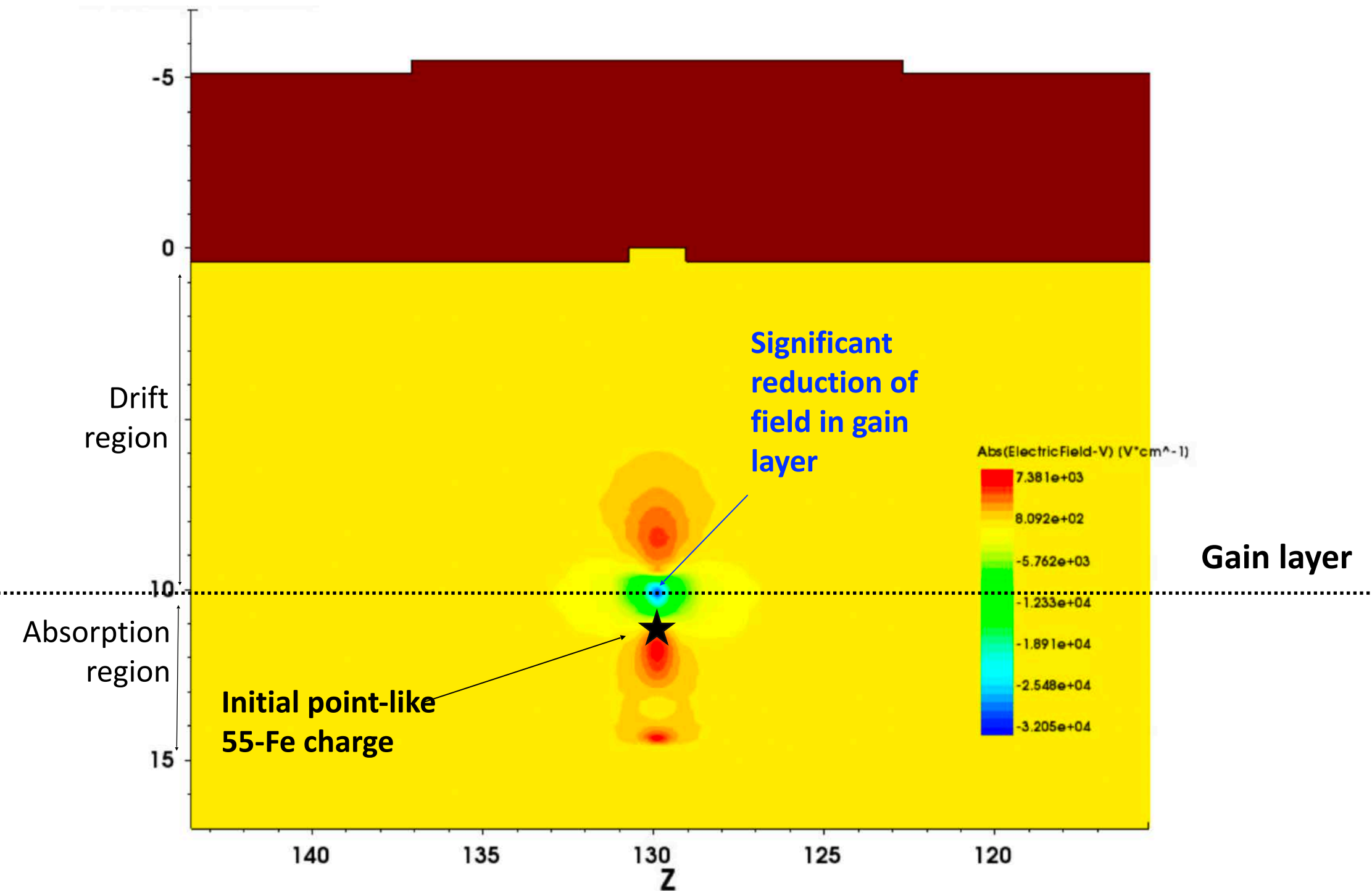


Transient 3D TCAD simulation of point like 55-Fe charge deposition in absorption layer:

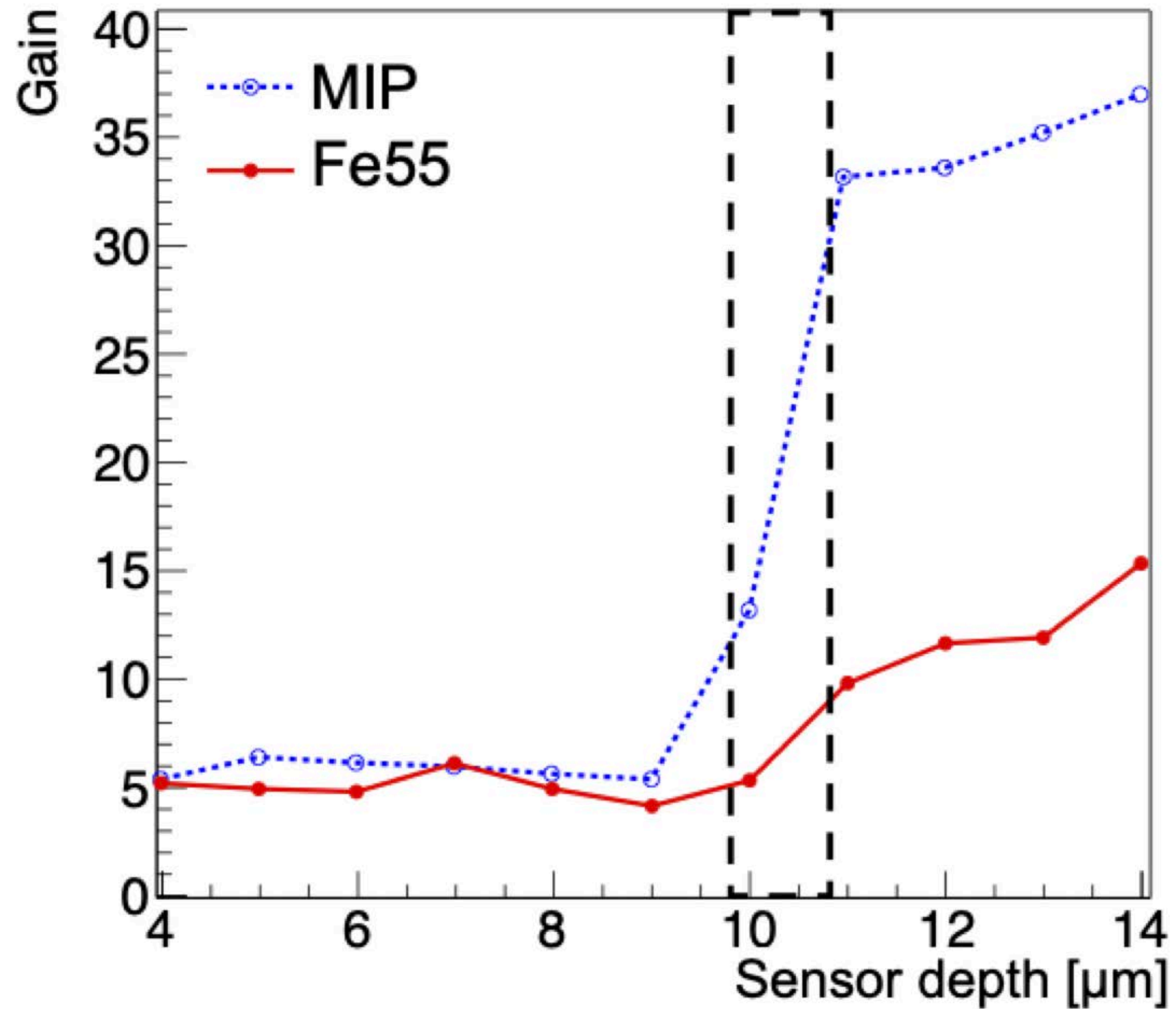
Space charge:
10ps after charge generation – before charge generation:



Electric field:
10ps after charge generation – before charge generation



Gain as function of sensor depth for different primary charge carrier densities:



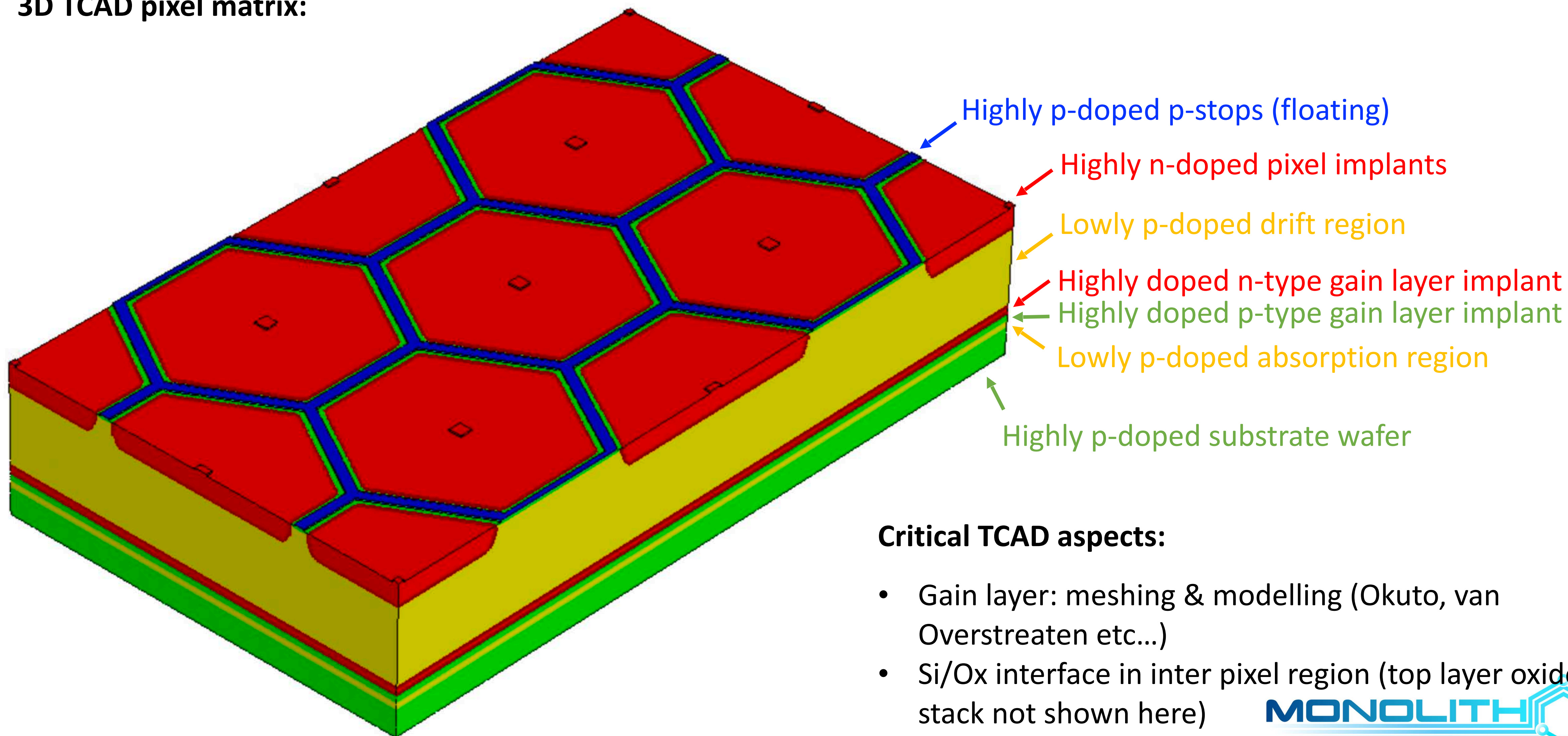
- For high charge carrier densities (Fe55) the gain is suppressed compared to lower charge carrier densities (MIPs).

- Simulated suppression factor of Fe55 w.r.t. MIP charge compatible to calculation of compression factor from test-beam and Fe55 measurements.

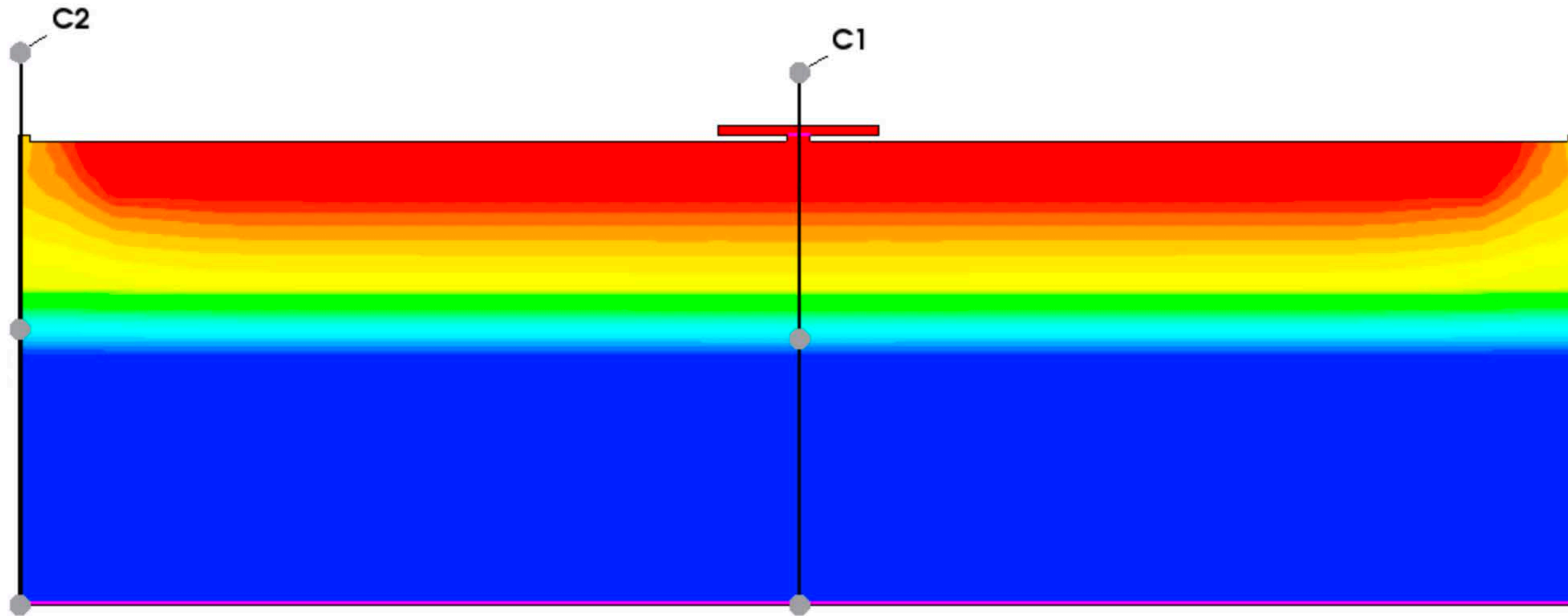
→ Measured gain for Fe55 significantly suppressed by transient space charge effect.

→ Need of fully self consistent transient TCAD simulations.

3D TCAD pixel matrix:

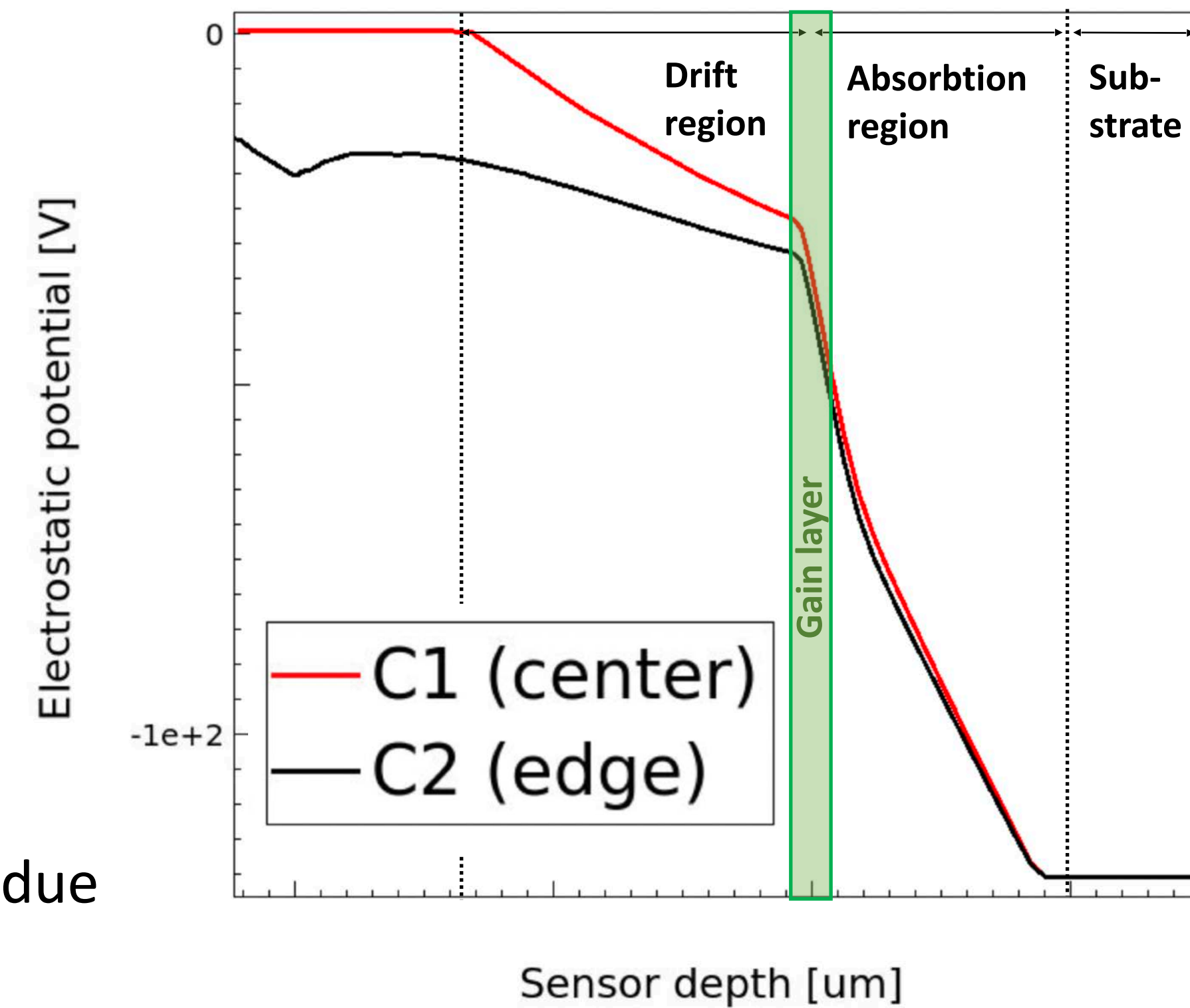


Electrostatic potential – 2D map:

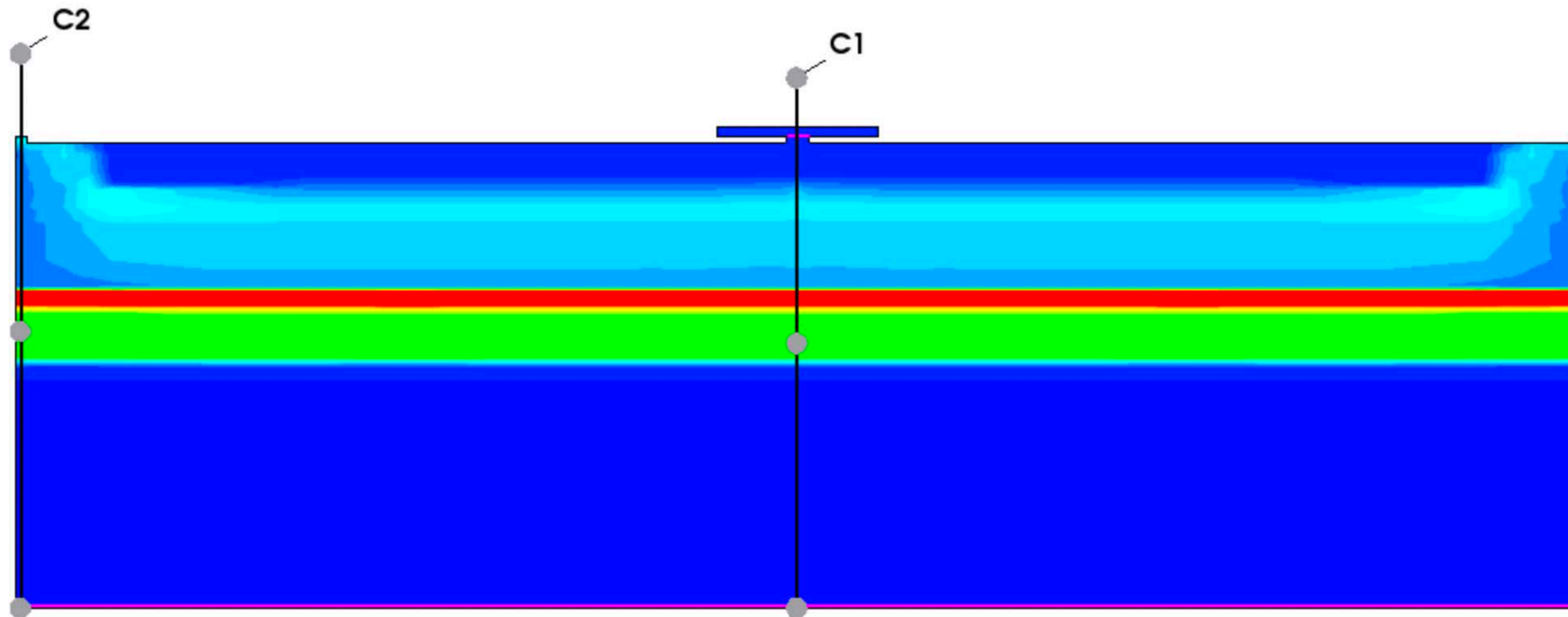


- Highest potential drop in gain layer (as expected)
- Significant potential drop in drift region, less compared to absorption region due to increased thickness
- In inter-pixel region:
 - Potential maximum close to surface
 - Reduced potential drop in drift & gain layer region

Electrostatic potential – cuts C1, C2:

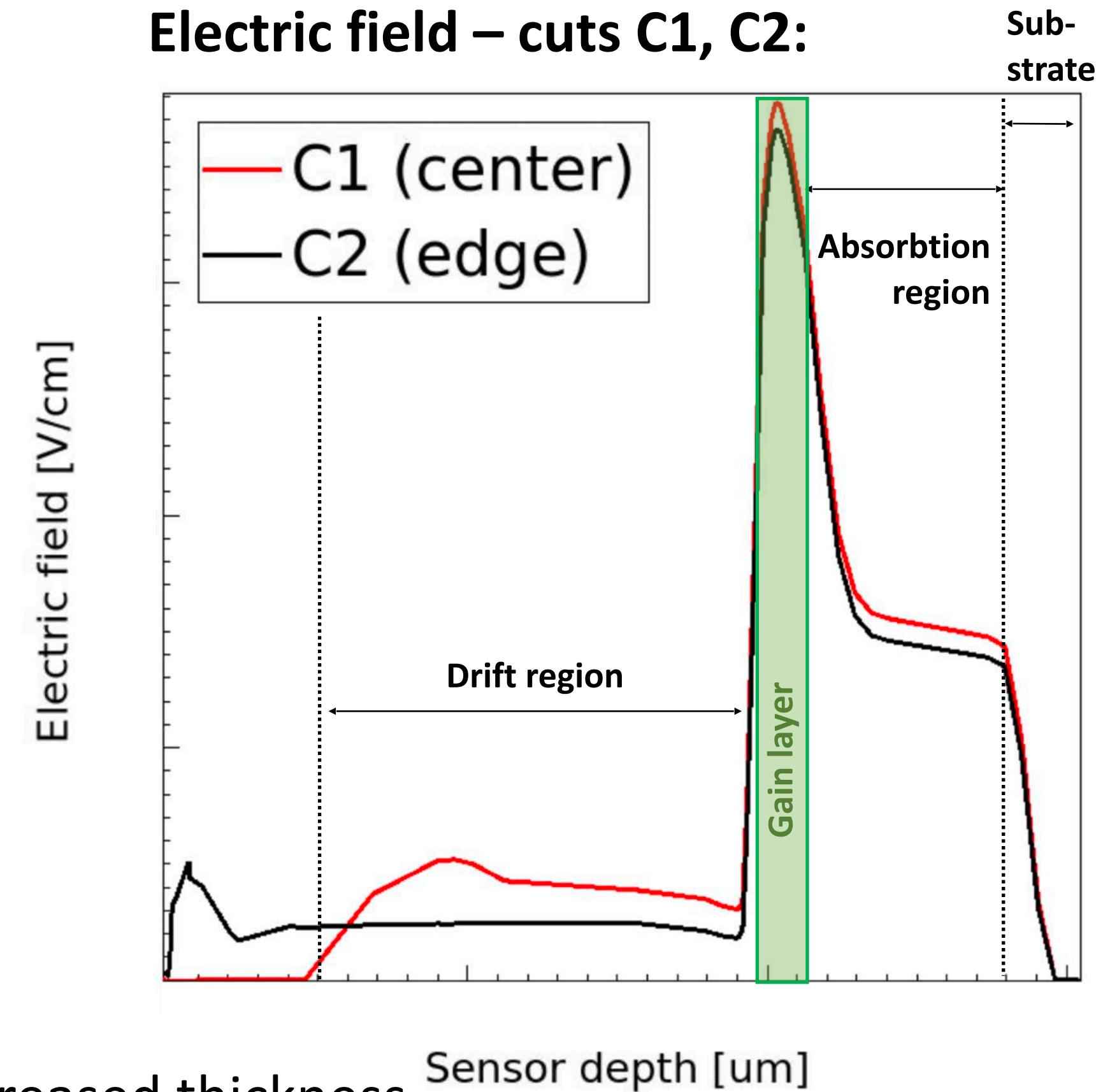


Electric field – 2D map:

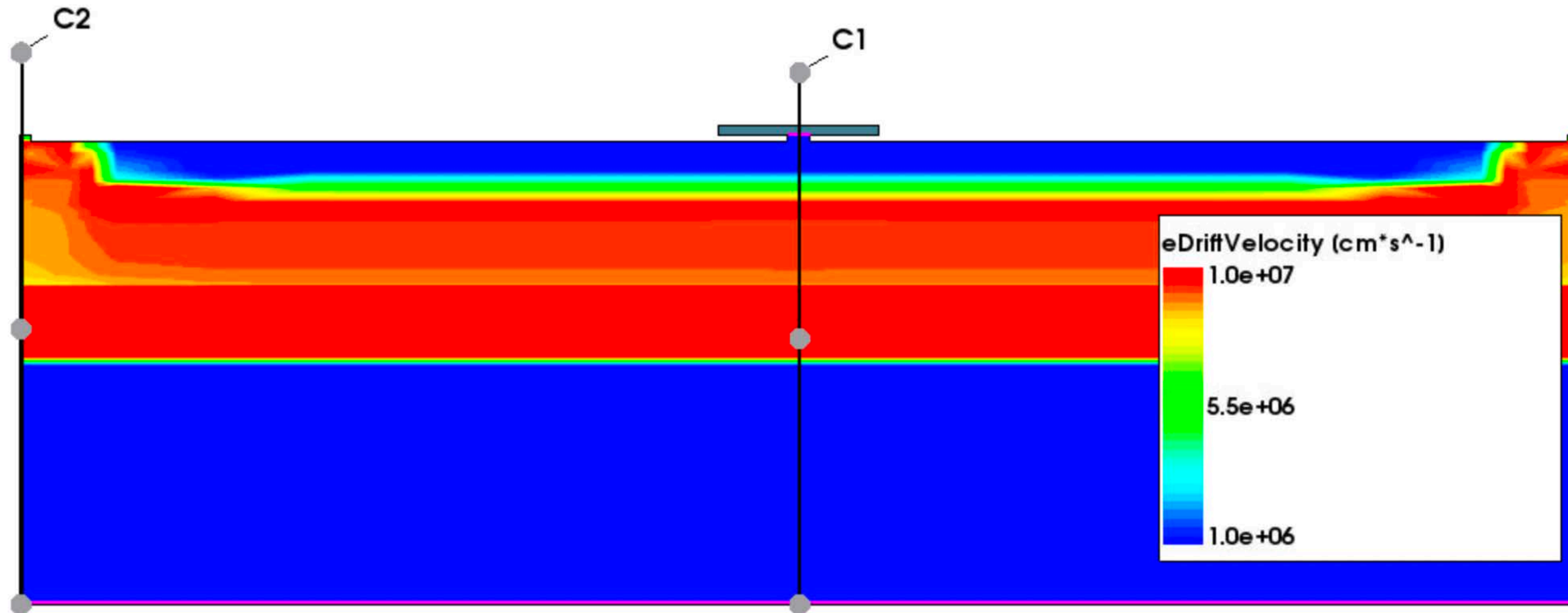


- Highest electric field in gain layer (as expected)
- Significant E field in drift region, less compared to absorption region due to increased thickness
- In inter-pixel region:
 - Field minimum close to surface
 - Reduced field in drift & gain layer region → lower gain in inter pixel region

Electric field – cuts C1, C2:

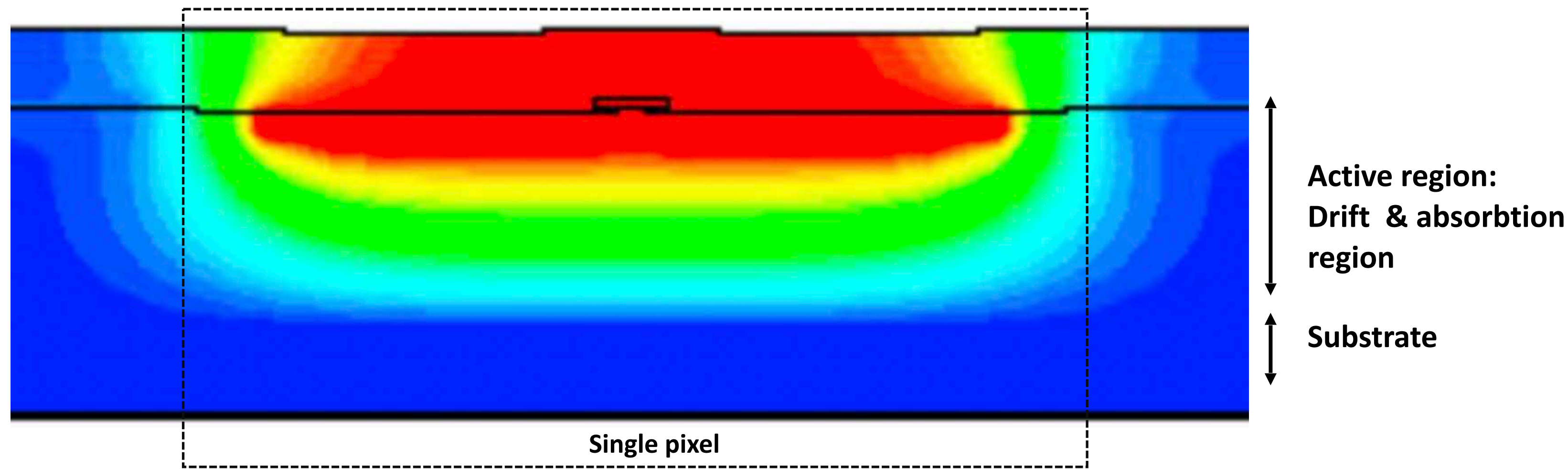


Electron drift velocity – 2D map:



- Electron drift velocity very close to saturation in full pixel volume (note the scale!)
- Important for precise timing

Weighting potential – 2D map:

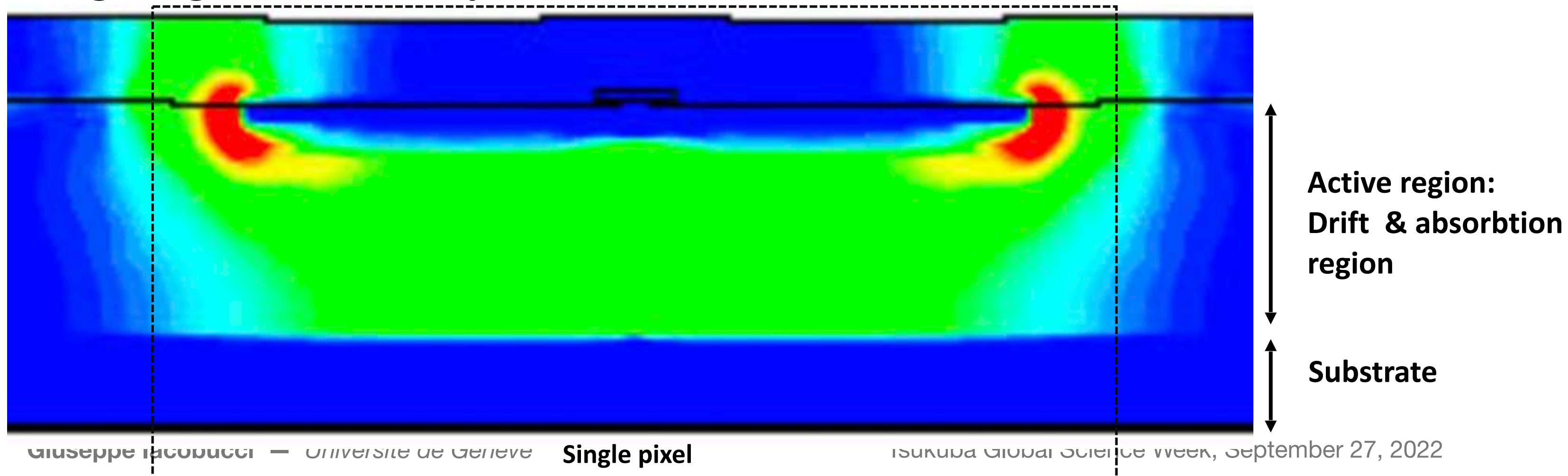


- No impact of gain layer on weighting potential & field

- High weighting field over full active thickness

→ Important for precise timing

Weighting field – 2D map:



- Highest weighting field in pixel implant corners due to largest potential drop

First proof of concept prototype with non-optimal drift region thickness:

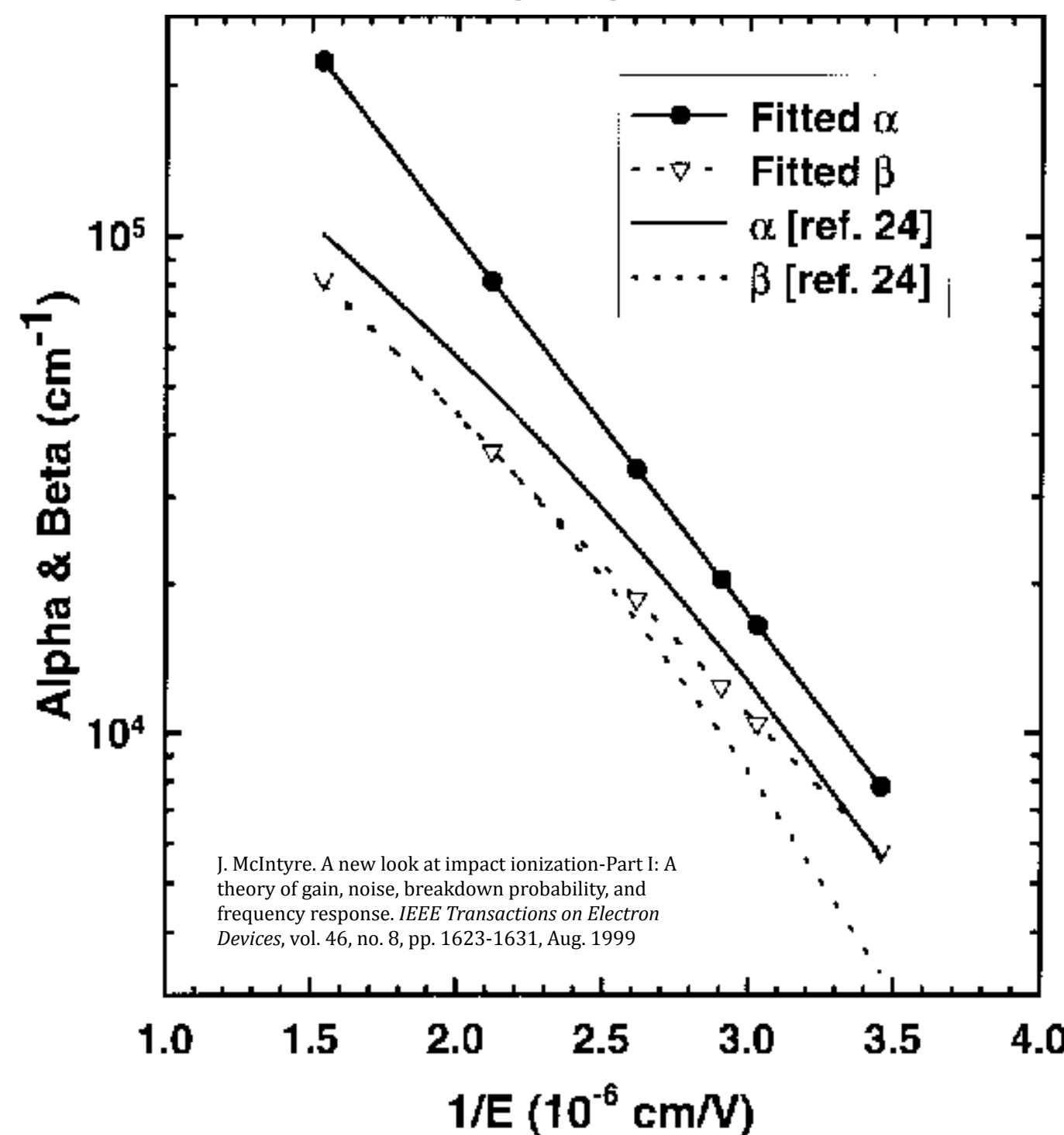
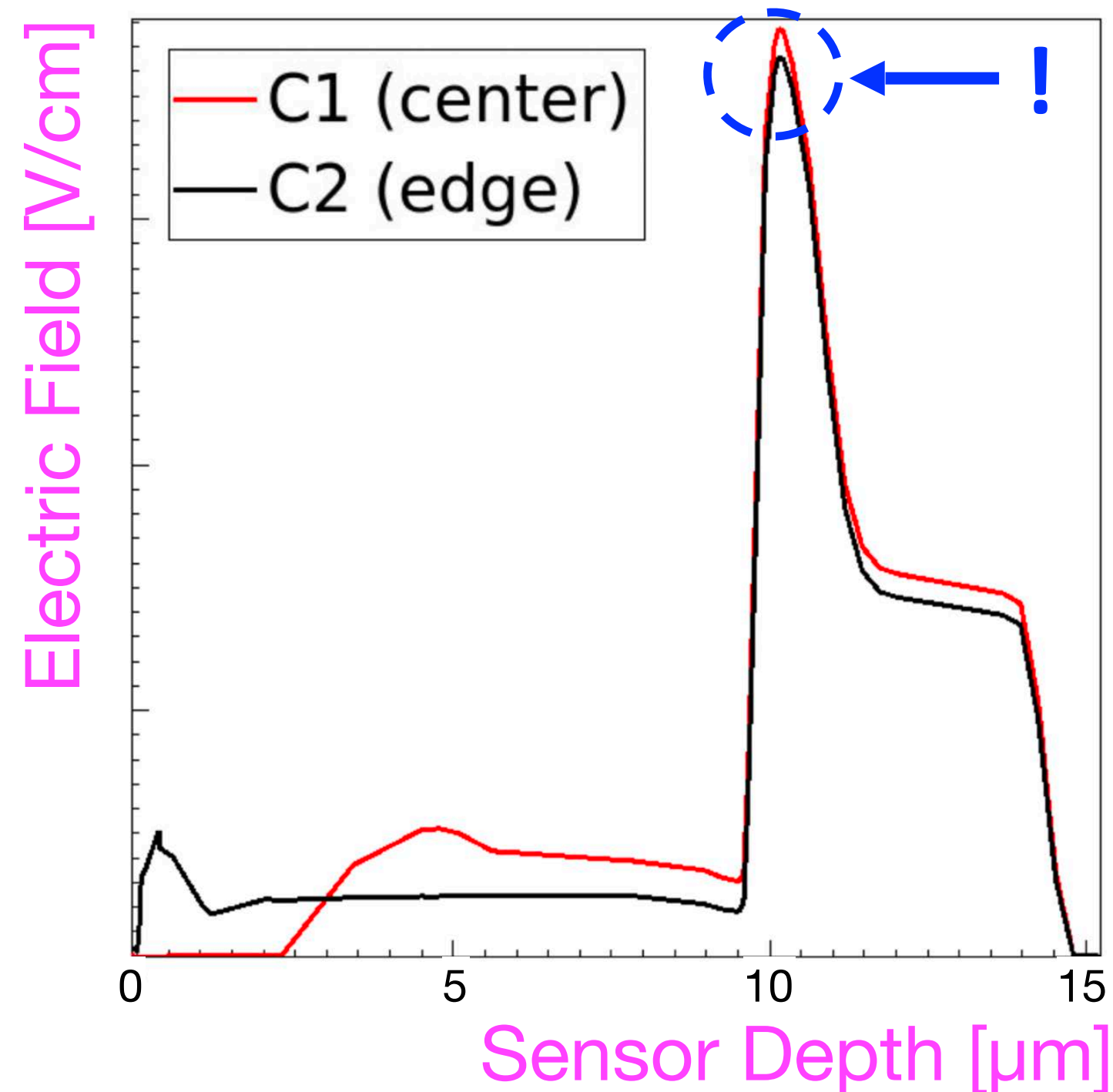
Thickness of epi-layer limited by production process

→ Significant gain variations in inter-pixel region:

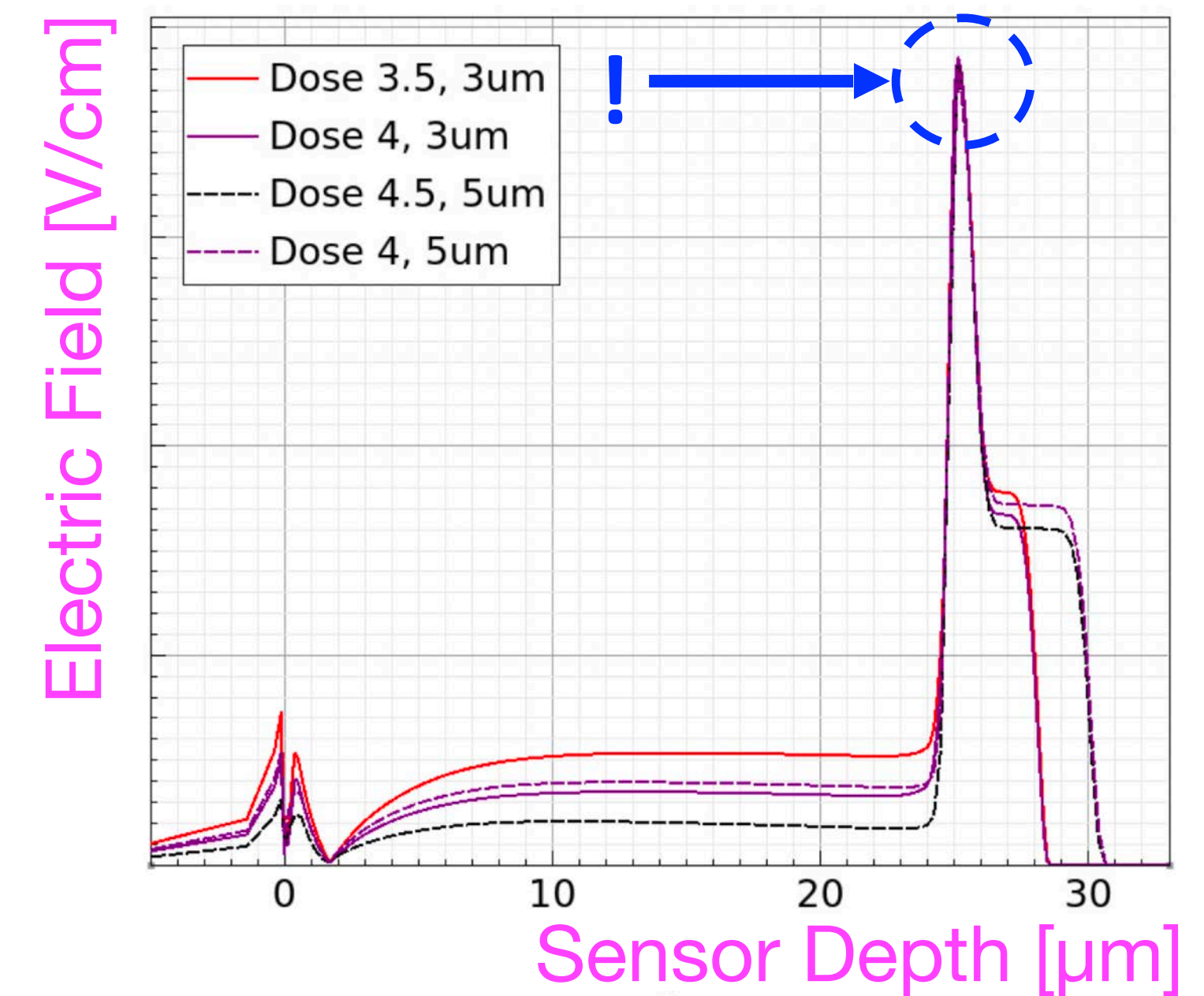
At high voltage, small variations of the electric field in the gain layer result in large gain variations:

→ Next production (with external company): thicker epitaxial layer for drift region

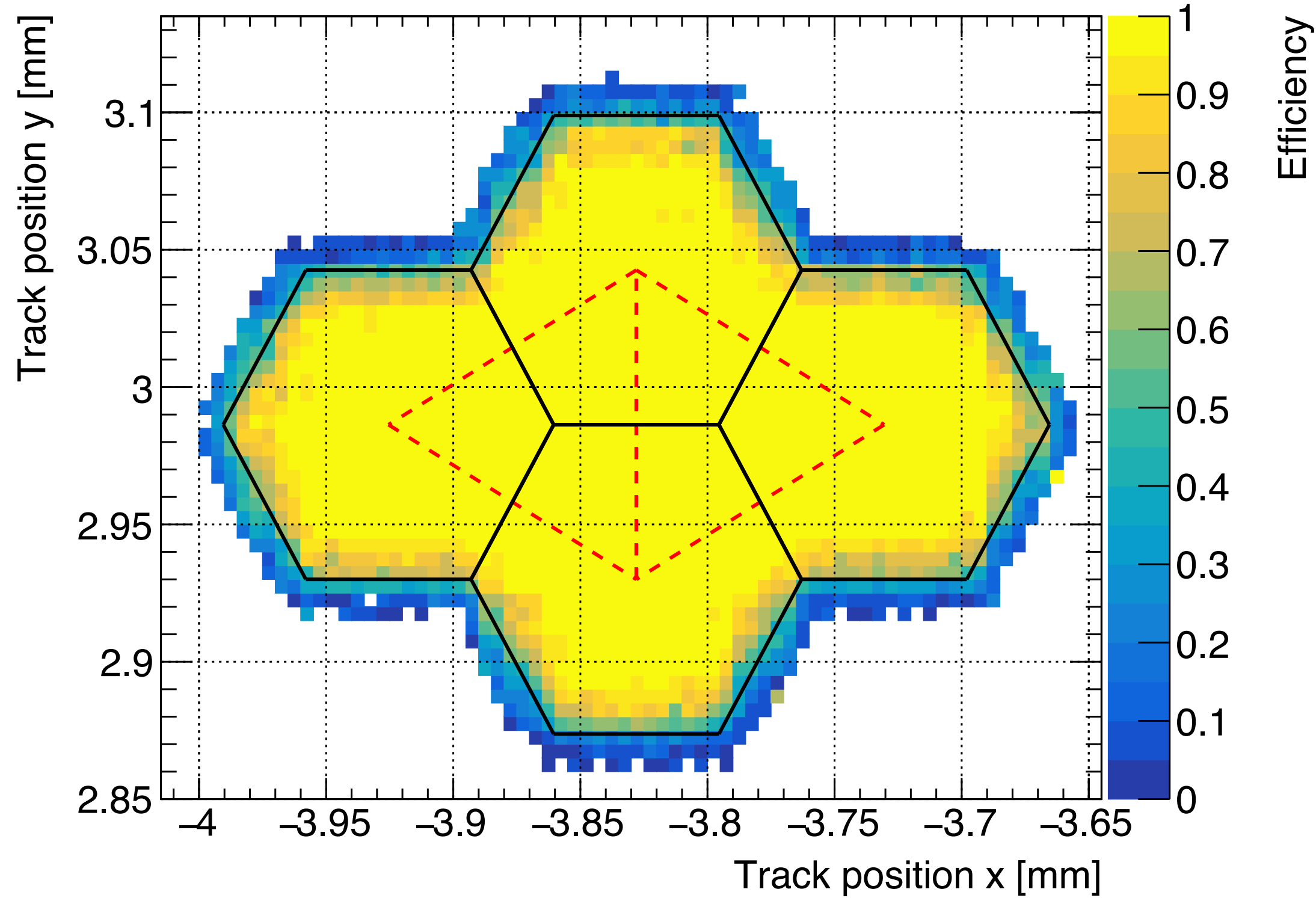
E_{field} , 1st prototype, 10 μ m drift region:



E_{field} , 2nd prototype, 25 μ m drift region:

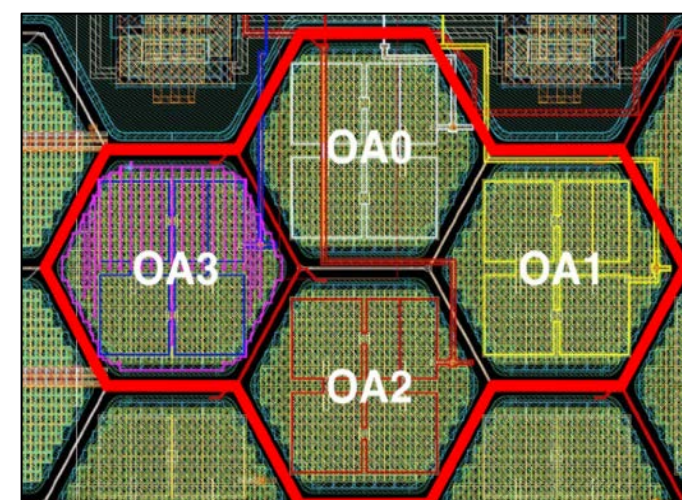
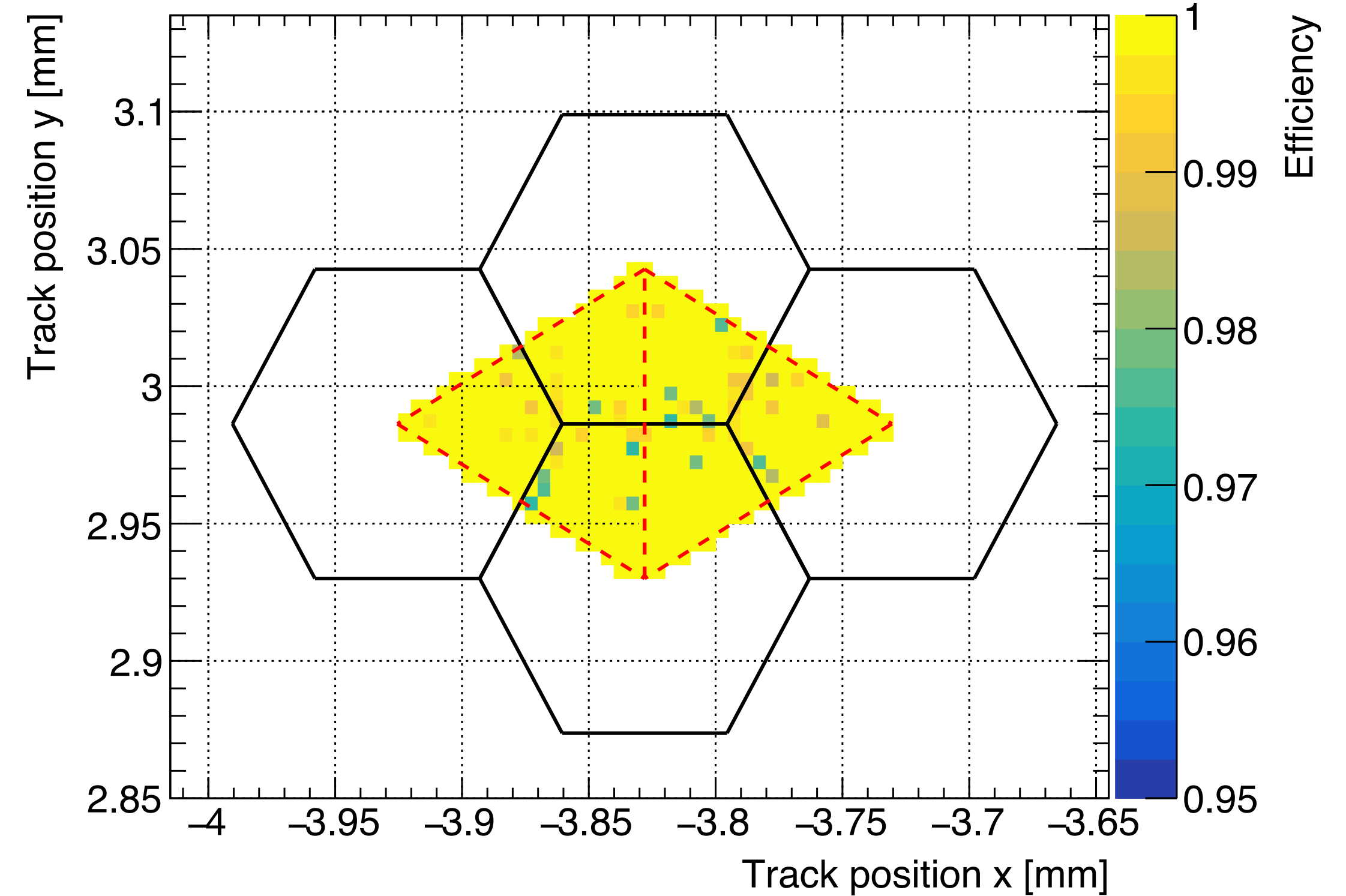


PicoAD proof-of-concept prototype (2022)

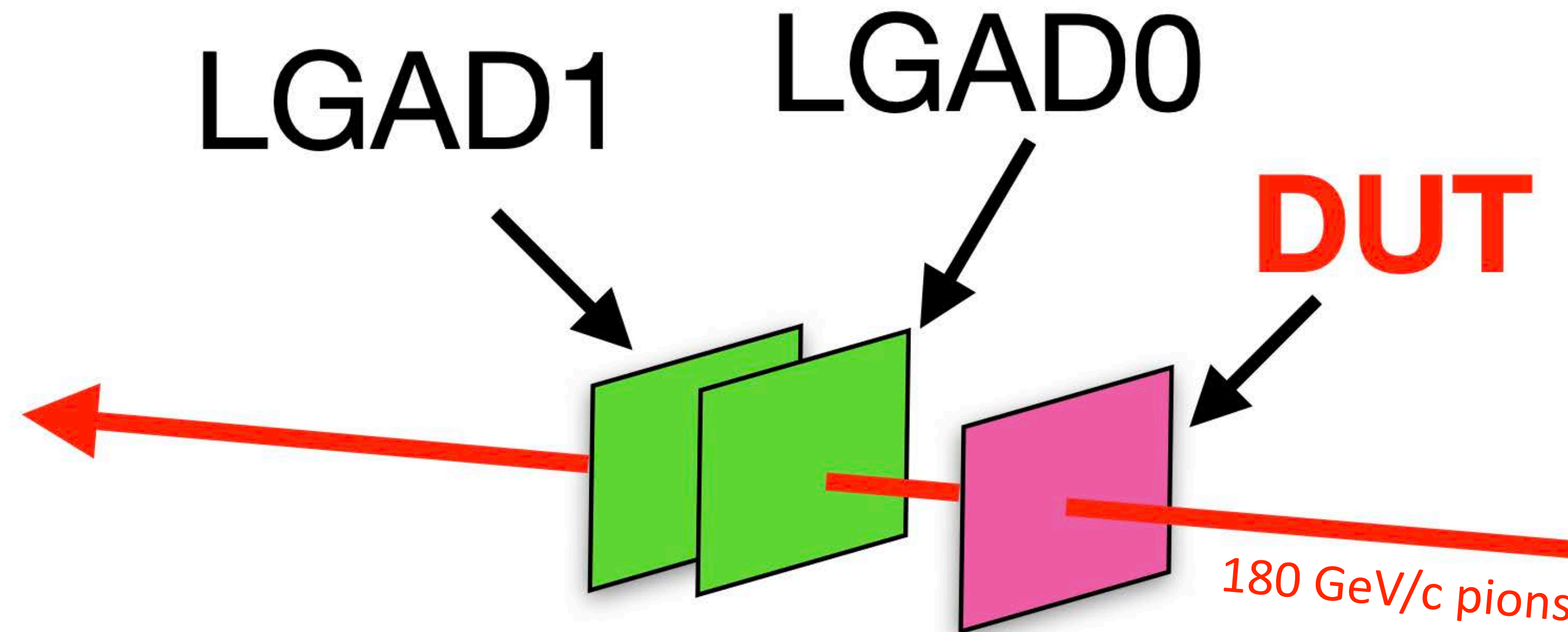


CERN SPS Testbeam: 180 GeV/c pions
 $V_{th} = 4 \text{ mV}$; $HV = 125 \text{ V}$; $Power = 2.7 \text{ W/cm}^2$

Efficiency of triangles

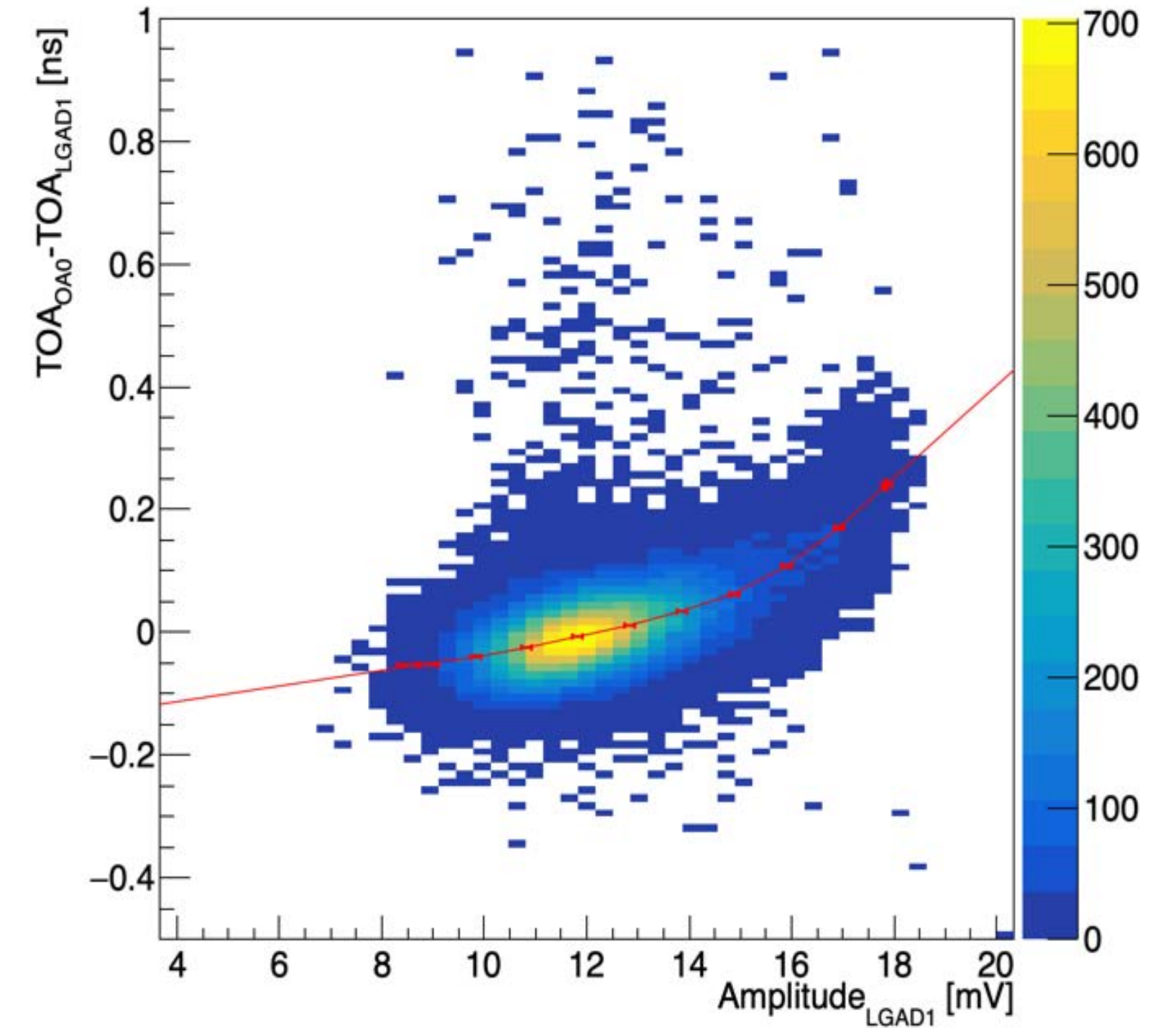
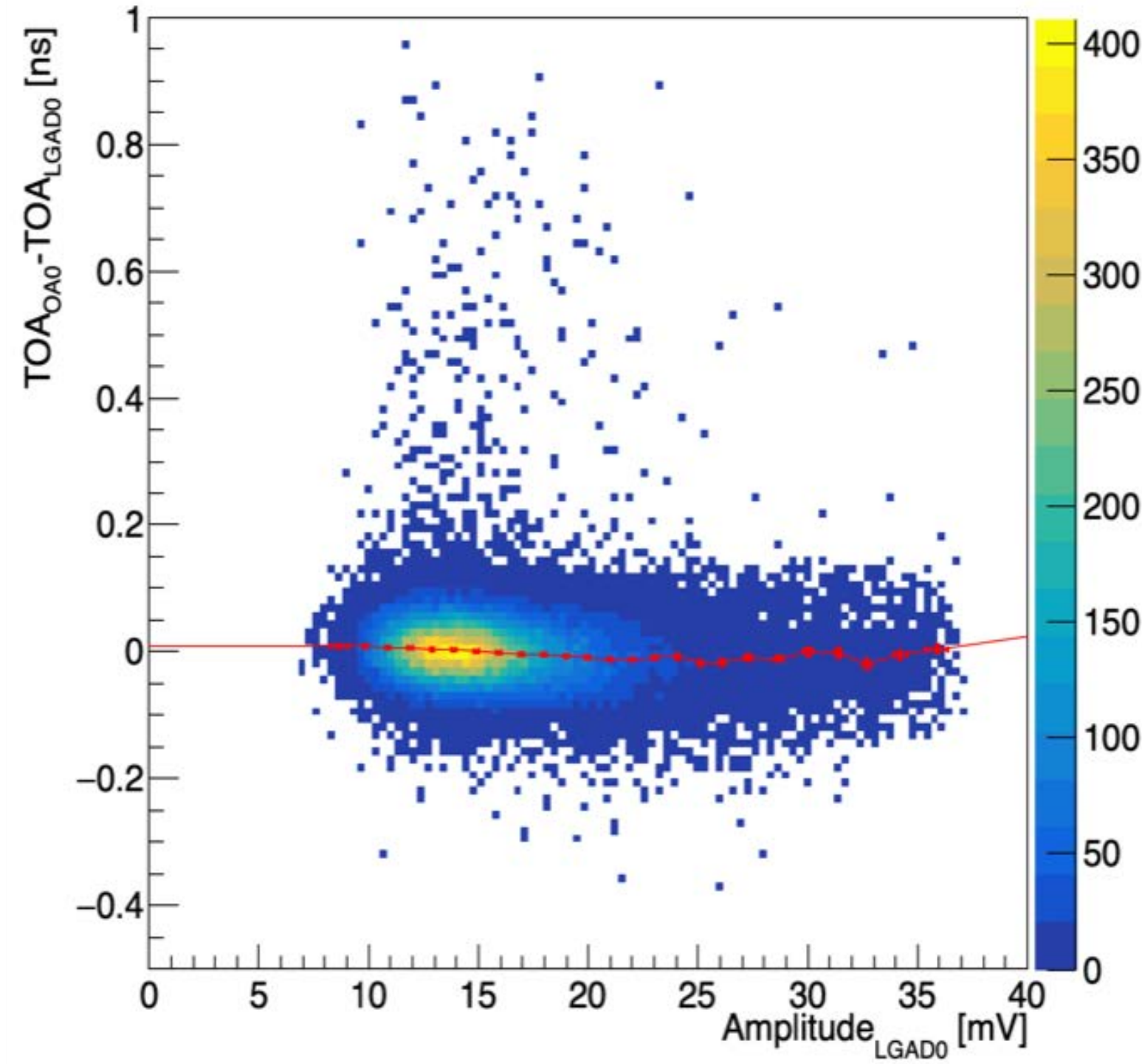
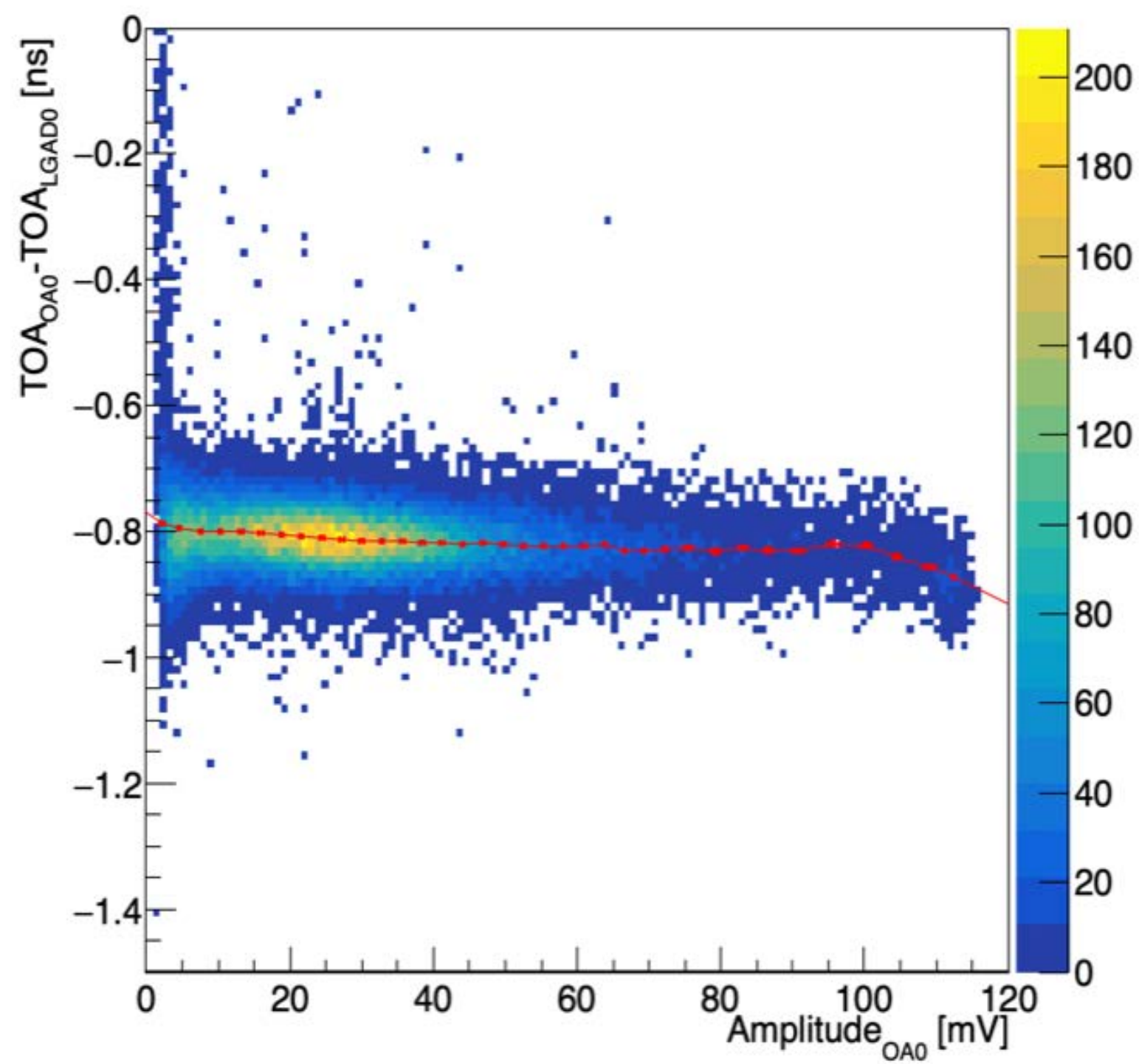


- Selection of two **triangles**:
- representative of a whole pixel
 - **unbiased** by telescope resolution



Results were also verified using **two SPADs** (but with much smaller statistics)

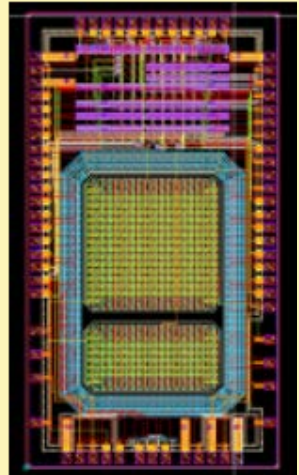
- Shift at 200 ps of the waveform to subtract low-frequency noise
- Time at constant fraction: 25% of max amplitude
- Amplitude-based time-walk correction for residual time walk



Prototypes without internal gain layer

PicoAD Proof-Of-Concept Prototype

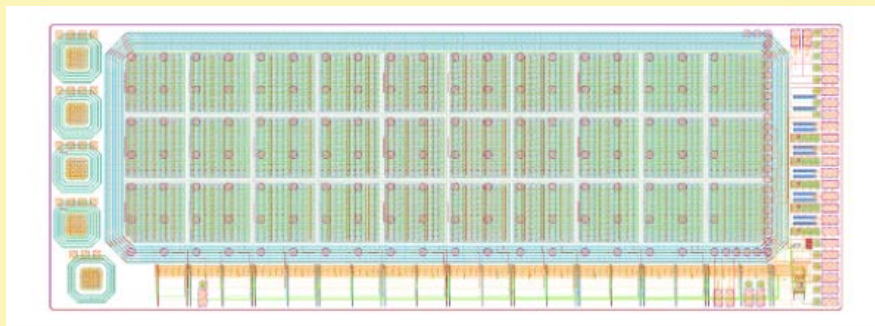
2016



200ps

- 1 and 0.5 mm² pixels
- Discriminator output

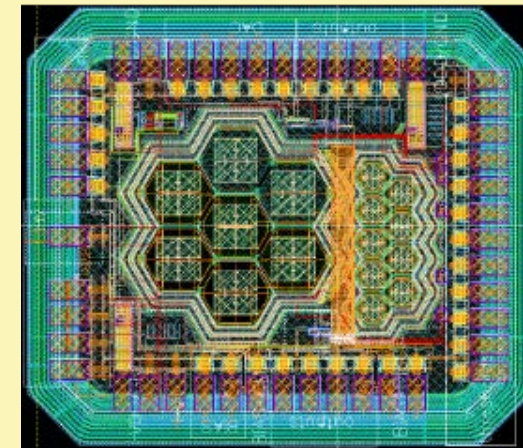
2017



110ps

- 30 pixels 500x500µm²
- 100ps TDC +I/O logic

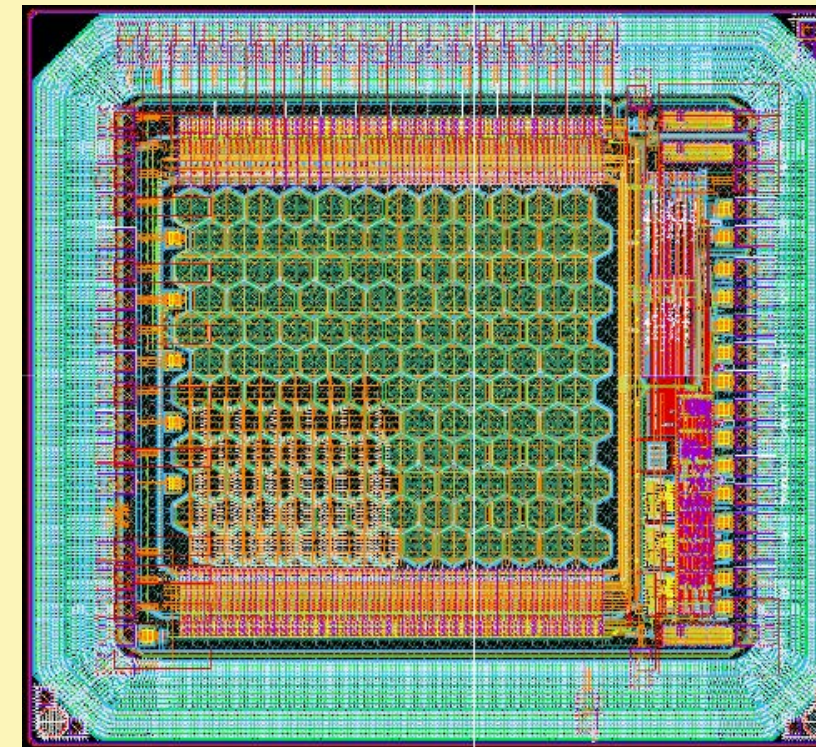
2018



50ps

- Hexagonal pixels 65µm and 130µm side
- Discriminator output

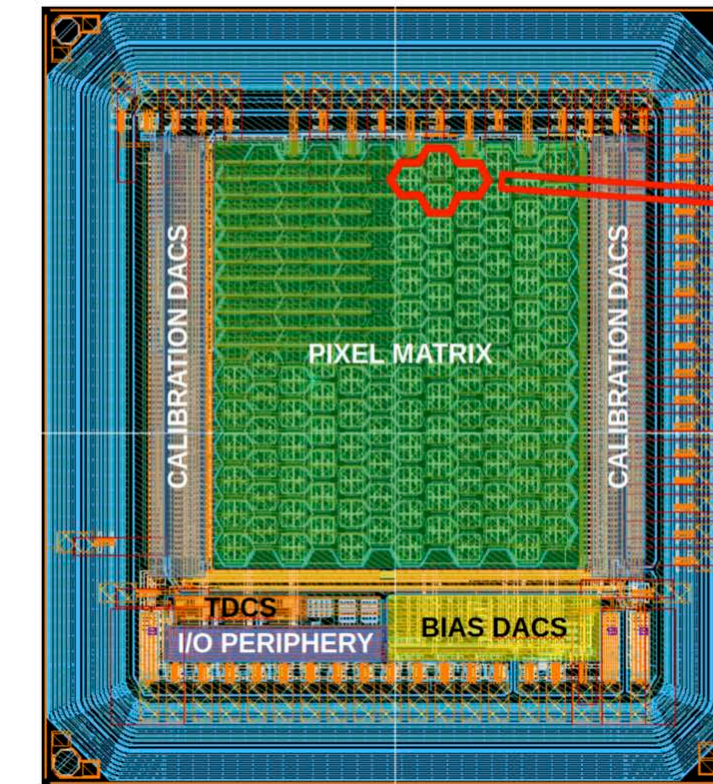
2019



36 ps

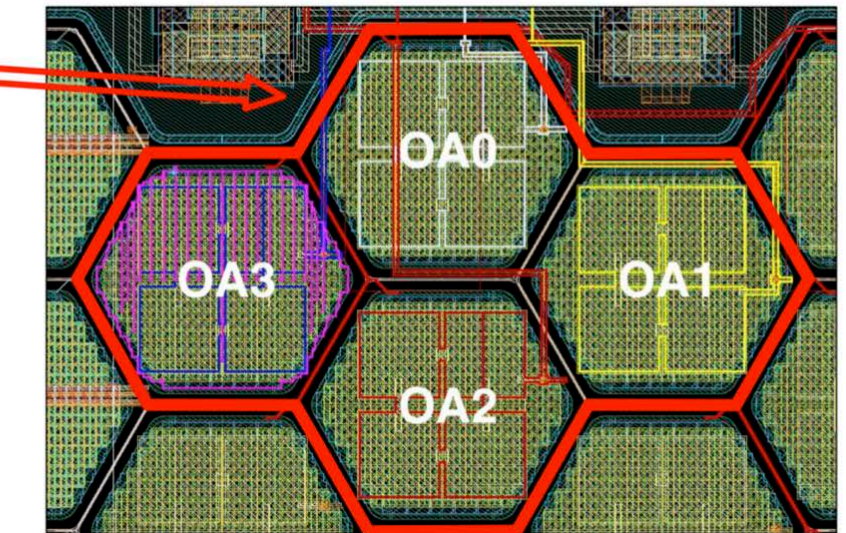
- Hexagonal pixels 65µm side
- 30ps TDC +I/O logic
- Analog channels

2021



17 ps

- Same electronics as 2019 prototype
- Epitaxial layers + gain layer
- 4 different gain-layer doses

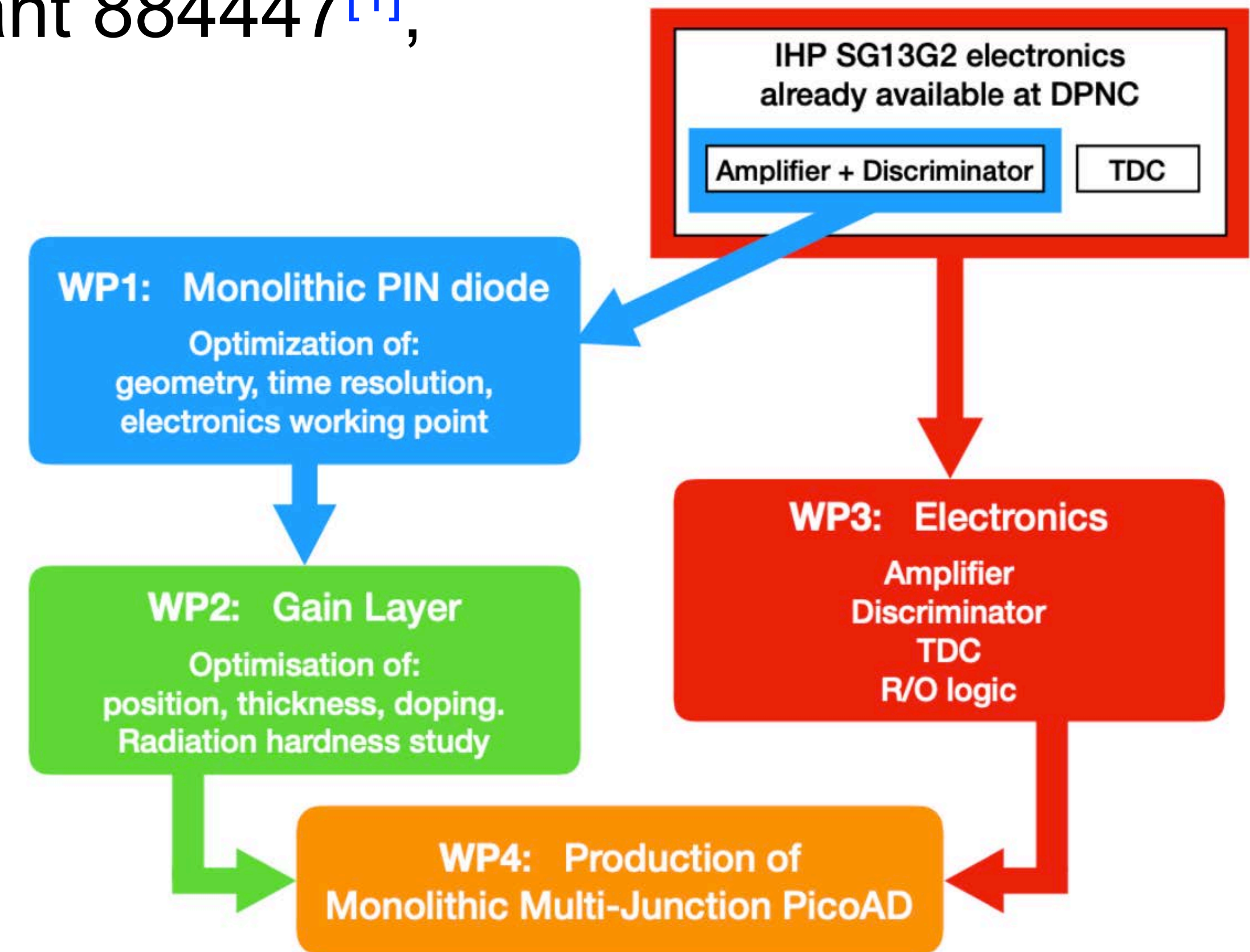


Sensor with no gain test beam results: JINST P02019 2022

PicoAD proof-of-concept prototype

Gain measurements: arXiv:2206.07952, June 2022
Testbeam results: arXiv:2208.11019, August 2022

- Funded by the H2020 ERC Advanced grant 884447^[1], July 2020 - June 2025
- Monolithic silicon sensor able to:
 - ▶ precisely measure 3D spatial position
 - ▶ provide picosecond-level time resolution
- Implements:
 - ▶ Fast and low-noise **SiGe BiCMOS electronics**
 - ▶ Novel sensor concept: the Picosecond Avalanche Detector (**PicoAD**)



[1] MONOLITH H2020 ERC Advanced Project Web Page - <https://www.unige.ch/dpnc/en/groups/giuseppe-iacobucci/research/monolith-erc-advanced-project/>

Other UNIGE projects that use monolithic SiGe BiCMOS

1. 100 μ PET SNSF SINERGIA
2. FASER W-Si pre-shower



The 100 μ PET SNSF SINERGIA project



European Research Council
Established by the European Commission



Giuseppe Iacobucci
• P.I.



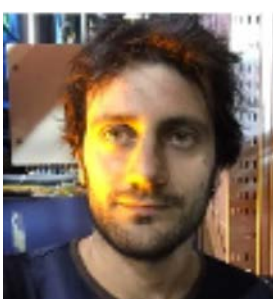
Mateus Vicente
• System integration
• Laboratory test



Jihad Saidi
• System simulation
• Laboratory test



Didier Ferrere
• System integration
• Laboratory test



Lorenzo Paolozzi
• Sensor design
• Analog electronics



Yannick Favre
• Board design
• RO system



Franck Cadoux
• Mechanics
• FEA calculations



Michäel Unser
• P. I.



Pol del Aguila Pla
• Statistical signal processing



Aleix Boquet-Pujadas
• Signal/image processing
• Physical modeling



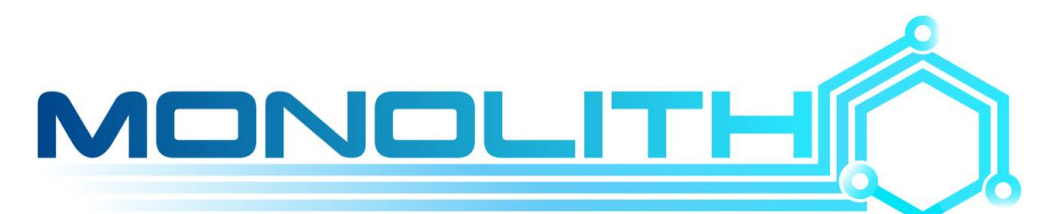
Martin Walter
• P. I.

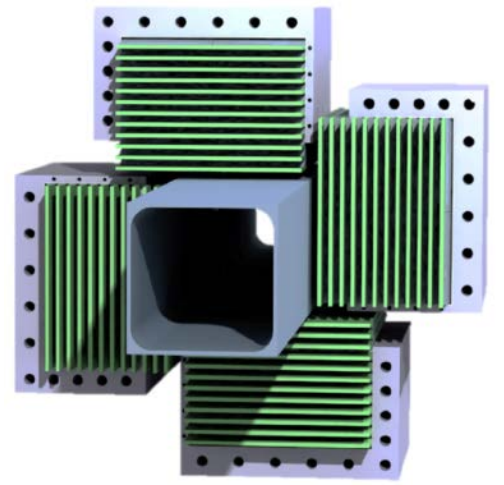


Pablo Jané
• Nuclear Medicine
• PET imaging
• Translational imaging



Xiaoying Xu
• Molecular Biology
• In vivo studies
• Bioinformatics

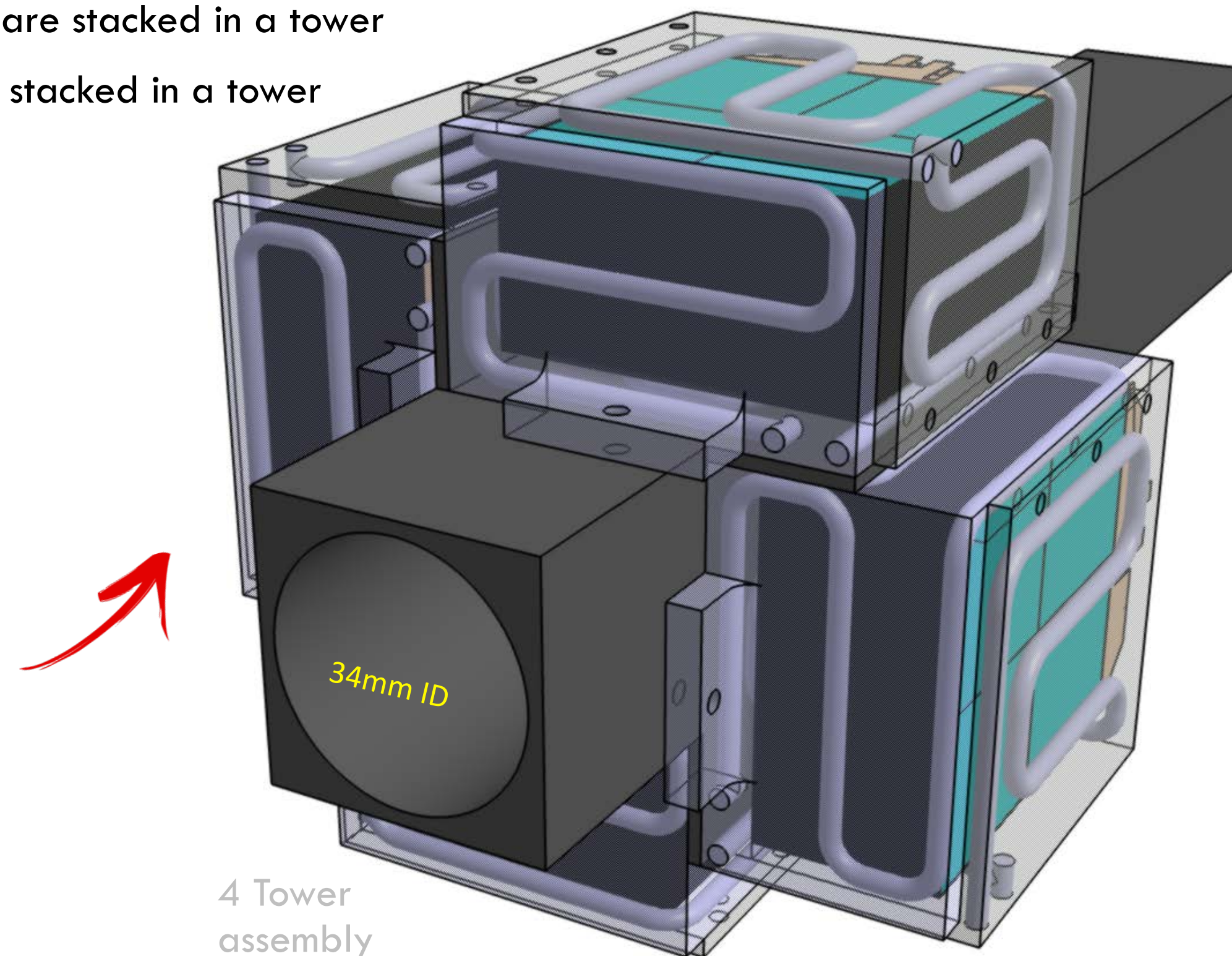
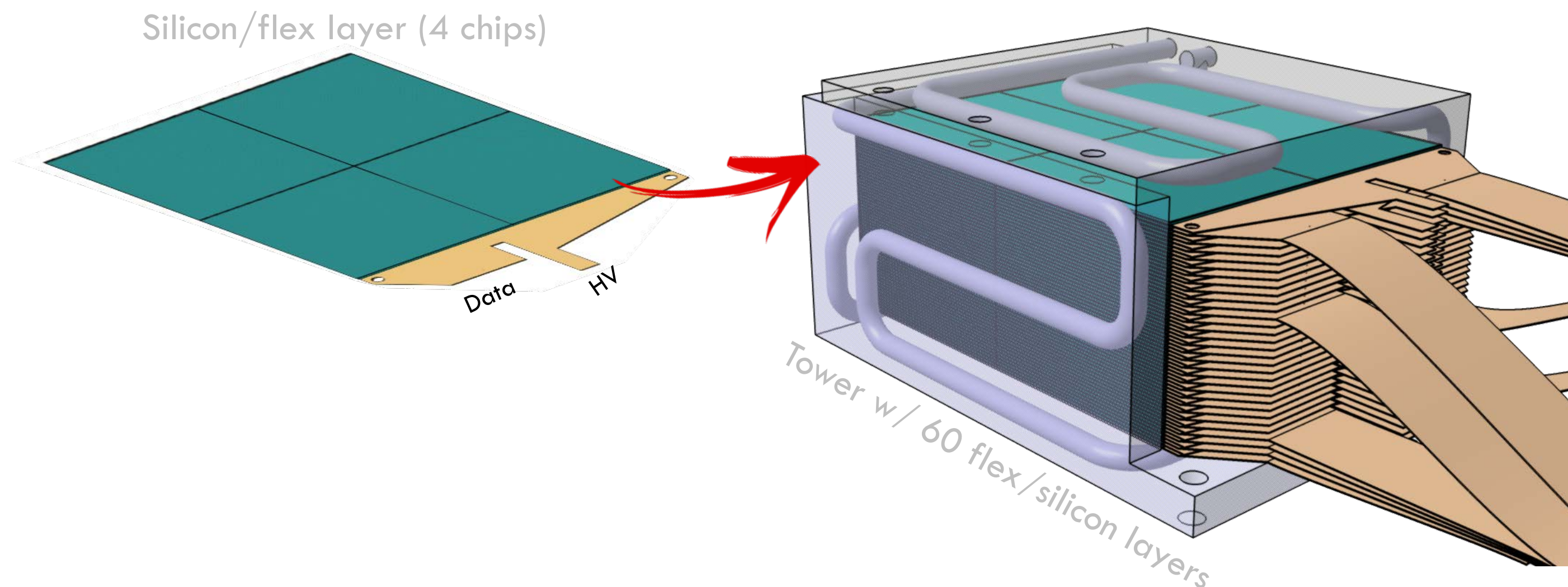




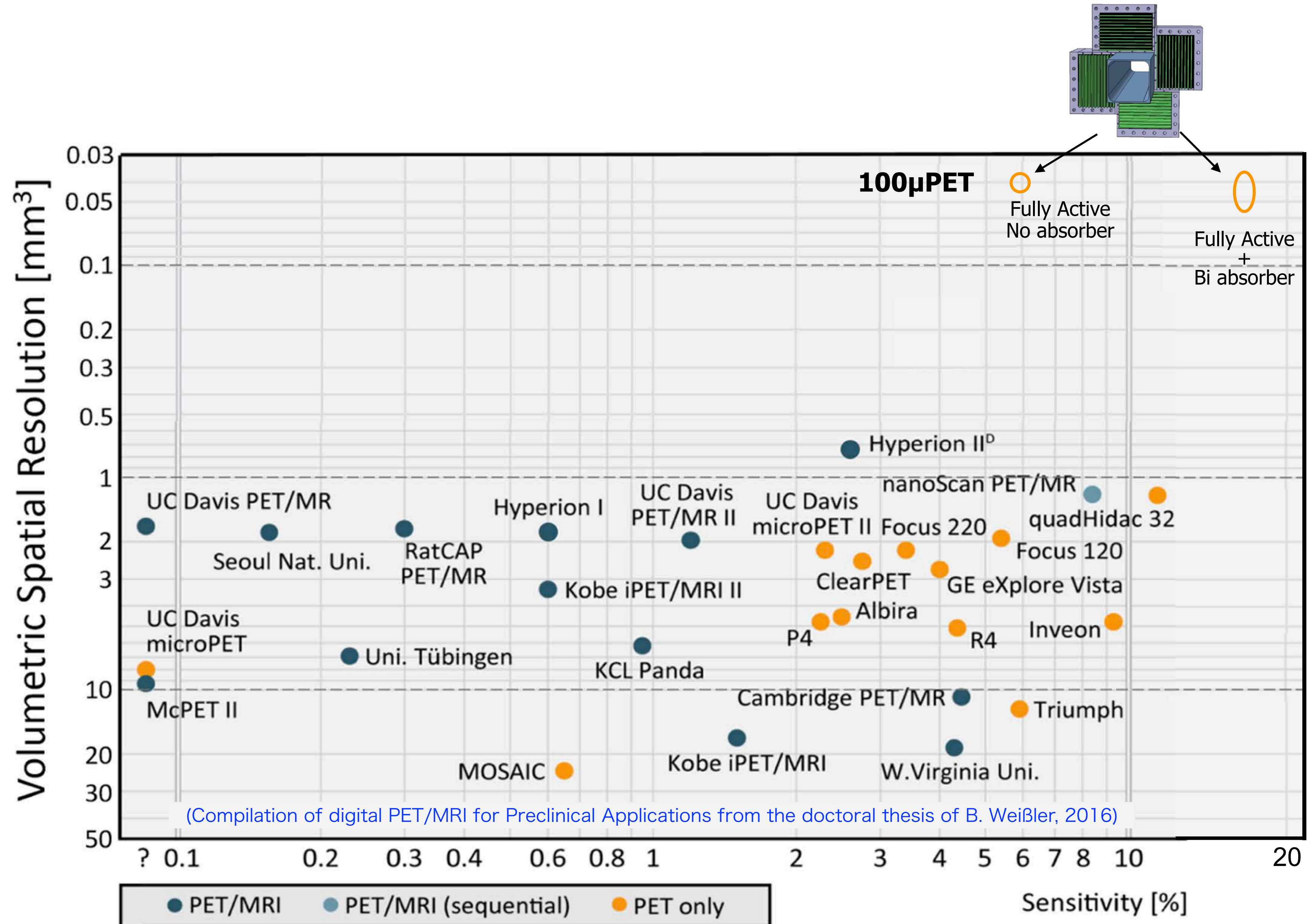
4 Tower
assembly

□ **Simplified and improved** scanner design, avoiding acceptance holes from cooling blocks

- **Monolithic 100 μ PET** detector ASIC: **2.5 x 3 cm²** active pixel matrix; **100 μ m** pixel pitch; **250 μ m** thick active silicon sensor
- Single silicon detection layer composed by **2x2 chips** assembled, covering **30 cm²**
- **4 “towers”** compose the scanner. **60** detection layers on each tower = **960 chips!**
- Large number of services and interconnections, requiring **innovative** design. Two possible designs under study
 - **5 silicon detector layers** (20 chips) stacked on a **PCB**, staggered for **wire-bonding**. **12 modules** are stacked in a tower
 - **1 detection layer** (2x2 chips) are interfaced to a **FPC** via **ACF bonding**. **60 FPC/ASIC layers** are stacked in a tower



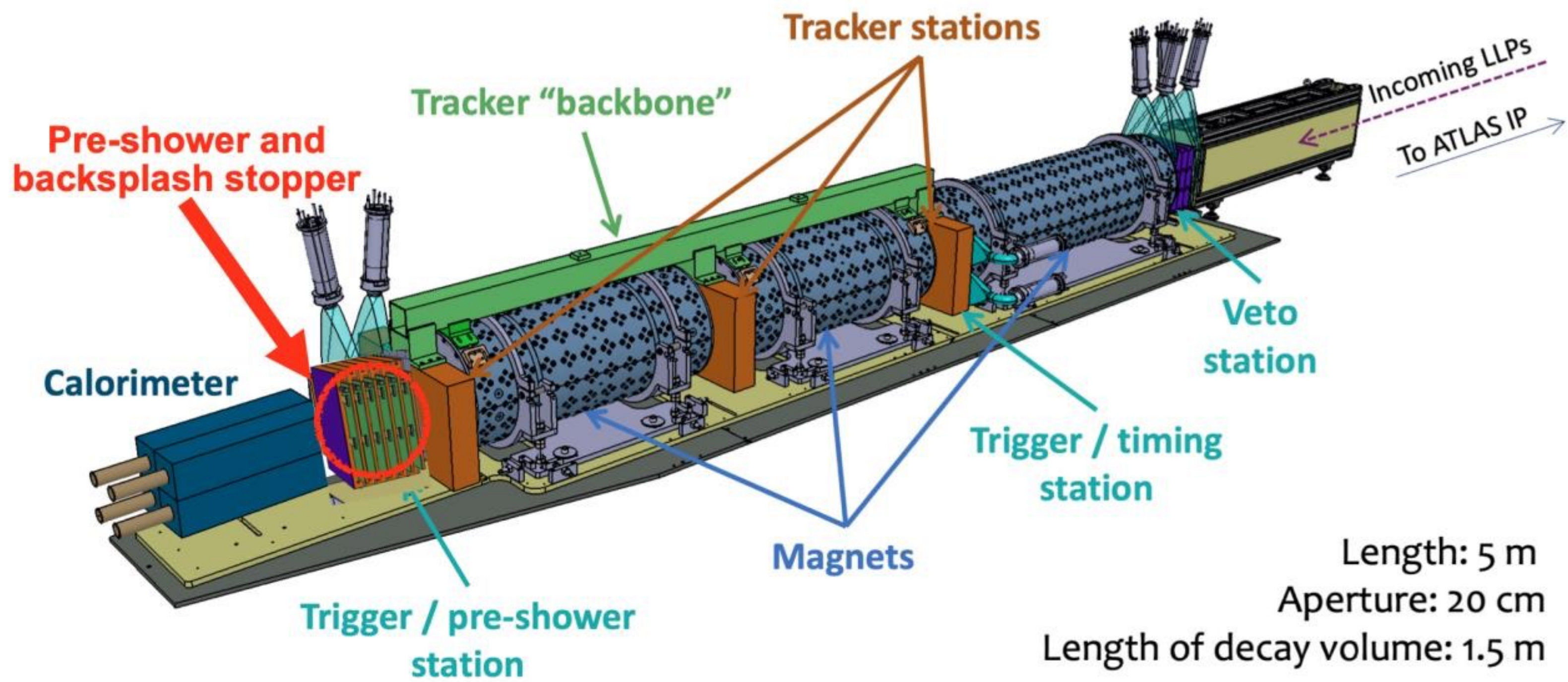
The 100 μ PET Performance



A. Sfyrla and G. Iacobucci groups

Current FASER pre-shower:

2 layers of tungsten + scintillating detectors \implies no XY granularity



To have access to **two-photon final states**:

- **High granularity and high dynamic range** pre-shower based on six planes of monolithic pixels
- Discriminate **TeV-scale EM showers**
- Targeting data taking in 2024-2026 and during HL-LHC



FLARE

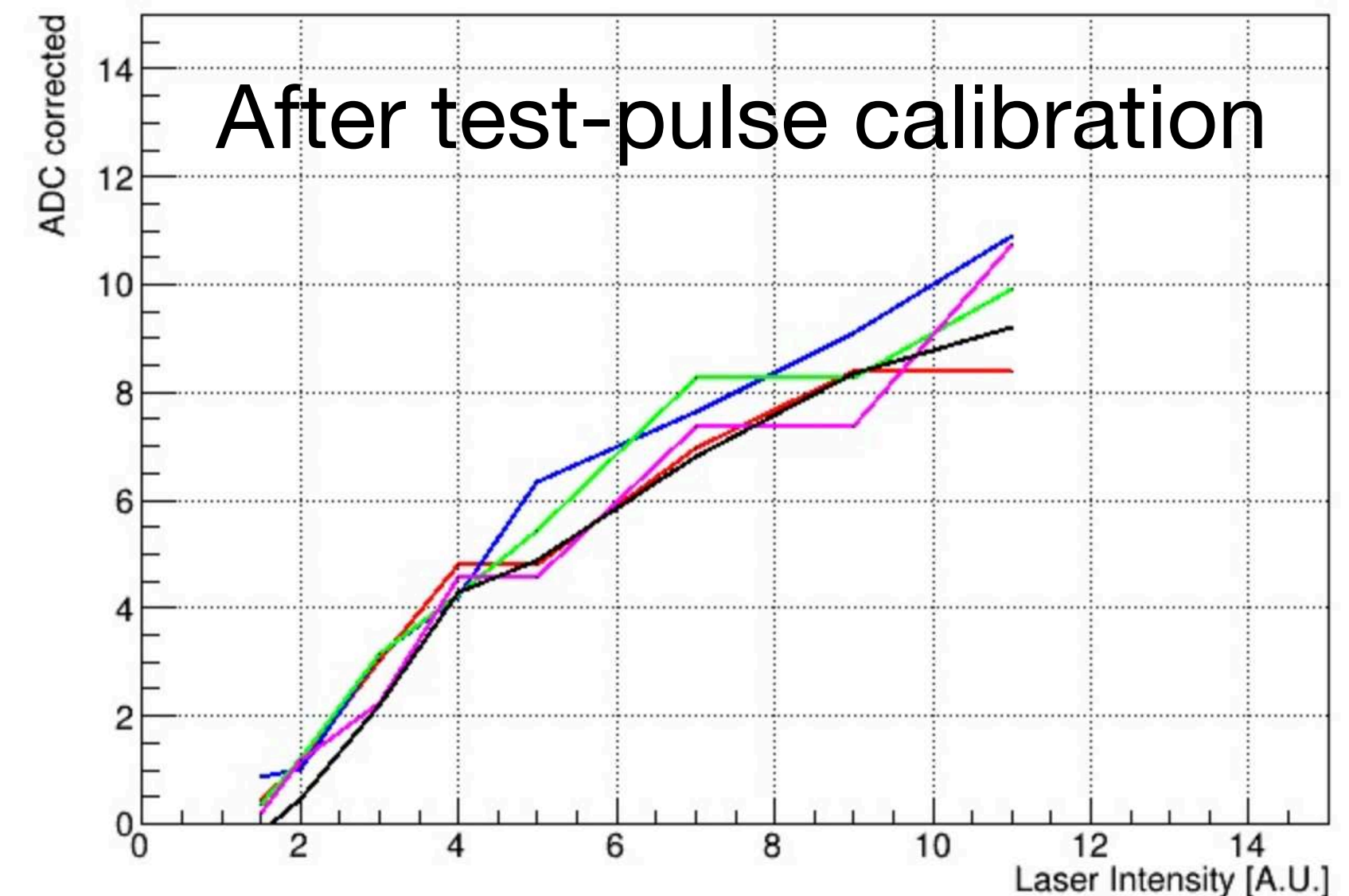
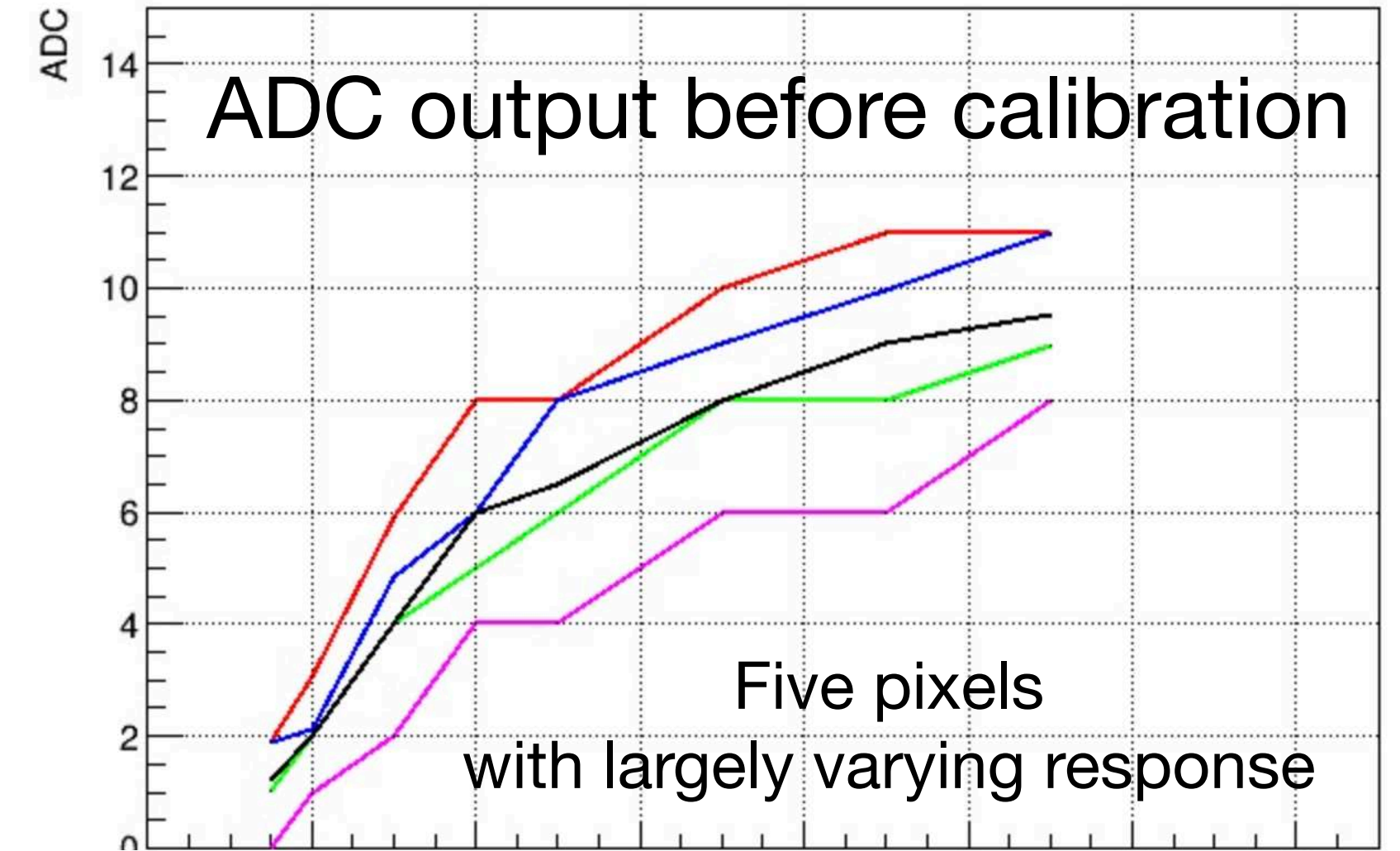
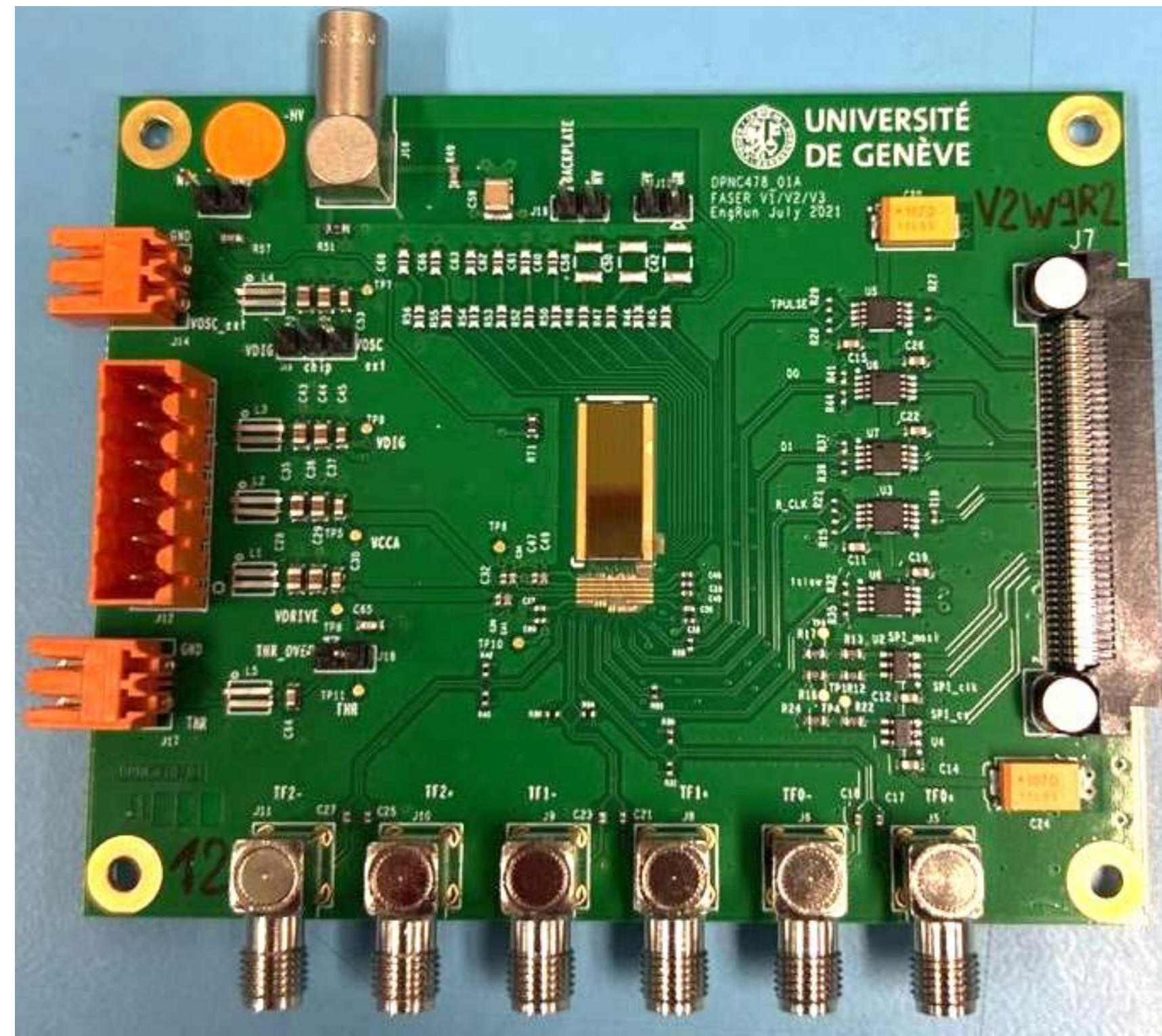
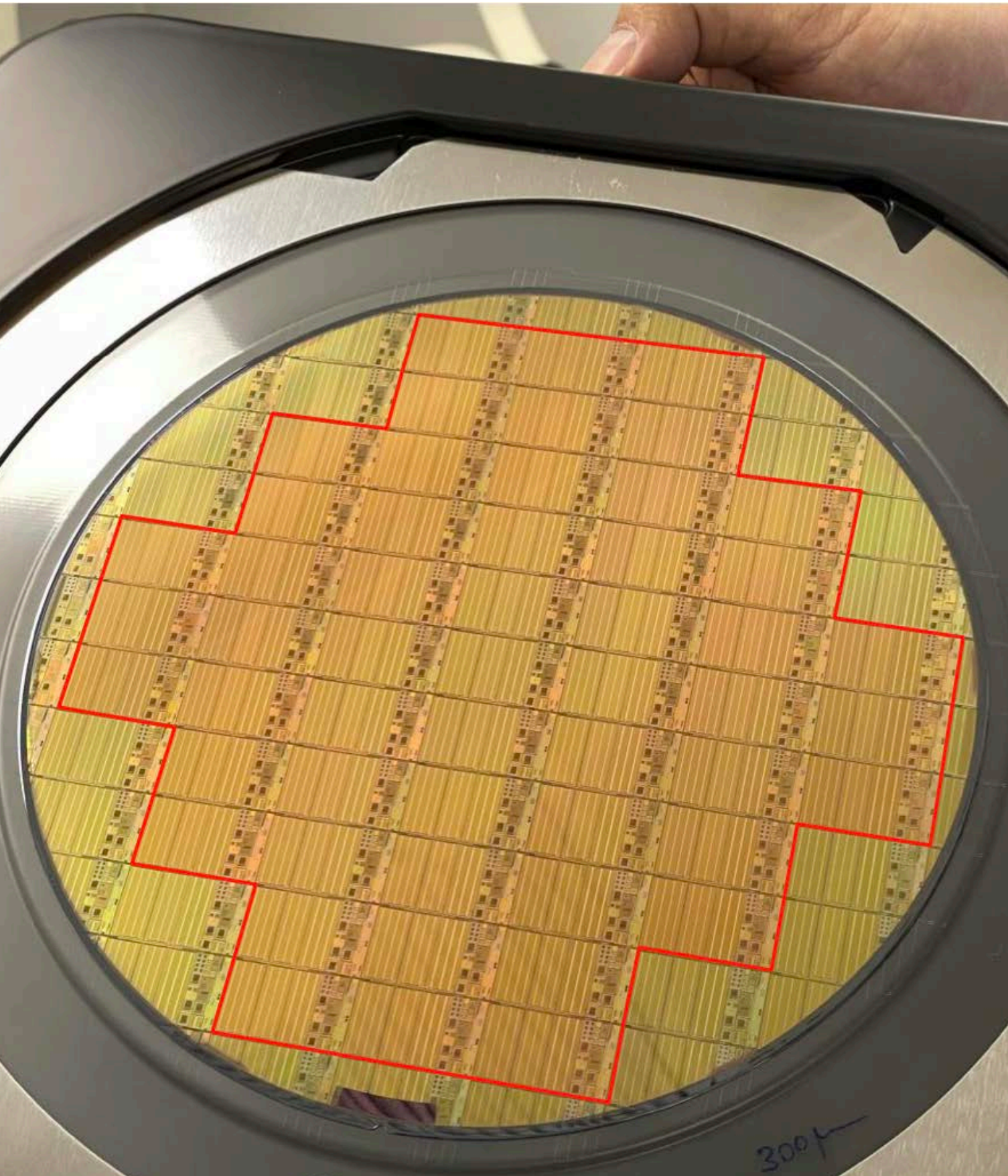
High granularity FASER W-Si pre-shower



European Research Council
Established by the European Commission

FASER preshower pre-production chip:

- **First engineering run produced by UNIGE in SiGe BiCMOS**
- Three large ASIC (15x7.5 mm²) with alternative designs
- pixels with 65μm side (~100μm pitch)
- Delivered in July; presently under test



The PicoAD[©] Monolithic proof-of-concept prototype **works**:

- **Gain ≈ 20** for ⁵⁵Fe X-rays (space-charge effects, for X-rays, measured)
- **Efficiency = 99.9 %** at full sensor-bias voltage
- **Time resolution $\sigma_t = (17.3 \pm 0.4)$ ps** (although sensor not yet optimized for timing)

Ongoing activities include:

- Optimization for timing of the PicoAD sensor design with TCAD to **achieve $\lesssim 10$ ps** (smaller pixel pitch; thicker drift layer; improved inter-pixel region)
- Development of **picosecond TDC** for fully monolithic chip

Deliverable of MONOLITH project:

- Full-reticle chip with 50 μ m pitch and sub-10ps timing in **Summer 2025**